DS2316 Datasheet 40MX and 42MX FPGA





Power Matters.*

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1 Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

1.1 Revision 16.0

Table 4, page 7 is edited in this revision to add the temperature grade, "I" for the column A42MX09 and row PQFP144

1.2 Revision 15.0

The following is a summary of the changes in revision 15.0 (Published in December 2016) of this document.

- Table 15, page 23 is edited to add the footnote, VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V
- Table 22, page 27 is edited to add the footnote, VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V
- Table 23, page 27 is edited to add the footnote, VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V

1.3 Revision 14.0

The following is a summary of the changes in revision 14.0 of this document.

- Added CQFP package information for A42MX16 device in Product Profile, page 3 and Ceramic Device Resources, page 6 (SAR 79522).
- Added Military (M) and MIL-STD-883 Class B (B) grades for CPGA 132 Package and added Commercial (C), Military (M), and MIL-STD-883 Class B (B) grades for CQFP 172 Package in Temperature Grade Offerings, page 7 (SAR 79519)
- Changed Silicon Sculptor II to Silicon Sculptor in Programming, page 15 (SAR 38754)
- Added Figure 53, page 160 CQ172 package (SAR 79522).

1.4 Revision 13.0

The following is a summary of the changes in revision 13.0 of this document.

- Added Figure 42, page 99 PQ144 Package for A42MX09 device (SAR 69776)
- Added Figure 52, page 155 PQ132 Package for A42MX09 device (SAR 69776)

1.5 Revision 12.0

The following is a summary of the changes in revision 12.0 of this document.

- Added information on power-up behavior for A42MX24 and A42MX36 devices to the Power Supply, page 15 (SAR 42096
- Corrected the inadvertent mistake in the naming of the PL68 pin assignment table (SARs 48999, 49793)

1.6 Revision 11.0

The following is a summary of the changes in revision 11.0 of this document.

- The FuseLock logo and accompanying text was removed from the User Security, page 14. This
 marking is no longer used on Microsemi devices (PCN 0915)
- The Development Tool Support, page 21 was updated (SAR 38512)

1.7 Revision 10.0

The following is a summary of the changes in revision 10.0 of this document.



- Ordering Information, page 5 was updated to include lead-free package ordering codes (SAR 21968)
- The User Security, page 14 was revised to clarify that although no existing security measures can give an absolute guarantee, Microsemi FPGAs implement the best security available in the industry (SAR 34673)
- The Transient Current, page 15 is new (SAR 36930).
- Package names were revised according to standards established in Package Mechanical Drawings (SAR 34774)

1.8 **Revision 9.0**

The following is a summary of the changes in revision 9.0 of this document

• In Table 20, page 25, the limits in VI were changed from -0.5 to VCCI + 0.5 to -0.5 to VCCA + 0.5 In Table 22, page 27, V_{OH} was changed from 3.7 to 2.4 for the min in industrial and military. V_{IH} had V_{CCI} and that was changed to VCCA

1.9 **Revision 6.0**

The following is a summary of the changes in revision 6.0 of this document.

- The Ease of Integration, page 3 was updated
- The Temperature Grade Offerings, page 7 is new
- The Speed Grade Offerings, page 7 is new
- The General Description, page 8 was updated
- The MultiPlex I/O Modules, page 13 was updated
- The User Security, page 14 was updated
- Table 6, page 15 was updated
- The Power Dissipation, page 16 was updated.
- The Static Power Component, page 16 was updated
- The Equivalent Capacitance, page 17 was updated
- Figure 13, page 19 was updated
- Table 10, page 20 was updated.
- Figure 14, page 20 was updated.
- Table 11, page 21 was updated.



2 40MX and 42MX FPGA Families

2.1 Features

The following sections list out various features of the 40MX and 42MX FPGA family devices.

2.1.1 High Capacity

- Single-Chip ASIC Alternative
- 3,000 to 54,000 System Gates
- Up to 2.5 kbits Configurable Dual-Port SRAM
- Fast Wide-Decode Circuitry
- Up to 202 User-Programmable I/O Pins

2.1.2 High Performance

- 5.6 ns Clock-to-Out
- 250 MHz Performance
- 5 ns Dual-Port SRAM Access
- 100 MHz FIFOs
- 7.5 ns 35-Bit Address Decode

2.1.3 HiRel Features

- Commercial, Industrial, Automotive, and Military Temperature Plastic Packages
- Commercial, Military Temperature, and MIL-STD-883 Ceramic Packages
- QML Certification
- Ceramic Devices Available to DSCC SMD

2.1.4 Ease of Integration

- Mixed-Voltage Operation (5.0 V or 3.3 V for core and I/Os), with PCI-Compliant I/Os
- Up to 100% Resource Utilization and 100% Pin Locking
- Deterministic, User-Controllable Timing
- Unique In-System Diagnostic and Verification Capability with Silicon Explorer II
- Low Power Consumption
- IEEE Standard 1149.1 (JTAG) Boundary Scan Testing

2.2 Product Profile

The following table gives the features of the products.

Table 1 • Product profile

Device	A40MX02	A40MX04	A42MX09	A42MX16	A42MX24	A42MX36
Capacity System Gates SRAM Bits	3,000	6,000	14,000	24,000	36,000	54,000 2,560
Logic Modules Sequential Combinatorial Decode	295	547	348 336	624 608	954 912 24	1,230 1,184 24
Clock-to-Out	9.5 ns	9.5 ns	5.6 ns	6.1 ns	6.1 ns	6.3 ns
SRAM Modules (64x4 or 32x8)						10
Dedicated Flip-Flops			348	624	954	1,230



Table 1 • Product profile (continued)

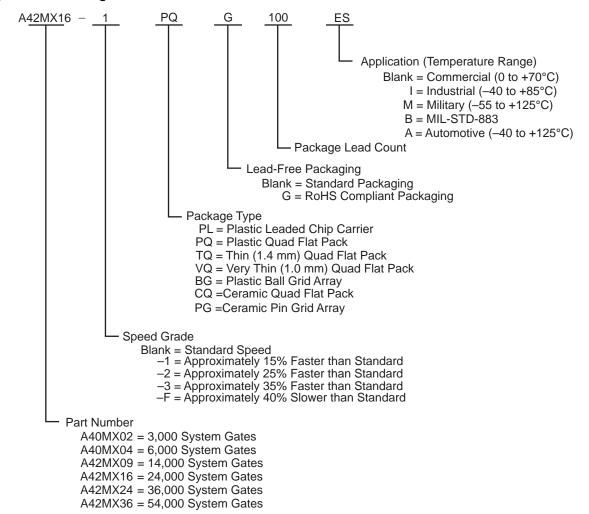
Device	A40MX02	A40MX04	A42MX09	A42MX16	A42MX24	A42MX36
Maximum Flip-Flops	147	273	516	928	1,410	1,822
Clocks	1	1	2	2	2	6
User I/O (maximum)	57	69	104	140	176	202
PCI					Yes	Yes
Boundary Scan Test (BST)					Yes	Yes
Packages (by pin						
count)	44, 68	44, 68, 84	84	84	84	
PLCC	100	100	100, 144,	100, 160,	160, 208	208, 240
PQFP	80	80	160	208		
VQFP			100	100	176	
TQFP			176	176		208, 256
CQFP				172		272
PBGA		_				
CPGA			132			



2.3 Ordering Information

The following figure shows ordering information. All the following tables show plastic and ceramic device resources, temperature and speed grade offerings.

Figure 1 • Ordering Information





2.4 Plastic Device Resources

Table 2 • Plastic Device Resources

	User I/	Os										
Device		PLCC 68-Pin			PQFP 144- Pin	PQFP 160- Pin	PQFP 208- Pin	PQFP 240- Pin	VQFP 80-Pin	VQFP 100- Pin	TQFP 176- Pin	PBGA 272- Pin
A40MX02	34	57		57					57			
A40MX04	34	57	69	69					69			
A42MX09			72	83	95	101				83	104	
A42MX16			72	83		125	140			83	140	
A42MX24			72			125	176				150	
A42MX36							176	202				202

Note: Package Definitions: PLCC = Plastic Leaded Chip Carrier, PQFP = Plastic Quad Flat Pack, TQFP = Thin Quad Flat Pack, VQFP = Very Thin Quad Flat Pack, PBGA = Plastic Ball Grid Array

2.5 Ceramic Device Resources

Table 3 • Ceramic Device Resources

	User I/Os								
Device	CPGA 132-Pin	CQFP 172-Pin	CQFP 208-Pin	CQFP 256-Pin					
A42MX09	95								
A42MX16		131							
A42MX36			176	202					

Note: Package Definitions: CQFP = Ceramic Quad Flat Pack



2.6 Temperature Grade Offerings

Table 4 • Temperature Grade Offerings

A40MX02	A40MX04	A42MX09	A42MX16	A42MX24	A42MX36
C, I, M	C, I, M				
C, I, A, M	C, I, M				
	C, I, A, M	C, I, A, M	C, I, M	C, I, M	
C, I, A, M	C, I, A, M	C, I, A, M	C, I, M		
		C, I			
		C, I, A, M	C, I, M	C, I, A, M	
			C, I, A, M	C, I, A, M	C, I, A, M
					C, I, A, M
C, I, A, M	C, I, A, M				
		C, I, A, M	C, I, A, M		
		C, I, A, M	C, I, A, M	C, I, A, M	
					C, I, M
			C, M, B		
					C, M, B
					C, M, B
		C, M, B			
	C, I, M C, I, A, M C, I, A, M	C, I, M C, I, M C, I, A, M C, I, M C, I, A, M C, I, A, M	C, I, M C, I, M C, I, A, M C, I, M C, I, A, M C, I C, I C, I, A, M	C, I, M C, I, M C, I, A, M C, I, M C, I, A, M C, I, A, M C, I, M C, I, A, M C, I, A, M C, I, M C, I, A, M C, I, A, M C, I, M C, I C, I C, I, A, M	C, I, M C, I, M C, I, A, M C, I, M C, I, A, M C, I, A, M C, I, M C, I, M C, I, A, M C, I, A, M C, I, M C, I, A, M C, I, A, M C, I, M C, I C, I C, I, A, M C, I, A, M C, M, B

Note: C = Commercial

I = Industrial

A = Automotive

M = Military

B = MIL-STD-883 Class B

2.7 Speed Grade Offerings

Table 5 • Speed Grade Offerings

	– F	Std	-1	-2	-3
С	Р	Р	Р	Р	Р
I		Р	Р	Р	Р
Α		Р			
М		Р	Р		
В		Р	Р		

Note: See the 40MX and 42MX Automotive Family FPGAs datasheet for details on automotive-grade MX offerings.

Contact your local Microsemi Sales representative for device availability.



3 40MX and 42MX FPGAs

3.1 General Description

Microsemi's 40MX and 42MX families offer a cost-effective design solution at 5V. The MX devices are single-chip solutions and provide high performance while shortening the system design and development cycle. MX devices can integrate and consolidate logic implemented in multiple programmable array logics (PALs), complex programmable logic devices (CPLDs), and FPGAs. Example applications include high-speed controllers and address decoding, peripheral bus interfaces, digital signal processor (DSP), and co-processor functions.

The MX device architecture is based on Microsemi's patented antifuse technology implemented in a 0.45µm triple-metal CMOS process. With capacities ranging from 3,000 to 54,000 system gates, the MX devices provide performance up to 250 MHz, are live on power-up and have one-fifth the standby power consumption of comparable FPGAs. MX FPGAs provide up to 202 user I/Os and are available in a wide variety of packages and speed grades.

A42MX24 and A42MX36 devices also feature multiPlex I/Os, which support mixed-voltage systems, enable programmable peripheral component interconnect (PCI), deliver high-performance operation at both 5.0V and 3.3V, and provide a low-power mode. The devices are fully compliant with the PCI local bus specification

(version 2.1). They deliver 200 MHz on-chip operation and 6.1 ns clock-to-output performance.

The 42MX24 and 42MX36 devices include system-level features such as IEEE Standard 1149.1 (JTAG) Boundary Scan Testing and fast wide-decode modules. In addition, the A42MX36 device offers dual-port SRAM for implementing fast first in first out (FIFOs), last in first out (LIFOs), and temporary data storage. The storage elements can efficiently address applications requiring wide data path manipulation and can perform transformation functions such as those required for telecommunications, networking, and DSP.

All MX devices are fully tested over automotive and military temperature ranges. In addition, the largest member of the family, the A42MX36, is available in both CQ208 and CQ256 ceramic packages screened to MIL-STD-883 levels. For easy prototyping and conversion from plastic to ceramic, the CQ208 and PQ208 devices are pin-compatible.

3.2 MX Architectural Overview

The MX devices are composed of fine-grained building blocks that enable fast, efficient logic designs. All devices within these families are composed of logic modules, I/O modules, routing resources and clock networks, which are the building blocks for fast logic designs. In addition, the A42MX36 device contains embedded dual-port SRAM modules, which are optimized for high-speed data path functions such as FIFOs. LIFOs and scratch pad memory. A42MX24 and A42MX36 also contain wide-decode modules.

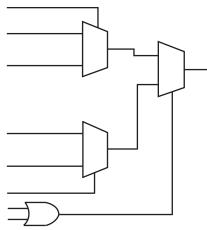
3.2.1 Logic Modules

The 40MX logic module is an eight-input, one-output logic circuit designed to implement a wide range of logic functions with efficient use of interconnect routing resources.(see the following figures).

The logic module can implement the four basic logic functions (NAND, AND, OR and NOR) in gates of two, three, or four inputs. The logic module can also implement a variety of D-latches, exclusivity functions, AND-ORs and OR-ANDs. No dedicated hard-wired latches or flip-flops are required in the array; latches and flip-flops can be constructed from logic modules whenever required in the application.



Figure 2 • 42MX C-Module Implementation



The 42MX devices contain three types of logic modules: combinatorial (C-modules), sequential (S-modules) and decode (D-modules). The following figure illustrates the combinatorial logic module. The S-module, shown in Figure 4, page 10, implements the same combinatorial logic function as the C-module while adding a sequential element. The sequential element can be configured as either a D-flip-flop or a transparent latch. The S-module register can be bypassed so that it implements purely combinatorial logic.

Figure 3 • 42MX C-Module Implementation

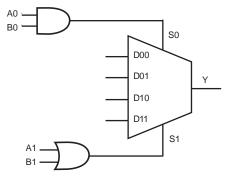
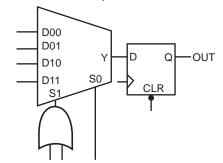
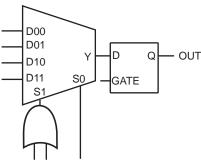




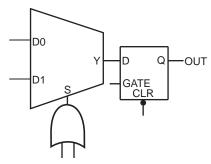
Figure 4 • 42MX S-Module Implementation



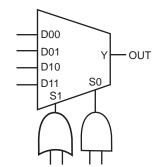
Up to 7-Input Function Plus D-Type Flip-Flop with Clear



Up to 7-Input Function Plus Latch



Up to 4-Input Function Plus Latch with Clear



Up to 8-Input Function (Same as C-Module)

A42MX24 and A42MX36 devices contain D-modules, which are arranged around the periphery of the device. D-modules contain wide-decode circuitry, providing a fast, wide-input AND function similar to that found in CPLD architectures (Figure 5, page 11). The D-module allows A42MX24 and A42MX36 devices to perform wide-decode functions at speeds comparable to CPLDs and PALs. The output of the D-module has a programmable inverter for active HIGH or LOW assertion. The D-module output is hardwired to an output pin, and can also be fed back into the array to be incorporated into other logic.

3.2.2 Dual-Port SRAM Modules

The A42MX36 device contains dual-port SRAM modules that have been optimized for synchronous or asynchronous applications. The SRAM modules are arranged in 256-bit blocks that can be configured as 32x8 or 64x4. SRAM modules can be cascaded together to form memory spaces of user-definable width and depth. A block diagram of the A42MX36 dual-port SRAM block is shown in Figure 6, page 11.

The A42MX36 SRAM modules are true dual-port structures containing independent read and write ports. Each SRAM module contains six bits of read and write addressing (RDAD[5:0] and WRAD[5:0], respectively) for 64x4-bit blocks. When configured in byte mode, the highest order address bits (RDAD5 and WRAD5) are not used. The read and write ports of the SRAM block contain independent clocks (RCLK and WCLK) with programmable polarities offering active HIGH or LOW implementation. The SRAM block contains eight data inputs (WD[7:0]), and eight outputs (RD[7:0]), which are connected to segmented vertical routing tracks.

The A42MX36 dual-port SRAM blocks provide an optimal solution for high-speed buffered applications requiring FIFO and LIFO queues. The ACTgen Macro Builder within Microsemi's designer software provides capability to quickly design memory functions with the SRAM blocks. Unused SRAM blocks can be used to implement registers for other user logic within the design.



Figure 5 • A42MX24 and A42MX36 D-Module Implementation

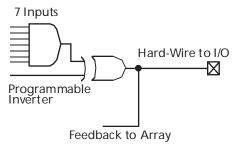
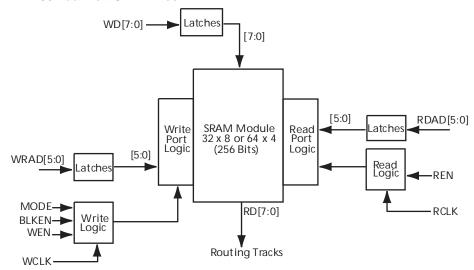


Figure 6 • A42MX36 Dual-Port SRAM Block



3.2.3 Routing Structure

The MX architecture uses vertical and horizontal routing tracks to interconnect the various logic and I/O modules. These routing tracks are metal interconnects that may be continuous or split into segments. Varying segment lengths allow the interconnect of over 90% of design tracks to occur with only two antifuse connections. Segments can be joined together at the ends using antifuses to increase their lengths up to the full length of the track. All interconnects can be accomplished with a maximum of four antifuses.

3.2.3.1 Horizontal Routing

Horizontal routing tracks span the whole row length or are divided into multiple segments and are located in between the rows of modules. Any segment that spans more than one-third of the row length is considered a long horizontal segment. A typical channel is shown in Figure 7, page 12. Within horizontal routing, dedicated routing tracks are used for global clock networks and for power and ground tie-off tracks. Non-dedicated tracks are used for signal nets.

3.2.3.2 Vertical Routing

Another set of routing tracks run vertically through the module. There are three types of vertical tracks: input, output, and long. Long tracks span the column length of the module, and can be divided into multiple segments. Each segment in an input track is dedicated to the input of a particular module; each segment in an output track is dedicated to the output of a particular module. Long segments are uncommitted and can be assigned during routing.

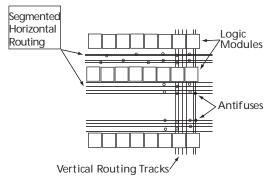
Each output segment spans four channels (two above and two below), except near the top and bottom of the array, where edge effects occur. Long vertical tracks contain either one or two segments. An example of vertical routing tracks and segments is shown in Figure 7, page 12.



3.2.3.3 Antifuse Structures

An antifuse is a "normally open" structure. The use of antifuses to implement a programmable logic device results in highly testable structures as well as efficient programming algorithms. There are no pre-existing connections; temporary connections can be made using pass transistors. These temporary connections can isolate individual antifuses to be programmed and individual circuit structures to be tested, which can be done before and after programming. For instance, all metal tracks can be tested for continuity and shorts between adjacent tracks, and the functionality of all logic modules can be verified.

Figure 7 • MX Routing Structure



3.2.4 Clock Networks

The 40MX devices have one global clock distribution network (CLK). A signal can be put on the CLK network by being routed through the CLKBUF buffer.

In 42MX devices, there are two low-skew, high-fanout clock distribution networks, referred to as CLKA and CLKB. Each network has a clock module (CLKMOD) that can select the source of the clock signal from any of the following (Figure 8, page 13):

- Externally from the CLKA pad, using CLKBUF buffer
- · Externally from the CLKB pad, using CLKBUF buffer
- Internally from the CLKINTA input, using CLKINT buffer
- Internally from the CLKINTB input, using CLKINT buffer

The clock modules are located in the top row of I/O modules. Clock drivers and a dedicated horizontal clock track are located in each horizontal routing channel.

Clock input pads in both 40MX and 42MX devices can also be used as normal I/Os, bypassing the clock networks.

The A42MX36 device has four additional register control resources, called quadrant clock networks (Figure 9, page 13). Each quadrant clock provides a local, high-fanout resource to the contiguous logic modules within its quadrant of the device. Quadrant clock signals can originate from specific I/O pins or from the internal array and can be used as a secondary register clock, register clear, or output enable.



Figure 8 • Clock Networks of 42MX Devices

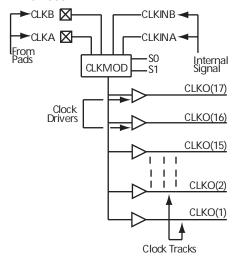
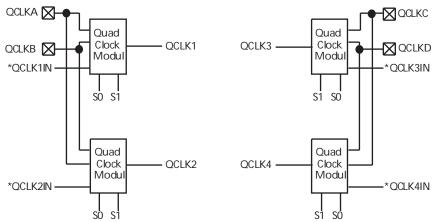


Figure 9 • Quadrant Clock Network of A42MX36 Devices



Note: *QCLK1IN, QCLK2IN, QCLK3IN, and QCLK4IN are internally-generated signals.

3.2.5 MultiPlex I/O Modules

42MX devices feature Multiplex I/Os and support 5.0 V, 3.3 V, and mixed 3.3 V/5.0 V operations.

The MultiPlex I/O modules provide the interface between the device pins and the logic array. Figure 10, page 14 is a block diagram of the 42MX I/O module. A variety of user functions, determined by a library macro selection, can be implemented in the module. (See the *Antifuse Macro Library Guide* for more information.) All 42MX I/O modules contain tristate buffers, with input and output latches that can be configured for input, output, or bidirectional operation.

All 42MX devices contain flexible I/O structures, where each output pin has a dedicated output-enable control (Figure 10, page 14). The I/O module can be used to latch input or output data, or both, providing fast set-up time. In addition, the Designer software tools can build a D-type flip-flop using a C-module combined with an I/O module to register input and output signals. See the *Antifuse Macro Library Guide* for more details.

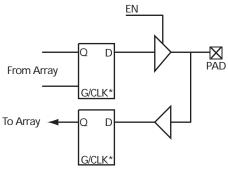
A42MX24 and A42MX36 devices also offer selectable PCI output drives, enabling 100% compliance with version 2.1 of the PCI specification. For low-power systems, all inputs and outputs are turned off to reduce current consumption to below 500 μ A.

To achieve 5.0 V or 3.3 V PCI-compliant output drives on A42MX24 and A42MX36 devices, a chip-wide PCI fuse is programmed via the Device Selection Wizard in the Designer software (Figure 11, page 14). When the PCI fuse is not programmed, the output drive is standard.



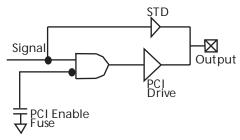
Designer software development tools provide a design library of I/O macro functions that can implement all I/O configurations supported by the MX FPGAs.

Figure 10 • 42MX I/O Module



Note: *Can be configured as a Latch or D Flip-Flop (Using C-Module)

Figure 11 • PCI Output Structure of A42MX24 and A42MX36 Devices



3.3 Other Architectural Features

The following sections cover other architectural features of 40MX and 42MX FPGAs.

3.3.1 Performance

MX devices can operate with internal clock frequencies of 250 MHz, enabling fast execution of complex logic functions. MX devices are live on power-up and do not require auxiliary configuration devices and thus are an optimal platform to integrate the functionality contained in multiple programmable logic devices. In addition, designs that previously would have required a gate array to meet performance can be integrated into an MX device with improvements in cost and time-to-market. Using timing-driven place-and-route (TDPR) tools, designers can achieve highly deterministic device performance.

3.3.2 User Security

Microsemi FuseLock provides robust security against design theft. Special security fuses are hidden in the fabric of the device and protect against unauthorized users attempting to access the programming and/or probe interfaces. It is virtually impossible to identify or bypass these fuses without damaging the device, making Microsemi antifuse FPGAs protected with the highest level of security available from both invasive and noninvasive attacks.

Special security fuses in 40MX devices include the Probe Fuse and Program Fuse. The former disables the probing circuitry while the latter prohibits further programming of all fuses, including the Probe Fuse. In 42MX devices, there is the Security Fuse which, when programmed, both disables the probing circuitry and prohibits further programming of the device.



3.3.3 Programming

Device programming is supported through the Silicon Sculptor series of programmers. Silicon Sculptor is a compact, robust, single-site and multi-site device programmer for the PC. With standalone software, Silicon Sculptor is designed to allow concurrent programming of multiple units from the same PC.

Silicon Sculptor programs devices independently to achieve the fastest programming times possible. After being programmed, each fuse is verified to insure that it has been programmed correctly. Furthermore, at the end of programming, there are integrity tests that are run to ensure no extra fuses have been programmed. Not only does it test fuses (both programmed and non-programmed), Silicon Sculptor also allows self-test to verify its own hardware extensively.

The procedure for programming an MX device using Silicon Sculptor is as follows:

- 1. Load the *.AFM file
- Select the device to be programmed
- 3. Begin programming

When the design is ready to go to production, Microsemi offers device volume-programming services either through distribution partners or via In-House Programming from the factory.

For more details on programming MX devices, see the AC225: Programming Antifuse Devices application note and the Silicon Sculptor 3 Programmers User Guide.

3.3.4 Power Supply

MX devices are designed to operate in both 5.0V and 3.3V environments. In particular, 42MX devices can operate in mixed 5.0 V/3.3 V systems. The following table describes the voltage support of MX devices.

Device	VCC	VCCA	VCCI	Maximum Input Tolerance	Nominal Output Voltage
40MX	5.0 V			5.5 V	5.0 V
	3.3 V			3.6 V	3.3 V
42MX		5.0 V	5.0 V	5.5 V	5.0 V
		3.3 V	3.3 V	3.6 V	3.3 V
		5.0 V	3.3 V	5.5 V	3.3 V

Table 6 • Voltage Support of MX Devices

For A42MX24 and A42MX36 devices the VCCA supply has to be monotonic during power up in order for the POR to issue reset to the JTAG state machine correctly. For more information, see the AC291: 42MX Family Devices Power-Up Behavior.

3.3.5 Power-Up/Down in Mixed-Voltage Mode

When powering up 42MX in mixed voltage mode (VCCA = 5.0 V and VCCI = 3.3 V), VCCA must be greater than or equal to VCCI throughout the power-up sequence. If VCCI exceeds VCCA during power-up, one of two things will happen:

- The input protection diode on the I/Os will be forward biased
- The I/Os will be at logical High

In either case, ICC rises to high levels. For power-down, any sequence with VCCA and VCCI can be implemented.

3.3.6 Transient Current

Due to the simultaneous random logic switching activity during power-up, a transient current may appear on the core supply (VCC). Customers must use a regulator for the VCC supply that can source a minimum of 100 mA for transient current during power-up. Failure to provide enough power can prevent the system from powering up properly and result in functional failure. However, there are no reliability concerns, since transient current is distributed across the die instead of confined to a localized spot.



Since the transient current is not due to I/O switching, its value and duration are independent of the VCCI.

3.3.7 Low Power Mode

42MX devices have been designed with a low power mode. This feature, activated with setting the special LP pin to HIGH for a period longer than 800 ns, is particularly useful for battery-operated systems where battery life is a primary concern. In this mode, the core of the device is turned off and the device consumes minimal power with low standby current. In addition, all input buffers are turned off, and all outputs and bidirectional buffers are tristated. Since the core of the device is turned off, the states of the registers are lost. The device must be re-initialized when exiting low power mode. I/Os can be driven during LP mode, and clock pins should be driven HIGH or LOW and should not float to avoid drawing current. To exit LP mode, the LP pin must be pulled LOW for over 200 us to allow for charge pumps to power up, and device initialization will begin.

3.4 Power Dissipation

The general power consumption of MX devices is made up of static and dynamic power and can be expressed with the following equation.

3.4.1 General Power Equation

P = [ICCstandby + ICCactive]*VCCI + IOL*VOL*N + IOH*(VCCI - VOH)*M

EQ₁

where:

- ICCstandby is the current flowing when no inputs or outputs are changing.
- ICCactive is the current flowing due to CMOS switching.
- IOL, IOH are TTL sink/source currents.
- VOL, VOH are TTL level output voltages.
- N equals the number of outputs driving TTL loads to VOL.
- M equals the number of outputs driving TTL loads to VOH.

Accurate values for N and M are difficult to determine because they depend on the family type, on design details, and on the system I/O. The power can be divided into two components: static and active.

3.4.2 Static Power Component

The static power due to standby current is typically a small component of the overall power consumption. Standby power is calculated for commercial, worst-case conditions. The static power dissipation by TTL loads depends on the number of outputs driving, and on the DC load current. For instance, a 32-bit bus sinking 4mA at 0.33V will generate 42mW with all outputs driving LOW, and 140mW with all outputs driving HIGH. The actual dissipation will average somewhere in between, as I/Os switch states with time.

3.4.3 Active Power Component

Power dissipation in CMOS devices is usually dominated by the dynamic power dissipation. Dynamic power consumption is frequency-dependent and is a function of the logic and the external I/O. Active power dissipation results from charging internal chip capacitances of the interconnect, unprogrammed antifuses, module inputs, and module outputs, plus external capacitances due to PC board traces and load device inputs. An additional component of the active power dissipation is the totem pole current in the CMOS transistor pairs. The net effect can be associated with an equivalent capacitance that can be combined with frequency and voltage to represent active power dissipation.

The power dissipated by a CMOS circuit can be expressed by the equation:

$$Power(\mu W) = C_{EO}^* VCCA2^* F(1)$$

EQ 2



where:

- C_{EQ} = Equivalent capacitance expressed in picofarads (pF)
- VCCA = Power supply in volts (V)
- F = Switching frequency in megahertz (MHz)

3.4.4 Equivalent Capacitance

Equivalent capacitance is calculated by measuring ICCactive at a specified frequency and voltage for each circuit component of interest. Measurements have been made over a range of frequencies at a fixed value of VCC. Equivalent capacitance is frequency-independent, so the results can be used over a wide range of operating conditions. Equivalent capacitance values are shown below.

3.4.5 C_{EQ} Values for Microsemi MX FPGAs

Modules (C_{FOM})3.5

Input Buffers (C_{EQI})6.9

Output Buffers (C_{EQO})18.2

Routed Array Clock Buffer Loads (CFOCR)1.4

To calculate the active power dissipated from the complete design, the switching frequency of each part of the logic must be known. The equation below shows a piece-wise linear summation over all components.

$$\begin{aligned} & \text{Power} = \text{VCCA}^2 * [(\text{m} \times \text{C}_{\text{EQM}} * \text{f}_{\text{m}})_{\text{modules}} + (\text{n} * \text{C}_{\text{EQI}} * \text{f}_{\text{n}})_{\text{inputs}} + & (\text{p} * (\text{C}_{\text{EQO}} + \text{C}_{\text{L}}) * \text{f}_{\text{p}})_{\text{outputs}} + \\ & 0.5 * (\text{q}_1 * \text{C}_{\text{EQCR}} * \text{f}_{\text{q}1})_{\text{routed}} & (\text{Clk}_1 + (\text{r}_{1*} \text{f}_{\text{q}1})_{\text{routed}} & (\text{Clk}_1 + (\text{r}_{1*} \text{f}_{\text{q}2})_{\text{routed}} & (\text{Clk}_2 + (\text{r}_{2*} \text{f}_{\text{q}2})_{\text{routed}} & (\text{r}_{2*} \text{f}_{2*} + (\text{r}_{2*} \text{f}_{2*})_{\text{routed}} & (\text{r}_{2*} + (\text{r}_{2*} + (\text{r}_{2*} + (\text{r}$$

EQ3

where:

m = Number of logic modules switching at frequency f_m

n = Number of input buffers switching at frequency f_n

p = Number of output buffers switching at frequency fp

q₁ = Number of clock loads on the first routed array clock

q₂ = Number of clock loads on the second routed array clock

r₁ = Fixed capacitance due to first routed array clock

r₂ = Fixed capacitance due to second routed array clock

C_{EOM} = Equivalent capacitance of logic modules in pF

C_{EQI} = Equivalent capacitance of input buffers in pF

C_{EQO} = Equivalent capacitance of output buffers in pF

C_{EQCR} = Equivalent capacitance of routed array clock in pF

C_I = Output load capacitance in pF

f_m = Average logic module switching rate in MHz

f_n = Average input buffer switching rate in MHz

f_p = Average output buffer switching rate in MHz

f_{q1} = Average first routed array clock rate in MHz



 f_{02} = Average second routed array clock rate in MHz)

Table 7 • Fixed Capacitance Values for MX FPGAs (pF)

Device Type	r1 routed_Clk1	r2 routed_Clk2
A40MX02	41.4	N/A
A40MX04	68.6	N/A
A42MX09	118	118
A42MX16	165	165
A42MX24	185	185
A42MX36	220	220

3.4.6 Test Circuitry and Silicon Explorer II Probe

MX devices contain probing circuitry that provides built-in access to every node in a design, via the use of Silicon Explorer II. Silicon Explorer II is an integrated hardware and software solution that, in conjunction with the Designer software, allows users to examine any of the internal nets of the device while it is operating in a prototyping or a production system. The user can probe into an MX device without changing the placement and routing of the design and without using any additional resources. Silicon Explorer II's noninvasive method does not alter timing or loading effects, thus shortening the debug cycle and providing a true representation of the device under actual functional situations.

Silicon Explorer II samples data at 100 MHz (asynchronous) or 66 MHz (synchronous). Silicon Explorer II attaches to a PC's standard COM port, turning the PC into a fully functional 18-channel logic analyzer. Silicon Explorer II allows designers to complete the design verification process at their desks and reduces verification time from several hours per cycle to a few seconds.

Silicon Explorer II is used to control the MODE, DCLK, SDI and SDO pins in MX devices to select the desired nets for debugging. The user simply assigns the selected internal nets in the Silicon Explorer II software to the PRA/PRB output pins for observation. Probing functionality is activated when the MODE pin is held HIGH.

Figure 12, page 18 illustrates the interconnection between Silicon Explorer II and 40MX devices, while Figure 13, page 19 illustrates the interconnection between Silicon Explorer II and 42MX devices

To allow for probing capabilities, the security fuses must not be programmed. (See User Security, page 14 for the security fuses of 40MX and 42MX devices). Table 8, page 19 summarizes the possible device configurations for probing.

PRA and PRB pins are dual-purpose pins. When the "Reserve Probe Pin" is checked in the Designer software, PRA and PRB pins are reserved as dedicated outputs for probing. If PRA and PRB pins are required as user I/Os to achieve successful layout and "Reserve Probe Pin" is checked, the layout tool will override the option and place user I/Os on PRA and PRB pins.

Figure 12 • Silicon Explorer II Setup with 40MX

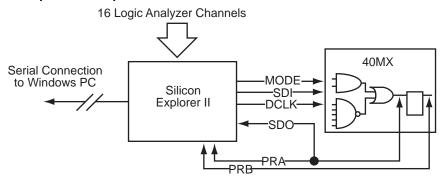




Figure 13 • Silicon Explorer II Setup with 42MX

Serial Connection to Windows PC

Silicon Explorer II

Spont Analyzer Channels

42MX

42MX

42MX

42MX

Table 8 • Device Configuration Options for Probe Capability

Security Fuse(s) Programmed	Mode	PRA, PRB ¹	SDI, SDO, DCLK ¹
No	LOW	User I/Os ²	User I/Os ²
No	HIGH	Probe Circuit Outputs	Probe Circuit Inputs
Yes		Probe Circuit Secured	Probe Circuit Secured

- Avoid using SDI, SDO, DCLK, PRA and PRB pins as input or bidirectional ports. Since these pins are active during probing, input signals will not pass through these pins and may cause contention.
- If no user signal is assigned to these pins, they will behave as unused I/Os in this mode. See the Pin Descriptions, page 85 for information on unused I/O pins

3.4.7 Design Consideration

It is recommended to use a series 70 Ω termination resistor on every probe connector (SDI, SDO, MODE, DCLK, PRA and PRB). The 70 Ω series termination is used to prevent data transmission corruption during probing and reading back the checksum.

3.4.8 IEEE Standard 1149.1 Boundary Scan Test (BST) Circuitry

42MX24 and 42MX36 devices are compatible with IEEE Standard 1149.1 (informally known as Joint Testing Action Group Standard or JTAG), which defines a set of hardware architecture and mechanisms for cost-effective board-level testing. The basic MX boundary-scan logic circuit is composed of the TAP (test access port), TAP controller, test data registers and instruction register (Figure 14, page 20). This circuit supports all mandatory IEEE 1149.1 instructions (EXTEST, SAMPLE/PRELOAD and BYPASS) and some optional instructions. Table 9, page 20 describes the ports that control JTAG testing, while Table 10, page 20 describes the test instructions supported by these MX devices.

Each test section is accessed through the TAP, which has four associated pins: TCK (test clock input), TDI and TDO (test data input and output), and TMS (test mode selector).

The TAP controller is a four-bit state machine. The '1's and '0's represent the values that must be present at TMS at a rising edge of TCK for the given state transition to occur. IR and DR indicate that the instruction register or the data register is operating in that state.

The TAP controller receives two control inputs (TMS and TCK) and generates control and clock signals for the rest of the test logic architecture. On power-up, the TAP controller enters the Test-Logic-Reset state. To guarantee a reset of the controller from any of the possible states, TMS must remain high for five TCK cycles.

42MX24 and 42MX36 devices support three types of test data registers: bypass, device identification, and boundary scan. The bypass register is selected when no other register needs to be accessed in a device. This speeds up test data transfer to other devices in a test data path. The 32-bit device identification register is a shift register with four fields (lowest significant byte (LSB), ID number, part number and version). The boundary-scan register observes and controls the state of each I/O pin.



Each I/O cell has three boundary-scan register cells, each with a serial-in, serial-out, parallel-in, and parallel-out pin. The serial pins are used to serially connect all the boundary-scan register cells in a device into a boundary-scan register chain, which starts at the TDI pin and ends at the TDO pin. The parallel ports are connected to the internal core logic tile and the input, output and control ports of an I/O buffer to capture and load data into the register to control or observe the logic state of each I/O.

Figure 14 • 42MX IEEE 1149.1 Boundary Scan Circuitry

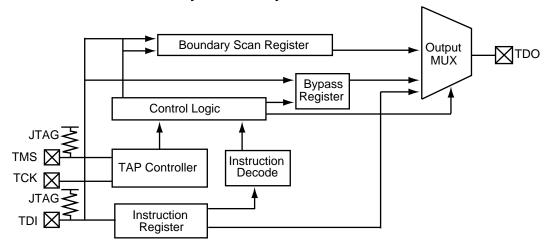


Table 9 • Test Access Port Descriptions

Port	Description
TMS (Test Mode Select)	Serial input for the test logic control bits. Data is captured on the rising edge of the test logic clock (TCK).
TCK (Test Clock Input)	Dedicated test logic clock used serially to shift test instruction, test data, and control inputs on the rising edge of the clock, and serially to shift the output data on the falling edge of the clock. The maximum clock frequency for TCK is 20 MHz.
TDI (Test Data Input)	Serial input for instruction and test data. Data is captured on the rising edge of the test logic clock.
TDO (Test Data Output)	Serial output for test instruction and data from the test logic. TDO is set to an inactive drive state (high impedance) when data scanning is not in progress.

Table 10 • Supported BST Public Instructions

Instruction	IR Code (IR2.IR0)	Instruction Type	Description
EXTEST	000	Mandatory	Allows the external circuitry and board-level interconnections to be tested by forcing a test pattern at the output pins and capturing test results at the input pins.
SAMPLE/PRELOAD	001	Mandatory	Allows a snapshot of the signals at the device pins to be captured and examined during operation
HIGH Z	101	Optional	Tristates all I/Os to allow external signals to drive pins. See the IEEE Standard 1149.1 specification.
CLAMP	110	Optional	Allows state of signals driven from component pins to be determined from the Boundary-Scan Register. See the IEEE Standard 1149.1 specification for details.
BYPASS	111	Mandatory	Enables the bypass register between the TDI and TDO pins. The test data passes through the selected device to adjacent devices in the test chain.



3.4.9 JTAG Mode Activation

The JTAG test logic circuit is activated in the Designer software by selecting **Tools > Device Selection**. This brings up the Device Selection dialog box as shown in the following figure. The JTAG test logic circuit can be enabled by clicking the "Reserve JTAG Pins" check box. The following table explains the pins' behavior in either mode.

Figure 15 • Device Selection Wizard



Table 11 • Boundary Scan Pin Configuration and Functionality

Reserve JTAG	Checked	Unchecked
TCK	BST input; must be terminated to logical HIGH or LOW to avoid floating	User I/O
TDI, TMS	BST input; may float or be tied to HIGH	User I/O
TDO	BST output; may float or be connected to TDI of another device	User I/O

3.4.10 TRST Pin and TAP Controller Reset

An active reset (TRST) pin is not supported; however, MX devices contain power-on circuitry that resets the boundary scan circuitry upon power-up. Also, the TMS pin is equipped with an internal pull-up resistor. This allows the TAP controller to remain in or return to the Test-Logic-Reset state when there is no input or when a logical 1 is on the TMS pin. To reset the controller, TMS must be HIGH for at least five TCK cycles.

3.4.11 Boundary Scan Description Language (BSDL) File

Conforming to the IEEE Standard 1149.1 requires that the operation of the various JTAG components be documented. The BSDL file provides the standard format to describe the JTAG components that can be used by automatic test equipment software. The file includes the instructions that are supported, instruction bit pattern, and the boundary-scan chain order. For an in-depth discussion on BSDL files, see the *BSDL Files Format Description* application note.

BSDL files are grouped into two categories - generic and device-specific. The generic files assign all user I/Os as inputs. Device-specific files assign user I/Os as inputs, outputs or inputs.

Generic files for MX devices are available on the Microsemi SoC Product Group's website:

http://www.microsemi.com/soc/techdocs/models/bsdl.html.

3.5 Development Tool Support

The MX family of FPGAs is fully supported by Libero[®] integrated design environment (IDE). Libero IDE is a design management environment, seamlessly integrating design tools while guiding the user through the design flow, managing all design and log files, and passing necessary design data among tools. Libero IDE allows users to integrate both schematic and HDL synthesis into a single flow and verify the entire design in a single environment. Libero IDE includes SynplifyPro from Synopsys, ModelSim[®] HDL Simulator from Mentor Graphics[®] and Viewdraw.

Libero IDE includes place-and-route and provides a comprehensive suite of backend support tools for FPGA development, including timing-driven place-and-route, and a world-class integrated static timing analyzer and constraints editor.



Additionally, the back-annotation flow is compatible with all the major simulators and the simulation results can be cross-probed with Silicon Explorer II, Microsemi's integrated verification and logic analysis tool. Another tool included in the Libero software is the SmartGen macro builder, which easily creates popular and commonly used logic functions for implementation into your schematic or HDL design.

Microsemi's Libero software is compatible with the most popular FPGA design entry and verification tools from companies such as Mentor Graphics, Synopsys, and Cadence design systems.

See the Libero IDE web content at www.microsemi.com/soc/products/software/libero/default.aspx for further information on licensing and current operating system support.

3.6 Related Documents

The following sections give the list of related documents which can be refered for this datasheet.

3.6.1 Application Notes

- AC278: BSDL Files Format Description
- AC225: Programming Antifuse Devices
- AC168: Implementation of Security in Microsemi Antifuse FPGAs

3.6.2 User Guides and Manuals

- Antifuse Macro Library Guide
- Silicon Sculptor Programmers User Guide

3.6.3 Miscellaneous

Libero IDE Flow Diagram

3.7 5.0 V Operating Conditions

The following tables show 5.0 V operating conditions.

Table 12 • Absolute Maximum Ratings for 40MX Devices*

Symbol	Parameter	Limits	Units
VCC	DC Supply Voltage	-0.5 to +7.0	V
VI	Input Voltage	-0.5 to VCC+0.5	V
VO	Output Voltage	-0.5 to VCC+0.5	V
t _{STG}	Storage Temperature	-65 to +150	°C

Note: *Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Devices should not be operated outside the recommended operating conditions.

Table 13 • Absolute Maximum Ratings for 42MX Devices*

Symbol	Parameter	Limits	Units
VCCI	DC Supply Voltage for I/Os	-0.5 to +7.0	V
VCCA	DC Supply Voltage for Array	-0.5 to +7.0	V
VI	Input Voltage	-0.5 to VCCI+0.5	V
VO	Output Voltage	-0.5 to VCCI+0.5	V
t _{STG}	Storage Temperature	-65 to +150	°C



Note: *Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Devices should not be operated outside the recommended operating conditions.

Table 14 • Recommended Operating Conditions

Parameter	Commercial	Industrial	Military	Units
Temperature Range*	0 to +70	-40 to +85	-55 to +125	°C
VCC (40MX)	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V
VCCA (42MX)	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V
VCCI (42MX)	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V

Note: * Ambient temperature (T_A) is used for commercial and industrial grades; case temperature (T_C) is used for military grades.

3.7.1 5 V TTL Electrical Specifications

The following tables show 5 V TTL electrical specifications.

Table 15 • 5V TTL Electrical Specifications

		Com	mercial	Com	mercial -F	Indus	strial	Milita	nry	
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
VOH ¹	IOH = -10 mA	2.4		2.4						V
	IOH = -4 mA					3.7		3.7		V
VOL ¹	IOL = 10 mA		0.5		0.5					V
	IOL = 6 mA						0.4		0.4	V
VIL		-0.3	0.8	-0.3	0.8	-0.3	0.8	-0.3	0.8	V
VIH (40MX)		2.0	VCC + 0.3	2.0	VCC + 0.3	2.0	VCC + 0.3	2.0	VCC + 0.3	V
VIH (42MX) ²		2.0	VCCI + 0.3	2.0	VCCI + 0.3	2.0	VCCI + 0.3	2.0	VCCI + 0.3	V
IIL	VIN = 0.5 V		-10		-10		-10		-10	μΑ
IIH	VIN = 2.7 V		-10		-10		-10		-10	μΑ
Input Transition Time, T_R and T_F			500		500		500		500	ns
C _{IO} I/O Capacitance			10		10		10		10	pF
Standby Current, ICC ³	A40MX02, A40MX04		3		25		10		25	mA
	A42MX09		5		25		25		25	mA
	A42MX16		6		25		25		25	mA
	A42MX24, A42MX36		20		25		25		25	mA
Low power mode Standby Current	42MX devices only		0.5		ICC - 5.0		ICC - 5.0		ICC - 5.0	mA
IIO, I/O source sink current	Can be derived (http://www.mid				cs/models/it	ois.htm	nl)			



- 1. Only one output tested at a time. VCC/VCCI = Min.
- 2. VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V
- 3. All outputs unloaded. All inputs = VCC/VCCI or GND

3.8 3.3 V Operating Conditions

The following table shows 3.3 V operating conditions.

Table 16 • Absolute Maximum Ratings for 40MX Devices*

Symbol	Parameter	Limits	Units
VCC	DC Supply Voltage	-0.5 to +7.0	V
VI	Input Voltage	-0.5 to VCC + 0.5	V
VO	Output Voltage	-0.5 to VCC + 0.5	V
t _{STG}	Storage Temperature	-65 to + 150	°C

Note: *Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Devices should not be operated outside the recommended operating conditions.

Table 17 • Absolute Maximum Ratings for 42MX Devices*

Symbol	Parameter	Limits	Units
VCCI	DC Supply Voltage for I/Os	-0.5 to +7.0	V
VCCA	DC Supply Voltage for Array	-0.5 to +7.0	V
VI	Input Voltage	-0.5 to VCCI+0.5	V
VO	Output Voltage	-0.5 to VCCI+0.5	V
t _{STG}	Storage Temperature	-65 to +150	°C

Note: *Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Devices should not be operated outside the recommended operating conditions.

Table 18 • Recommended Operating Conditions

Parameter	Commercial	Industrial	Military	Units
Temperature Range*	0 to +70	-40 to +85	-55 to +125	°C
VCC (40MX)	3.0 to 3.6	3.0 to 3.6	3.0 to 3.6	V
VCCA (42MX)	3.0 to 3.6	3.0 to 3.6	3.0 to 3.6	V
VCCI (42MX)	3.0 to 3.6	3.0 to 3.6	3.0 to 3.6	V

Note: *Ambient temperature (T_A) is used for commercial and industrial grades; case temperature (T_C) is used for military grades.

All the following tables show various specifications and operating conditions of 40MX and 42MX FPGAs.



3.8.1 3.3 V LVTTL Electrical Specifications

Table 19 • 3.3V LVTTL Electrical Specifications

		Comr	nercial	Com	nercial -F	Indus	trial	Military		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
VOH ¹	IOH = -4 mA	2.15		2.15		2.4		2.4		V
VOL ¹	IOL = 6 mA		0.4		0.4		0.48		0.48	V
VIL		-0.3	0.8	-0.3	0.8	-0.3	0.8	-0.3	0.8	V
VIH (40MX)		2.0	VCC + 0.3	2.0	VCC + 0.3	2.0	VCC + 0.3	2.0	VCC + 0.3	V
VIH (42MX)		2.0	VCCI + 0.3	2.0	VCCI + 0.3	2.0	VCCI + 0.3	2.0	VCCI + 0.3	V
IIL			-10		-10		-10		-10	μΑ
IIH			-10		-10		-10		-10	μΑ
Input Transition Time, T _R and T _F			500		500		500		500	ns
C _{IO} I/O Capacitance			10		10		10		10	pF
Standby Current, ICC ²	A40MX02, A40MX04		3		25		10		25	mA
	A42MX09		5		25		25		25	mA
	A42MX16		6		25		25		25	mA
	A42MX24, A42MX36		15		25		25		25	mA
Low-Power Mode Standby Current	42MX devices only		0.5		ICC - 5.0		ICC - 5.0		ICC - 5.0	mA
IIO, I/O source sink current	Can be derive	ed from	the IBIS mo	del (htt	p://www.micr	osemi.	com/soc/tech	idocs/	models/ibis.h	ntml)

^{1.} Only one output tested at a time. VCC/VCCI = Min.

3.9 Mixed 5.0 V / 3.3 V Operating Conditions (for 42MX Devices Only)

Table 20 • Absolute Maximum Ratings*

Symbol	Parameter	Limits	Units
VCCI	DC Supply Voltage for I/Os	-0.5 to +7.0	V
VCCA	DC Supply Voltage for Array	-0.5 to +7.0	V
VI	Input Voltage	-0.5 to VCCA +0.5	V
VO	Output Voltage	-0.5 to VCCI + 0.5	V
t _{STG}	Storage Temperature	-65 to +150	°C

Note: *Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device

^{2.} All outputs unloaded. All inputs = VCC/VCCI or GND.



reliability. Devices should not be operated outside the recommended operating conditions.

Table 21 • Recommended Operating Conditions

Parameter	Commercial	Industrial	Military	Units
Temperature Range*	0 to +70	-40 to +85	-55 to +125	°C
VCCA	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V
VCCI	3.14 to 3.47	3.0 to 3.6	3.0 to 3.6	V

Note: *Ambient temperature (T_A) is used for commercial and industrial grades; case temperature (T_C) is used for military grades.



3.9.1 Mixed 5.0V/3.3V Electrical Specifications

Table 22 • Mixed 5.0V/3.3V Electrical Specifications

		Com	mercial	Com	mercial -F	Indu	strial	Military		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
VOH ¹	IOH = -10 mA	2.4		2.4						V
	IOH = -4 mA					2.4		2.4		V
VOL ¹	IOL = 10 mA		0.5		0.5					V
	IOL = 6 mA						0.4		0.4	V
VIL		-0.3	0.8	-0.3	0.8	-0.3	0.8	-0.3	0.8	V
VIH ²		2.0	VCCA + 0.3	2.0	VCCA + 0.3	2.0	VCCA + 0.3	2.0	VCCA + 0.3	V
IL	VIN = 0.5 V		-10		-10		-10		-10	μΑ
IH	VIN = 2.7 V		-10		-10		-10		-10	μΑ
Input Transition Time, T _R and T _F			500		500		500		500	ns
C _{IO} I/O Capacitance			10		10		10		10	pF
Standby Current,	A42MX09		5		25		25		25	mA
ICC ³	A42MX16		6		25		25		25	mA
	A42MX24, A42MX36		20		25		25		25	mA
Low Power Mode Standby Current			0.5		ICC - 5.0		ICC - 5.0		ICC - 5.0	mA

IIO I/O source sink Can be derived from the *IBIS model* (http://www.microsemi.com/soc/techdocs/models/ibis.html) current

3.9.2 Output Drive Characteristics for 5.0 V PCI Signaling

MX PCI device I/O drivers were designed specifically for high-performance PCI systems. Figure 16, page 30 shows the typical output drive characteristics of the MX devices. MX output drivers are compliant with the PCI Local Bus Specification.

Table 23 • DC Specification (5.0 V PCI Signaling)¹

			PCI		MX		
Symbol	Parameter	Condition	Min.	Max.	Min.	Max.	Units
VCCI	Supply Voltage for I/Os		4.75	5.25	4.75	5.25 ²	V
VIH ³	Input High Voltage		2.0	VCC + 0.5	2.0	VCCI + 0.3	V
VIL	Input Low Voltage		-0.5	0.8	-0.3	0.8	V
IIH	Input High Leakage Current	VIN = 2.7 V		70		10	μΑ
IIL	Input Low Leakage Current	VIN=0.5 V		-7 0		-10	μΑ
VOH	Output High Voltage	IOUT = -2 mA IOUT = -6 mA	2.4		3.84		V
VOL	Output Low Voltage	IOUT = 3 mA, 6 mA		0.55		0.33	V

^{1.} Only one output tested at a time. VCCI = min.

^{2.} VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V

^{3.} All outputs unloaded. All inputs = VCCI or GND



Table 23 • DC Specification (5.0 V PCI Signaling)¹ (continued)

			PCI					
Symbol	Parameter	Condition	Min.	Max.	Min.	Max.	Units	
C _{IN}	Input Pin Capacitance			10		10	pF	
C _{CLK}	CLK Pin Capacitance		5	12		10	pF	
L _{PIN}	Pin Inductance			20		< 8 nH ⁴	nH	

- 1. PCI Local Bus Specification, Version 2.1, Section 4.2.1.1.
- 2. Maximum rating for VCCI is -0.5 V to 7.0 V
- 3. VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V.
- 4. Dependent upon the chosen package. PCI recommends QFP and BGA packaging to reduce pin inductance and capacitance.

Table 24 • AC Specifications (5.0V PCI Signaling)*

			PCI		MX			
Symbol	Parameter	Condition	Min.	Max.	Min.	Max.	Units	
ICL	Low Clamp Current	-5 < VIN ≤ -1	-25 + (VIN +1) /0.015		-60	-10	mA	
Slew (r)	Output Rise Slew Rate	0.4 V to 2.4 V load	1	5	1.8	2.8	V/ns	
Slew (f)	Output Fall Slew Rate	2.4 V to 0.4 V load	1	5	2.8	4.3	V/ns	

Note: *PCI Local Bus Specification, Version 2.1, Section 4.2.1.2.



3.9.3 Output Drive Characteristics for 3.3 V PCI Signaling

Table 25 • DC Specification (3.3 V PCI Signaling)¹

			PCI		MX		
Symbol	Parameter	Condition	Min.	Max.	Min.	Max.	Units
VCCI	Supply Voltage for I/Os		3.0	3.6	3.0	3.6 ²	V
VIH	Input High Voltage		0.5	VCC + 0.5	0.5	VCCI + 0.3	V
VIL	Input Low Voltage		-0.5	0.8	-0.3	0.8	V
IIH	Input High Leakage Current	VIN = 2.7 V		70		10	μΑ
IIL	Input Leakage Current			-70		-10	μΑ
VOH	Output High Voltage	IOUT = −2 mA	0.9		3.3		V
VOL	Output Low Voltage	IOUT = 3 mA, 6 mA		0.1		0.1 VCCI	V
C _{IN}	Input Pin Capacitance			10		10	pF
C _{CLK}	CLK Pin Capacitance		5	12		10	pF
L _{PIN}	Pin Inductance			20		< 8 nH ³	nH

^{1.} PCI Local Bus Specification, Version 2.1, Section 4.2.2.1.

Table 26 • AC Specifications for (3.3 V PCI Signaling)*

		Condition	PCI		– Units		
Symbol Parameter		Condition	Min.	Max.	Min.	Max.	– Ullits
ICL	Low Clamp Current	-5 < VIN ≤ -1	-25 + (VIN +1) /0.015		-60	-10	mA
Slew (r)	Output Rise Slew Rate	0.2 V to 0.6 V load	1	4	1.8	2.8	V/ns
Slew (f)	Output Fall Slew Rate	0.6 V to 0.2 V load	1	4	2.8	4.0	V/ns

Note: *PCI Local Bus Specification, Version 2.1, Section 4.2.2.2.

^{2.} Maximum rating for VCCI is-0.5 V to 7.0V.

^{3.} Dependent upon the chosen package. PCI recommends QFP and BGA packaging to reduce pin inductance and capacitance.



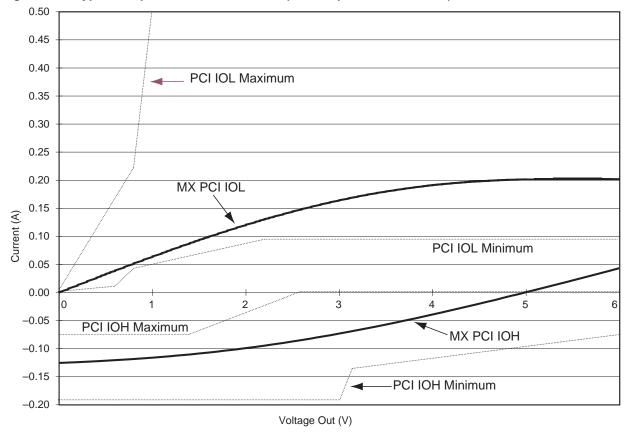


Figure 16 • Typical Output Drive Characteristics (Based Upon Measured Data)

3.9.4 Junction Temperature (T_J)

The temperature variable in the Designer software refers to the junction temperature, not the ambient temperature. This is an important distinction because the heat generated from dynamic power consumption is usually hotter than the ambient temperature. The following equation can be used to calculate junction temperature.

Junction Temperature = $\Delta T + T_a(1)$

EQ4

where:

- T_a = Ambient Temperature
- ΔT = Temperature gradient between junction (silicon) and ambient
- $\Delta T = \theta_{ja} * P (2)$
- P = Power
- θ_{ia} = Junction to ambient of package. θ_{ia} numbers are located in Table 27, page 31.

3.9.5 Package Thermal Characteristics

The device junction-to-case thermal characteristic is θ_{jc} , and the junction-to-ambient air characteristic is θ_{ia} . The thermal characteristics for θ_{ia} are shown with two different air flow rates.

The maximum junction temperature is 150°C.

Maximum power dissipation for commercial- and industrial-grade devices is a function of θ_{ja} .



A sample calculation of the absolute maximum power dissipation allowed for a TQ176 package at commercial temperature and still air is given in the following equation

$$MaximumPowerAllowed = \frac{Max \cdot junction \ temp \cdot (^{\circ}C) - Max \cdot ambient \ temp \cdot (^{\circ}C)}{\theta_{ja}(^{\circ}(C/W))} = \frac{150^{\circ}C - 70^{\circ}C}{(28^{\circ}C)/W} = 2.86W$$

EQ 5

The maximum power dissipation for military-grade devices is a function of θ_{Jc} . A sample calculation of the absolute maximum power dissipation allowed for CQFP 208-pin package at military temperature and still air is given in the following equation

$$MaximumPowerAllowed = \frac{Max \cdot junction \ temp \cdot (^{\circ}C) - Max \cdot ambient \ temp \cdot (^{\circ}C)}{\theta_{jc}(^{\circ}(C/W))} = \frac{150^{\circ}C - 125^{\circ}C}{(6.3^{\circ}C)/W} = 3.97W$$

EQ6

Table 27 • Package Thermal Characteristics

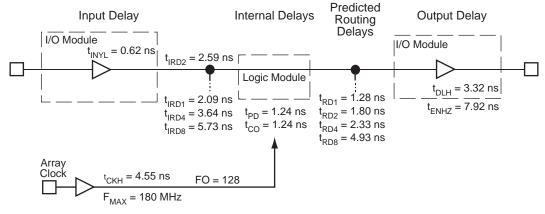
			θ_{ja}			_
Plastic Packages	Pin Count	$\theta_{ extsf{jc}}$	Still Air	1.0 m/s 200 ft/min.	2.5 m/s 500 ft/min.	Units
Plastic Quad Flat Pack	100	12.0	27.8	23.4	21.2	°C/W
Plastic Quad Flat Pack	144	10.0	26.2	22.8	21.1	°C/W
Plastic Quad Flat Pack	160	10.0	26.2	22.8	21.1	°C/W
Plastic Quad Flat Pack	208	8.0	26.1	22.5	20.8	°C/W
Plastic Quad Flat Pack	240	8.5	25.6	22.3	20.8	°C/W
Plastic Leaded Chip Carrier	44	16.0	20.0	24.5	22.0	°C/W
Plastic Leaded Chip Carrier	68	13.0	25.0	21.0	19.4	°C/W
Plastic Leaded Chip Carrier	84	12.0	22.5	18.9	17.6	°C/W
Thin Plastic Quad Flat Pack	176	11.0	24.7	19.9	18.0	°C/W
Very Thin Plastic Quad Flat Pack	80	12.0	38.2	31.9	29.4	°C/W
Very Thin Plastic Quad Flat Pack	100	10.0	35.3	29.4	27.1	°C/W
Plastic Ball Grid Array	272	3.0	18.3	14.9	13.9	°C/W
Ceramic Packages						
Ceramic Pin Grid Array	132	4.8	25.0	20.6	18.7	°C/W
Ceramic Quad Flat Pack	208	2.0	22.0	19.8	18.0	°C/W
Ceramic Quad Flat Pack	256	2.0	20.0	16.5	15.0	°C/W



3.10 Timing Models

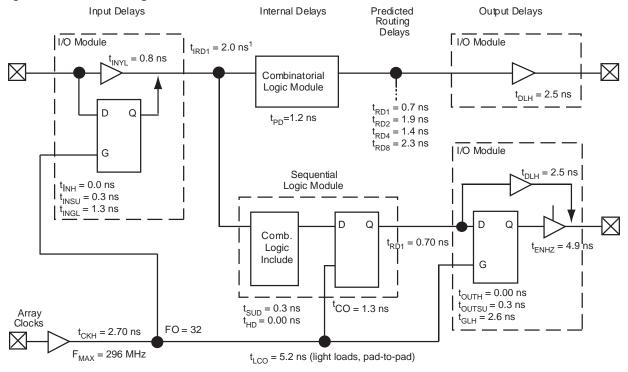
The following figures show various timing models.

Figure 17 • 40MX Timing Model*



Note: Values are shown for 40MX –3 speed grade devices at 5.0 V worst-case commercial conditions.

Figure 18 • 42MX Timing Model



Note: 1. Input module predicted routing delay

Note: 2. Values are shown for A42MX09 –3 speed grade devices at 5.0 V worst-case commercial conditions.



Predicted Routing Input Delays Internal Delays Output Delays Delays I/O Module I/O Module $t_{INPY} = 1.0 \text{ ns}$ t_{IRD1}= 2.0 ns Combinatorial M Ø Module t_{DLH} = 2.6 ns $t_{RD1} = 0.9 \text{ ns}$ t_{PD} =1.3 ns $t_{RD2} = 1.3 \text{ ns}$ $t_{RD4} = 2.0 \text{ ns}$ G Decode $t_{INH} = 0.0 \text{ ns}$ Module $t_{INSU} = 0.5 \text{ ns}$ $t_{RDD} = 0.3 \text{ ns}$ t_{INGO} = 1.4 ns $t_{PDD} = 1.6 \text{ ns}$ I/O Module Sequential Logic Module = 0.9 nsComb. $t_{ENHZ} = 5.3 \text{ ns}$ Logic Include G $t_{LH} = 0.00 \text{ ns}$ t_{CO} = 1.3 ns $t_{SUD} = 3.0 \text{ ns}$ $t_{LSU} = 0.5 \text{ ns}$ $t_{HD} = 0.0 \text{ ns}$ $t_{GHL} = 2.9 \text{ ns}$

Figure 19 • 42MX Timing Model (Logic Functions Using Quadrant Clocks)

Note: 1. Load-dependent

FMAX=180 MHz

 $t_{CKH} = 3.03 \text{ ns}^{-1}$

Quadrant

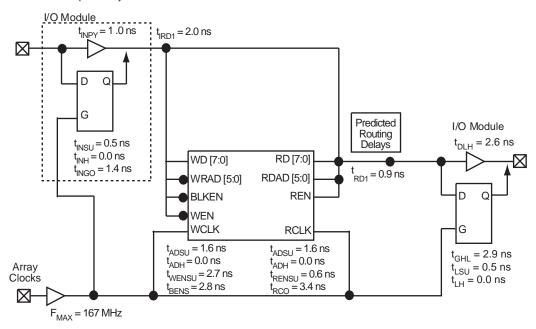
Clocks

Note: 2. Values are shown for A42MX36 -3 speed grade devices at 5.0 V worst-case commercial conditions



Figure 20 • 42MX Timing Model (SRAM Functions)

Input Delays



Note: Values are shown for A42MX36 –3 speed grade devices at 5.0 V worst-case commercial conditions.

3.10.1 Parameter Measurement

The following figures show parameter measurement details.

Figure 21 • Output Buffer Delays



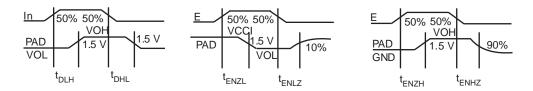




Figure 22 • AC Test Loads

Load 1 (Used to measure propagation delay)

Load 2 (Used to measure rising/falling edges)

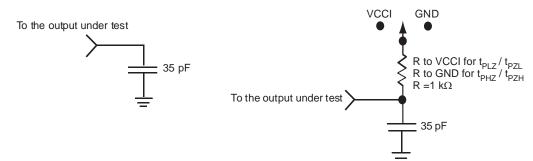


Figure 23 • Input Buffer Delays

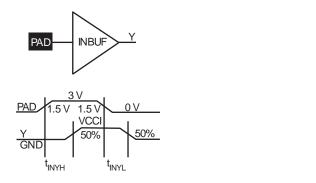
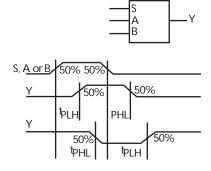


Figure 24 • Module Delays

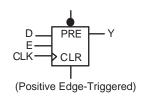


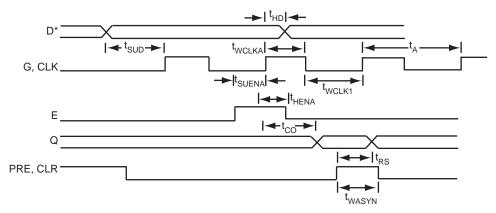


3.10.2 Sequential Module Timing Characteristics

The following figure shows sequential module timing characteristics.

Figure 25 • Flip-Flops and Latches





Note: *D represents all data functions involving A, B, and S for multiplexed flip-flops.

3.10.3 Sequential Timing Characteristics

The following figures show sequential timing characteristics.

Figure 26 • Input Buffer Latches

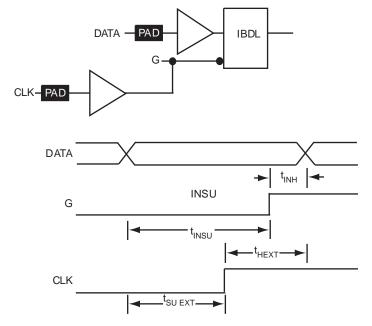
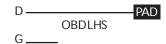
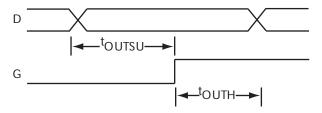




Figure 27 • Output Buffer Latches

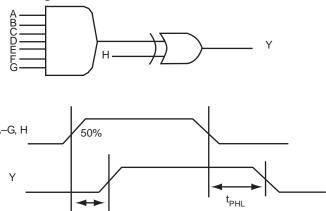




3.10.4 Decode Module Timing

The following figure shows decode module timing.

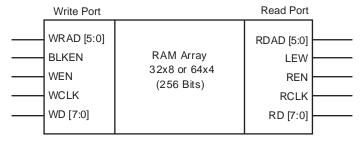
Figure 28 • Decode Module Timing



3.10.5 SRAM Timing Characteristics

The following figure shows SRAM timing characteristics.

Figure 29 • SRAM Timing Characteristics

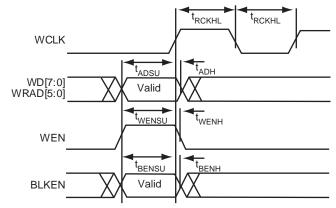




3.10.6 Dual-Port SRAM Timing Waveforms

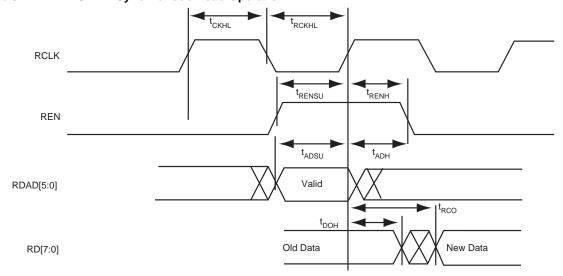
The following figures show dual-port SRAM timing waveforms.

Figure 30 • 42MX SRAM Write Operation



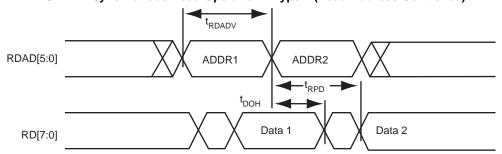
Note: Identical timing for falling edge clock

Figure 31 • 42MX SRAM Synchronous Read Operation



Note: Identical timing for falling edge clock

Figure 32 • 42MX SRAM Asynchronous Read Operation—Type 1 (Read Address Controlled)





WEN

WD[7:0]
WRAD[5:0]
BLKEN

WCLK

RD[7:0]

Old Data

Twensu

twenh

twenh

New Data

Figure 33 • 42MX SRAM Asynchronous Read Operation—Type 2 (Write Address Controlled)

3.10.7 Predictable Performance: Tight Delay Distributions

Propagation delay between logic modules depends on the resistive and capacitive loading of the routing tracks, the interconnect elements, and the module inputs being driven. Propagation delay increases as the length of routing tracks, the number of interconnect elements, or the number of inputs increases.

From a design perspective, the propagation delay can be statistically correlated or modeled by the fanout (number of loads) driven by a module. Higher fanout usually requires some paths to have longer routing tracks.

The MX FPGAs deliver a tight fanout delay distribution, which is achieved in two ways: by decreasing the delay of the interconnect elements and by decreasing the number of interconnect elements per path.

Microsemi's patented antifuse offers a very low resistive/capacitive interconnect. The antifuses, fabricated in 0.45 μ m lithography, offer nominal levels of 100 Ω resistance and 7.0 fF capacitance per antifuse.

MX fanout distribution is also tight due to the low number of antifuses required for each interconnect path. The proprietary architecture limits the number of antifuses per path to a maximum of four, with 90 percent of interconnects using only two antifuses.

3.11 Timing Characteristics

Device timing characteristics fall into three categories: family-dependent, device-dependent, and design-dependent. The input and output buffer characteristics are common to all MX devices. Internal routing delays are device-dependent; actual delays are not determined until after place-and-route of the user's design is complete. Delay values may then be determined by using the Designer software utility or by performing simulation with post-layout delays.

3.11.1 Critical Nets and Typical Nets

Propagation delays are expressed only for typical nets, which are used for initial design performance evaluation. Critical net delays can then be applied to the most timing critical paths. Critical nets are determined by net property assignment in Microsemi's Designer software prior to placement and routing. Up to 6% of the nets in a design may be designated as critical.



3.11.2 Long Tracks

Some nets in the design use long tracks, which are special routing resources that span multiple rows, columns, or modules. Long tracks employ three and sometimes four antifuse connections, which increase capacitance and resistance, resulting in longer net delays for macros connected to long tracks. Typically, up to 6 percent of nets in a fully utilized device require long tracks.

Long tracks add approximately a 3 ns to a 6 ns delay, which is represented statistically in higher fanout (FO=8) routing delays in the data sheet specifications section, shown in Table 34, page 43.

3.11.3 Timing Derating

MX devices are manufactured with a CMOS process. Therefore, device performance varies according to temperature, voltage, and process changes. Minimum timing parameters reflect maximum operating voltage, minimum operating temperature and best-case processing. Maximum timing parameters reflect minimum operating voltage, maximum operating temperature and worst-case processing.

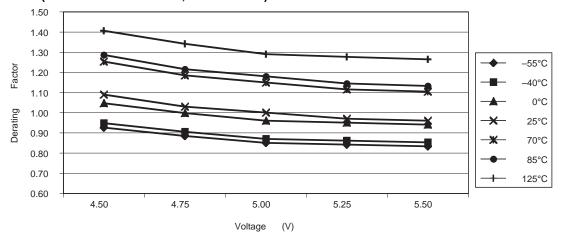
3.11.4 Temperature and Voltage Derating Factors

The following tables and figures show temperature and voltage derating factors for 40MX and 42MX FPGAs.

Table 28 • 42MX Temperature and Voltage Derating Factors (Normalized to $T_J = 25^{\circ}C$, VCCA = 5.0 V)

	Temperature											
42MX Voltage	-55°C	-40°C	0°C	25°C	70°C	85°C	125°C					
4.50	0.93	0.95	1.05	1.09	1.25	1.29	1.41					
4.75	0.88	0.90	1.00	1.03	1.18	1.22	1.34					
5.00	0.85	0.87	0.96	1.00	1.15	1.18	1.29					
5.25	0.84	0.86	0.95	0.97	1.12	1.14	1.28					
5.50	0.83	0.85	0.94	0.96	1.10	1.13	1.26					

Figure 34 • 42MX Junction Temperature and Voltage Derating Curves (Normalized to TJ = 25°C, VCCA = 5.0 V)



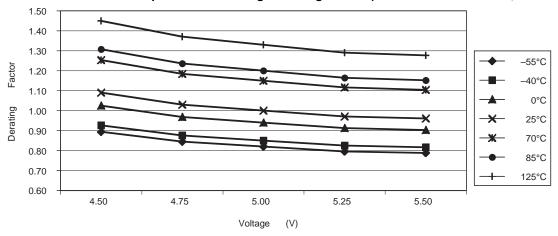


Note: This derating factor applies to all routing and propagation delays

Table 29 • 40MX Temperature and Voltage Derating Factors(Normalized to TJ = 25°C, VCC = 5.0 V)

	Temperature										
40MX Voltage	-55°C	-40°C	0°C	25°C	70°C	85°C	125°C				
4.50	0.89	0.93	1.02	1.09	1.25	1.31	1.45				
4.75	0.84	0.88	0.97	1.03	1.18	1.24	1.37				
5.00	0.82	0.85	0.94	1.00	1.15	1.20	1.33				
5.25	0.80	0.82	0.91	0.97	1.12	1.16	1.29				
5.50	0.79	0.82	0.90	0.96	1.10	1.15	1.28				

Figure 35 • 40MX Junction Temperature and Voltage Derating Curves (Normalized to TJ = 25°C, VCC = 5.0 V)



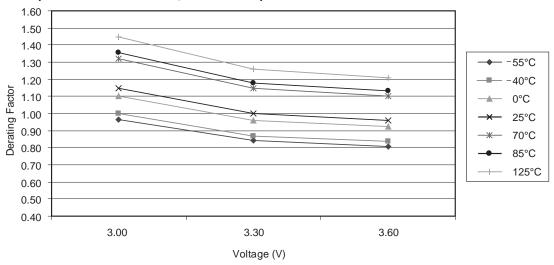
Note: This derating factor applies to all routing and propagation delays

Table 30 • 42MX Temperature and Voltage Derating Factors(Normalized to TJ = 25°C, VCCA = 3.3 V)

	Temperature										
42MX Voltage	-55°C	-40°C	0°C	25°C	70°C	85°C	125°C				
3.00	0.97	1.00	1.10	1.15	1.32	1.36	1.45				
3.30	0.84	0.87	0.96	1.00	1.15	1.18	1.26				
3.60	0.81	0.84	0.92	0.96	1.10	1.13	1.21				



Figure 36 • 42MX Junction Temperature and Voltage Derating Curves (Normalized to TJ = 25°C, VCCA = 3.3 V)

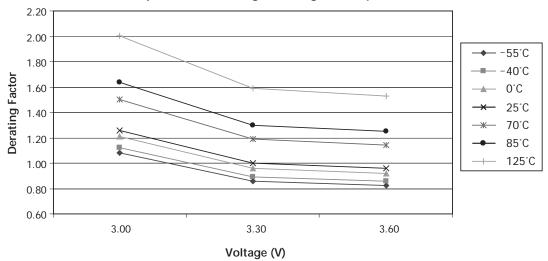


Note: This derating factor applies to all routing and propagation delays

Table 31 • 40MX Temperature and Voltage Derating Factors (Normalized to TJ = 25°C, VCC = 3.3 V)

	Temperature											
40MX Voltage	-55°C	-40°C	0°C	25°C	70°C	85°C	125°C					
3.00	1.08	1.12	1.21	1.26	1.50	1.64	2.00					
3.30	0.86	0.89	0.96	1.00	1.19	1.30	1.59					
3.60	0.83	0.85	0.92	0.96	1.14	1.25	1.53					

Figure 37 • 40MX Junction Temperature and Voltage Derating Curves (Normalized to TJ = 25°C, VCC = 3.3 V)



Note: This derating factor applies to all routing and propagation delays



3.11.5 PCI System Timing Specification

The following tables list the critical PCI timing parameters and the corresponding timing parameters for the MX PCI-compliant devices.

3.11.6 PCI Models

Microsemi provides synthesizable VHDL(VHSIC Hardware Description Language) and Verilog-HDL models for a PCI Target interface, a PCI Target and Target+DMA Master interface. Contact the Microsemi sales representative for more details.

Table 32 • Clock Specification for 33 MHz PCI

		PCI		A42N	1X24	A42N		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{CYC}	CLK Cycle Time	30		4.0		4.0		ns
t _{HIGH}	CLK High Time	11		1.9		1.9		ns
t _{LOW}	CLK Low Time	11		1.9		1.9		ns

Table 33 • Timing Parameters for 33 MHz PCI

		PCI		A42N	1X24	A42N		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{VAL}	CLK to Signal Valid—Bused Signals	2	11	2.0	9.0	2.0	9.0	ns
t _{VAL(PTP)}	CLK to Signal Valid—Point-to-Point	2 ²	12	2.0	9.0	2.0	9.0	ns
t _{ON}	Float to Active	2		2.0	4.0	2.0	4.0	ns
t _{OFF}	Active to Float		28		8.3 ¹		8.3 ¹	ns
t _{SU}	Input Set-Up Time to CLK—Bused Signals	7		1.5		1.5		ns
t _{SU(PTP)}	Input Set-Up Time to CLK—Point-to-Point	10, 12 ²		1.5		1.5		ns
t _H	Input Hold to CLK	0		0		0		ns

^{1.} TOFF is system dependent. MX PCI devices have 7.4 ns turn-off time, reflection is typically an additional 10 ns.

3.11.6.1 Timing Characteristics

The following tables list the timing characteristics.

Table 34 • A40MX02 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C)

		-3 Sp	eed	-2 Sp	eed	-1 Sp	eed	Std S	peed	−F Sp	eed	
Parai	meter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic	Module Propagation Delays	S										
t _{PD1}	Single Module		1.2		1.4		1.6		1.9		2.7	ns
t _{PD2}	Dual-Module Macros		2.7		3.1		3.5		4.1		5.7	ns
t _{CO}	Sequential Clock-to-Q		1.2		1.4		1.6		1.9		2.7	ns
t _{GO}	Latch G-to-Q		1.2		1.4		1.6		1.9		2.7	ns
t _{RS}	Flip-Flop (Latch) Reset-to-Q		1.2		1.4		1.6		1.9		2.7	ns
Logic	Module Predicted Routing	Delays	,1									

REQ# and GNT# are point-to-point signals and have different output valid delay and input setup times than do bussed signals. GNT# has a setup of 10; REW# has a setup of 12.



Table 34 • A40MX02 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C) (continued)

		−3 S _I	peed	–2 Sp	peed	–1 Sp	eed	Std S	peed	−F Sp	eed	
Paran	neter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{RD1}	FO = 1 Routing Delay		1.3		1.5		1.7		2.0		2.8	ns
t _{RD2}	FO = 2 Routing Delay		1.8		2.1		2.4		2.8		3.9	ns
t _{RD3}	FO = 3 Routing Delay		2.3		2.7		3.0		3.6		5.0	ns
t _{RD4}	FO = 4 Routing Delay		2.9		3.3		3.7		4.4		6.1	ns
t _{RD8}	FO = 8 Routing Delay		4.9		5.7		6.5		7.6		10.6	ns
Logic	Module Sequential Timing	2										
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up	3.1		3.5		4.0		4.7		6.6		ns
t _{HD} 3	Flip-Flop (Latch) Data Input Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{SUEN} A	Flip-Flop (Latch) Enable Set-Up	3.1		3.5		4.0		4.7		6.6		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCL} KA	Flip-Flop (Latch) Clock Active Pulse Width	3.3		3.8		4.3		5.0		7.0		ns
t _{WAS} YN	Flip-Flop (Latch) Asynchronous Pulse Width	3.3		3.8		4.3		5.0		7.0		ns
t _A	Flip-Flop Clock Input Period	4.8		5.6		6.3		7.5		10.4		ns
f _{MAX}	Flip-Flop (Latch) Clock Frequency (FO = 128)		181		168		154		134		80	MHz
Input	Module Propagation Delay	S										
t _{INYH}	Pad-to-Y HIGH		0.7		8.0		0.9		1.1		1.5	ns
t _{INYL}	Pad-to-Y LOW		0.6		0.7		8.0		1.0		1.3	ns
Input	Module Predicted Routing	Delays	1									
t _{IRD1}	FO = 1 Routing Delay		2.1		2.4		2.2		3.2		4.5	ns
t _{IRD2}	FO = 2 Routing Delay		2.6		3.0		3.4		4.0		5.6	ns
t _{IRD3}	FO = 3 Routing Delay		3.1		3.6		4.1		4.8		6.7	ns
t _{IRD4}	FO = 4 Routing Delay		3.6		4.2		4.8		5.6		7.8	ns
t _{IRD8}	FO = 8 Routing Delay		5.7		6.6		7.5		8.8		12.4	ns
Globa	al Clock Network											
t _{CKH}	Input Low to HIGH FO = 16 FO = 12		4.6 4.6		5.3 5.3		6.0 6.0		7.0 7.0		9.8 9.8	ns
t _{CKL}	Input High to LOW FO = 16 FO = 12		4.8 4.8		5.6 5.6		6.3 6.3		7.4 7.4		10.4 10.4	ns
t _{PWH}	Minimum Pulse FO = 16 Width HIGH FO = 12			2.6 2.7		2.9 3.1		3.4 3.6		4.8 5.1		ns
	Minimum Pulse FO = 16	2.2		2.6		2.9		3.4		4.8		ns



Table 34 • A40MX02 Timing Characteristics (Nominal 5.0 V Operation)
(Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C) (continued)

			-3 Sp	eed	–2 Sp	eed	-1 Sp	eed	Std S	peed	−F Sp	eed	
Paran	neter / Descriptior	1	Min.	Max.	Units								
t _{CKS}	Maximum Skew	FO = 16		0.4		0.5		0.5		0.6		0.8	ns
W		FO = 128		0.5		0.6		0.7		8.0		1.2	
t _P	Minimum Period		4.7		5.4		6.1		7.2		10.0		ns
		FO = 128	4.8		5.6		6.3		7.5		10.4		
f_{MAX}	Maximum	FO = 16		188		175		160		139		83	MHz
	Frequency	FO = 128		181		168		154		134		80	
TTL C	Output Module Tim	ning ⁴											
t_{DLH}	Data-to-Pad HIGH	ł		3.3		3.8		4.3		5.1		7.2	ns
t _{DHL}	Data-to-Pad LOW	,		4.0		4.6		5.2		6.1		8.6	ns
t _{ENZH}	Enable Pad Z to F	lIGH		3.7		4.3		4.9		5.8		8.0	ns
t _{ENZL}	Enable Pad Z to L	.OW		4.7		5.4		6.1		7.2		10.1	ns
t _{ENHZ}	Enable Pad HIGH	to Z		7.9		9.1		10.4		12.2		17.1	ns
t _{ENLZ}	Enable Pad LOW	to Z		5.9		6.8		7.7		9.0		12.6	ns
d _{TLH}	Delta LOW to HIGH			0.02		0.02		0.03		0.03		0.04	ns/pF
d _{THL}	Delta HIGH to LOW			0.03		0.03		0.03		0.04		0.06	ns/pF
CMOS	S Output Module 1	Γiming ⁴											
t _{DLH}	Data-to-Pad HIGH	ł		3.9		4.5		5.1		6.05		8.5	ns
t _{DHL}	Data-to-Pad LOW			3.4		3.9		4.4		5.2		7.3	ns
t _{ENZH}	Enable Pad Z to F	IIGH		3.4		3.9		4.4		5.2		7.3	ns
t _{ENZL}	Enable Pad Z to L	.OW		4.9		5.6		6.4		7.5		10.5	ns
t _{ENHZ}	Enable Pad HIGH	to Z		7.9		9.1		10.4		12.2		17.0	ns
t _{ENLZ}	Enable Pad LOW	to Z		5.9		6.8		7.7		9.0		12.6	ns
d _{TLH}	Delta LOW to HIGH			0.03		0.04		0.04		0.05		0.07	ns/pF
d _{THL}	Delta HIGH to LOW			0.02		0.02		0.03		0.03		0.04	ns/pF

Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance

Table 35 • A40MX02 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C)

			peed	-2 Speed		-1 Sp	peed	Std S	peed	−F S	peed	
Paran	neter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic	Module Propagation Delays	3										
t _{PD1}	Single Module		1.7		2.0		2.3		2.7		3.7	ns

^{2.} Set-up times assume fanout of 3. Further testing information can be obtained from the Timer utility

^{3.} The hold time for the DFME1A macro may be greater than 0 ns. Use the Timer tool from the Designer software to check the hold time for this macro.

^{4.} Delays based on 35pF loading



Table 35 • A40MX02 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C) (continued)

	-	-3 Sp	peed	-2 S _I	peed	-1 S _I	peed	Std S	peed	−F S	peed	
Parame	eter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{PD2}	Dual-Module Macros		3.7		4.3		4.9		5.7		8.0	ns
t _{CO}	Sequential Clock-to-Q		1.7		2.0		2.3		2.7		3.7	ns
t _{GO}	Latch G-to-Q		1.7		2.0		2.3		2.7		3.7	ns
t _{RS}	Flip-Flop (Latch) Reset-to-Q		1.7		2.0		2.3		2.7		3.7	ns
Logic N	Module Predicted Routing D	elays										
t _{RD1}	FO = 1 Routing Delay		2.0		2.2		2.5		3.0		4.2	ns
t _{RD2}	FO = 2 Routing Delay		2.7		3.1		3.5		4.1		5.7	ns
t _{RD3}	FO = 3 Routing Delay		3.4		3.9		4.4		5.2		7.3	ns
t _{RD4}	FO = 4 Routing Delay		4.2		4.8		5.4		6.3		8.9	ns
t _{RD8}	FO = 8 Routing Delay		7.1		8.2		9.2		10.9		15.2	ns
Logic N	Module Sequential Timing ²											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up	4.3		4.9		5.6		6.6		9.2		ns
t _{HD} ³	Flip-Flop (Latch) Data Input Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	4.3		4.9		5.6		6.6		9.2		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	4.6		5.3		6.0		7.0		9.8		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	4.6		5.3		6.0		7.0		9.8		ns
t _A	Flip-Flop Clock Input Period	6.8		7.8		8.9		10.4		14.6		ns
f _{MAX}	Flip-Flop (Latch) Clock Frequency (FO = 128)		109		101		92		80		48	MHz
Input N	Iodule Propagation Delays											
t _{INYH}	Pad-to-Y HIGH		1.0		1.1		1.3		1.5		2.1	ns
t _{INYL}	Pad-to-Y LOW		0.9		1.0		1.1		1.3		1.9	ns
Input N	Iodule Predicted Routing De	elays ¹										
t _{IRD1}	FO = 1 Routing Delay		2.9		3.4		3.8		4.5		6.3	ns
t _{IRD2}	FO = 2 Routing Delay		3.6		4.2		4.8		5.6		7.8	ns
t _{IRD3}	FO = 3 Routing Delay		4.4		5.0		5.7		6.7		9.4	ns
t _{IRD4}	FO = 4 Routing Delay		5.1		5.9		6.7		7.8		11.0	ns
t _{IRD8}	FO = 8 Routing Delay		8.0		9.26		10.5		12.6		17.3	ns
	Clock Network											
t _{CKH}	Input LOW to FO = 16 HIGH FO = 128		6.4 6.4		7.4 7.4		8.3 8.3		9.8 9.8		13.7 13.7	ns



Table 35 • A40MX02 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C) (continued)

			-3 Sp	peed	-2 S _I	peed	-1 Sp	peed	Std S	Speed	−F S	peed	
Param	eter / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{CKL}	Input HIGH to LOW	FO = 16 FO = 128		6.7 6.7		7.8 7.8		8.8 8.8		10.4 10.4		14.5 14.5	ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 16 FO = 128	3.1 3.3		3.6 3.8		4.1 4.3		4.8 5.1		6.7 7.1		ns
t _{PWL}	Minimum Pulse Width LOW	FO = 16 FO = 128	3.1 3.3		3.6 3.8		4.1 4.3		4.8 5.1		6.7 7.1		ns
t _{CKSW}	Maximum Skew	FO = 16 FO = 128		0.6 0.8		0.6 0.9		0.7 1.0		0.8 1.2		1.2 1.6	ns
t _P	Minimum Period	FO = 16 FO = 128	6.5 6.8		7.5 7.8		8.5 8.9		10.1 10.4		14.1 14.6		ns
f _{MAX}	Maximum Frequency	FO = 16 FO = 128		113 109		105 101		96 92		83 80		50 48	MHz
TTL O	utput Module Timi	ng ⁴											
t _{DLH}	Data-to-Pad HIGH			4.7		5.4		6.1		7.2		10.0	ns
t _{DHL}	Data-to-Pad LOW	1		5.6		6.4		7.3		8.6		12.0	ns
t _{ENZH}	Enable Pad Z to I	HIGH		5.2		6.0		6.8		8.1		11.3	ns
t _{ENZL}	Enable Pad Z to L	_OW		6.6		7.6		8.6		10.1		14.1	ns
t _{ENHZ}	Enable Pad HIGH	l to Z		11.1		12.8		14.5		17.1		23.9	ns
t _{ENLZ}	Enable Pad LOW	to Z		8.2		9.5		10.7		12.6		17.7	ns
d _{TLH}	Delta LOW to HIGH			0.03		0.03		0.04		0.04		0.06	ns/pF
d _{THL}	Delta HIGH to LOW			0.04		0.04		0.05		0.06		0.08	ns/pF



Table 35 • A40MX02 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C) (continued)

		–3 Sp	eed	–2 Sp	peed	-1 Sp	peed	Std S	peed	−F S	peed	
Param	eter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
CMOS	Output Module Timing ⁴											
t _{DLH}	Data-to-Pad HIGH		5.5		6.4		7.2		8.5		11.9	ns
t _{DHL}	Data-to-Pad LOW		4.8		5.5		6.2		7.3		10.2	ns
t _{ENZH}	Enable Pad Z to HIGH		4.7		5.5		6.2		7.3		10.2	ns
t _{ENZL}	Enable Pad Z to LOW		6.8		7.9		8.9		10.5		14.7	ns
t _{ENHZ}	Enable Pad HIGH to Z		11.1		12.8		14.5		17.1		23.9	ns
t _{ENLZ}	Enable Pad LOW to Z		8.2		9.5		10.7		12.6		17.7	ns
d _{TLH}	Delta LOW to HIGH		0.05		0.05		0.06		0.07		0.10	ns/pF
d _{THL}	Delta HIGH to LOW		0.03		0.03		0.04		0.04		0.06	ns/pF

Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

Table 36 • A40MX04 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C)

Speed -F S	peed	
Max. Min.	Max.	Units
1.9	2.7	ns
4.1	5.7	ns
1.9	2.7	ns
1.9	2.7	ns
1.9	2.7	ns
2.1	3.0	ns
2.9	4.1	ns
3.7	5.2	ns
4.5	6.3	ns
7.8	10.9	ns
6.6		ns
0.0		ns
	6.6	8 10.9

^{2.} Set-up times assume fanout of 3. Further testing information can be obtained from the Timer utility.

^{3.} The hold time for the DFME1A macro may be greater than 0 ns. Use the Timer tool from the Designer software to check the hold time for this macro

^{4.} Delays based on 35 pF loading



Table 36 • A40MX04 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C) (continued)

			-3 Sp	peed	–2 Sp	oeed	-1 S _I	peed	Std S	Speed	−F S _I	peed	
Parame	ter / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up		3.1		3.5		4.0		4.7		6.6		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold		0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse	Width	3.3		3.8		4.3		5.0		7.0		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Puls	e Width	3.3		3.8		4.3		5.0		7.0		ns
t _A	Flip-Flop Clock Inpo	ut Period	4.8		5.6		6.3		7.5		10.4		ns
f _{MAX}	Flip-Flop (Latch) Clock Frequency (FO = 128)			181		167		154		134		80	MHz
Input M	odule Propagation	Delays											
t _{INYH}	Pad-to-Y HIGH			0.7		0.8		0.9		1.1		1.5	ns
t _{INYL}	Pad-to-Y LOW			0.6		0.7		0.8		1.0		1.3	ns
Input M	odule Predicted Ro	uting Dela	ys ¹										
t _{IRD1}	FO = 1 Routing Del	lay		2.1		2.4		2.2		3.2		4.5	ns
t _{IRD2}	FO = 2 Routing Del	lay		2.6		3.0		3.4		4.0		5.6	ns
t _{IRD3}	FO = 3 Routing Del	lay		3.1		3.6		4.1		4.8		6.7	ns
t _{IRD4}	FO = 4 Routing Del	lay		3.6		4.2		4.8		5.6		7.8	ns
t _{IRD8}	FO = 8 Routing Del	lay		5.7		6.6		7.5		8.8		12.4	ns
Global (Clock Network												
t _{CKH}	Input Low to HIGH	FO = 16 FO = 128		4.6 4.6		5.3 5.3		6.0 6.0		7.0 7.0		9.8 9.8	ns
t _{CKL}	Input High to LOW	FO = 16 FO = 128		4.8 4.8		5.6 5.6		6.3 6.3		7.4 7.4		10.4 10.4	ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 16 FO = 128	2.2 2.4		2.6 2.7		2.9 3.1		3.4 3.6		4.8 5.1		ns
t _{PWL}	Minimum Pulse Width LOW	FO = 16 FO = 128			2.6 2.7		2.9 3.01		3.4 3.6		4.8 5.1		ns
t _{CKSW}	Maximum Skew	FO = 16 FO = 128		0.4 0.5		0.5 0.6		0.5 0.7		0.6 0.8		0.8 1.2	ns
t _P	Minimum Period	FO = 16 FO = 128			5.4 5.6		6.1 6.3		7.2 7.5		10.0 10.4		ns
f _{MAX}	Maximum Frequency	FO = 16 FO = 128		188 181		175 168		160 154		139 134		83 80	MHz
TTL Out	tput Module Timing	4											
t _{DLH}	Data-to-Pad HIGH			3.3		3.8		4.3		5.1		7.2	ns
t _{DHL}	Data-to-Pad LOW			4.0		4.6		5.2		6.1		8.6	ns
t _{ENZH}	Enable Pad Z to HI	GH		3.7		4.3		4.9		5.8		8.0	ns



Table 36 • A40MX04 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C) (continued)

		-3 Speed		-2 Speed		-1 Speed		Std S	Speed	−F S	peed	
Parame	eter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{ENZL}	Enable Pad Z to LOW		4.7		5.4		6.1		7.2		10.1	ns
t _{ENHZ}	Enable Pad HIGH to Z		7.9		9.1		10.4		12.2		17.1	ns
t _{ENLZ}	Enable Pad LOW to Z		5.9		6.8		7.7		9.0		12.6	ns
d _{TLH}	Delta LOW to HIGH		0.02		0.02		0.03		0.03		0.04	ns/pF
d _{THL}	Delta HIGH to LOW		0.03		0.03		0.03		0.04		0.06	ns/pF



Table 36 • A40MX04 Timing Characteristics (Nominal 5.0 V Operation)
(Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C) (continued)

				–2 Sp	peed	-1 Speed		Std S	Speed	−F S	peed	
Parame	eter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
CMOS	Output Module Timing ¹											
t _{DLH}	Data-to-Pad HIGH		3.9		4.5		5.1		6.05		8.5	ns
t _{DHL}	Data-to-Pad LOW		3.4		3.9		4.4		5.2		7.3	ns
t _{ENZH}	Enable Pad Z to HIGH		3.4		3.9		4.4		5.2		7.3	ns
t _{ENZL}	Enable Pad Z to LOW		4.9		5.6		6.4		7.5		10.5	ns
t _{ENHZ}	Enable Pad HIGH to Z		7.9		9.1		10.4		12.2		17.0	ns
t _{ENLZ}	Enable Pad LOW to Z		5.9		6.8		7.7		9.0		12.6	ns
d _{TLH}	Delta LOW to HIGH		0.03		0.04		0.04		0.05		0.07	ns/pF
d _{THL}	Delta HIGH to LOW		0.02		0.02		0.03		0.03		0.04	ns/pF

^{1.} Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

Table 37 • A40MX04 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C)

		-3 S _I	peed	-2 S _I	peed	–1 Sp	eed	Std S	Speed	−F S _l	peed	
Paramet	er / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic Mo	odule Propagation Delays											
t _{PD1}	Single Module		1.7		2.0		2.3		2.7		3.7	ns
t _{PD2}	Dual-Module Macros		3.7		4.3		4.9		5.7		8.0	ns
t _{CO}	Sequential Clock-to-Q		1.7		2.0		2.3		2.7		3.7	ns
t _{GO}	Latch G-to-Q		1.7		2.0		2.3		2.7		3.7	ns
t _{RS}	Flip-Flop (Latch) Reset-to-Q		1.7		2.0		2.3		2.7		3.7	ns
Logic Mo	odule Predicted Routing Delays ¹											
t _{RD1}	FO = 1 Routing Delay		1.9		2.2		2.5		3.0		4.2	ns
t _{RD2}	FO = 2 Routing Delay		2.7		3.1		3.5		4.1		5.7	ns
t _{RD3}	FO = 3 Routing Delay		3.4		3.9		4.4		5.2		7.3	ns
t _{RD4}	FO = 4 Routing Delay		4.1		4.8		5.4		6.3		8.9	ns
t _{RD8}	FO = 8 Routing Delay		7.1		8.1		9.2		10.9		15.2	ns
Logic Mo	odule Sequential Timing ²											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up	4.3		5.0		5.6		6.6		9.2		ns
t _{HD} ³	Flip-Flop (Latch) Data Input Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	4.3		5.0		5.6		6.6		9.2		ns

^{2.} Set-up times assume fanout of 3. Further testing information can be obtained from the Timer utility

^{3.} The hold time for the DFME1A macro may be greater than 0 ns. Use the Timer utility from the Designer software to check the hold time for this macro.

^{4.} Delays based on 35 pF loading



Table 37 • A40MX04 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C) (continued)

	A . A Day a death of	-3 S _I	peed	-2 S _I	peed	-1 Sp	eed	Std S	Speed	−F S _I	peed	
Paramet	er / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	4.6		5.3		5.6		7.0		9.8		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	4.6		5.3		5.6		7.0		9.8		ns
t _A	Flip-Flop Clock Input Period	6.8		7.8		8.9		10.4		14.6		ns
f _{MAX}	Flip-Flop (Latch) Clock Frequency (FO = 128)		109		101		92		80		48	MHz
Input Mo	odule Propagation Delays											
t _{INYH}	Pad-to-Y HIGH		1.0		1.1		1.3		1.5		2.1	ns
t _{INYL}	Pad-to-Y LOW		0.9		1.0		1.1		1.3		1.9	ns



Table 37 • A40MX04 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C) (continued)

			−3 S	peed	–2 S	peed	–1 Sp	peed	Std S	Speed	−F S	peed	
Parame	eter / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Input M	odule Predicted Rout	ing Delays1											
t _{IRD1}	FO = 1 Routing Dela	ay		2.9		3.3		3.8		4.5		6.3	ns
t _{IRD2}	FO = 2 Routing Dela	ay		3.6		4.2		4.8		5.6		7.8	ns
t _{IRD3}	FO = 3 Routing Dela	ay		4.4		5.0		5.7		6.7		9.4	ns
t _{IRD4}	FO = 4 Routing Dela	ay		5.1		5.9		6.7		7.8		11.0	ns
t _{IRD8}	FO = 8 Routing Delay			8.0		9.3		10.5		12.4		17.2	ns
Global	Clock Network												
t _{CKH}	Input LOW to HIGH	FO = 16 FO = 128		6.4 6.4		7.4 7.4		8.4 8.4		9.9 9.9		13.8 13.8	ns
t _{CKL}	Input HIGH to LOW	FO = 16 FO = 128		6.8 6.8		7.8 7.8		8.9 8.9		10.4 10.4		14.6 14.6	ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 16 FO = 128	3.1 3.3		3.6 3.8		4.1 4.3		4.8 5.1		6.7 7.1		ns
t _{PWL}	Minimum Pulse Width LOW	FO = 16 FO = 128	3.1 3.3		3.6 3.8		4.1 4.3		4.8 5.1		6.7 7.1		ns
t _{CKSW}	Maximum Skew	FO = 16 FO = 128		0.6 0.8		0.6 0.9		0.7 1.0		0.8 1.2		1.2 1.6	ns
t _P	Minimum Period	FO = 16 FO = 128	6.5 6.8		7.5 7.8		8.5 8.9		10.1 10.4		14.1 14.6		ns
f _{MAX}	Maximum Frequency	FO = 16 FO = 128		113 109		105 101		96 92		83 80		50 48	MHz
TTL Ou	tput Module Timing ⁴												
t _{DLH}	Data-to-Pad HIGH			4.7		5.4		6.1		7.2		10.0	ns
t _{DHL}	Data-to-Pad LOW			5.6		6.4		7.3		8.6		12.0	ns
t _{ENZH}	Enable Pad Z to HIG	SH .		5.2		6.0		6.9		8.1		11.3	ns
t _{ENZL}	Enable Pad Z to LO\	W		6.6		7.6		8.6		10.1		14.1	ns
t _{ENHZ}	Enable Pad HIGH to	Z		11.1		12.8		14.5		17.1		23.9	ns
t _{ENLZ}	Enable Pad LOW to	Z		8.2		9.5		10.7		12.6		17.7	ns
d _{TLH}	Delta LOW to HIGH			0.03		0.03		0.04		0.04		0.06	ns/pF
d _{THL}	Delta HIGH to LOW			0.04		0.04		0.05		0.06		0.08	ns/pF



Table 37 • A40MX04 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C) (continued)

			peed	-2 Speed	-1 Speed	Std Speed	-F Speed	
Paramet	ter / Description	Min.	Max.	Min. Max.	Min. Max.	Min. Max.	Min. Max.	Units
CMOS C	Output Module Timing ⁴							
t _{DLH}	Data-to-Pad HIGH		5.5	6.4	7.2	8.5	11.9	ns
t _{DHL}	Data-to-Pad LOW		4.8	5.5	6.2	7.3	10.2	ns
t _{ENZH}	Enable Pad Z to HIGH		4.7	5.5	6.2	7.3	10.2	ns
t _{ENZL}	Enable Pad Z to LOW		6.8	7.9	8.9	10.5	14.7	ns
t _{ENHZ}	Enable Pad HIGH to Z		11.1	12.8	14.5	17.1	23.9	ns
t _{ENLZ}	Enable Pad LOW to Z		8.2	9.5	10.7	12.6	17.7	ns
d _{TLH}	Delta LOW to HIGH		0.05	0.05	0.06	0.07	0.10	ns/pF
d _{THL}	Delta HIGH to LOW		0.03	0.03	0.04	0.04	0.06	ns/pF

^{1.} Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

Table 38 • A42MX09 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

		-3 Sp	peed	-2 S _I	peed	-1 Sp	eed	Std S	Speed	−F S	peed	
Parame	ter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic M	odule Propagation Delays ¹											
t _{PD1}	Single Module		1.2		1.3		1.5		1.8		2.5	ns
t _{CO}	Sequential Clock-to-Q		1.3		1.4		1.6		1.9		2.7	ns
t _{GO}	Latch G-to-Q		1.2		1.4		1.6		1.8		2.6	ns
t _{RS}	Flip-Flop (Latch) Reset-to-Q		1.2		1.6		1.8		2.1		2.9	ns
Logic M	odule Predicted Routing Delays ²											
t _{RD1}	FO = 1 Routing Delay		0.7		8.0		0.9		1.0		1.4	ns
t _{RD2}	FO = 2 Routing Delay		0.9		1.0		1.2		1.4		1.9	ns
t _{RD3}	FO = 3 Routing Delay		1.2		1.3		1.5		1.7		2.4	ns
t _{RD4}	FO = 4 Routing Delay		1.4		1.5		1.7		2.0		2.9	ns
t _{RD8}	FO = 8 Routing Delay		2.3		2.6		2.9		3.4		4.8	ns
Logic M	odule Sequential Timing ^{3, 4}											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up	0.3		0.4		0.4		0.5		0.7		ns
t _{HD}	Flip-Flop (Latch) Data Input Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	0.4		0.5		0.5		0.6		8.0		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	3.4		3.8		4.3		5.0		7.0		ns

^{2.} Set-up times assume fanout of 3. Further testing information can be obtained from the Timer utility.

^{3.} The hold time for the DFME1A macro may be greater than 0 ns. Use the Timer tool from the Designer software to check the hold time for this macro.

^{4.} Delays based on 35 pF loading.



Table 38 • A42MX09 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		-3 Speed		-2 S _I	peed	-1 Sp	eed	Std S	Speed	-F S	peed	
Paramet	ter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	4.5		4.9		5.6		6.6		9.2		ns
t _A	Flip-Flop Clock Input Period	3.5		3.8		4.3		5.1		7.1		ns
t _{INH}	Input Buffer Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{INSU}	Input Buffer Latch Set-Up	0.3		0.3		0.4		0.4		0.6		ns
t _{OUTH}	Output Buffer Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{OUTSU}	Output Buffer Latch Set-Up	0.3		0.3		0.4		0.4		0.6		ns
f _{MAX}	Flip-Flop (Latch) Clock Frequenc	у	268		244		224		195		117	MHz



Table 38 • A42MX09 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

			-3 Sp	peed	-2 S	peed	-1 S _l	peed	Std S	Speed	−F S	peed	
Parame	eter / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Input M	odule Propagation Del	lays											
t _{INYH}	Pad-to-Y HIGH			1.0		1.2		1.3		1.6		2.2	ns
t _{INYL}	Pad-to-Y LOW			0.8		0.9		1.0		1.2		1.7	ns
t _{INGH}	G to Y HIGH			1.3		1.4		1.6		1.9		2.7	ns
t _{INGL}	G to Y LOW			1.3		1.4		1.6		1.9		2.7	ns
Input M	odule Predicted Routi	ng Delays ²											
t _{IRD1}	FO = 1 Routing Delay	,		2.0		2.2		2.5		3.0		4.2	ns
t _{IRD2}	FO = 2 Routing Delay	,		2.3		2.5		2.9		3.4		4.7	ns
t _{IRD3}	FO = 3 Routing Delay	,		2.5		2.8		3.2		3.7		5.2	ns
t _{IRD4}	FO = 4 Routing Delay	,		2.8		3.1		3.5		4.1		5.7	ns
t _{IRD8}	FO = 8 Routing Delay	,		3.7		4.1		4.7		5.5		7.7	ns
Global	Clock Network												
t _{CKH}	Input LOW to HIGH	FO = 32		2.4		2.7		3.0		3.6		5.0	ns
		FO = 256		2.7		3.0		3.4		4.0		5.5	ns
t _{CKL}	Input HIGH to LOW	FO = 32 FO = 256		3.5 3.9		3.9 4.3		4.4 4.9		5.2 5.7		7.3 8.0	ns ns
t _{PWH}	Minimum Pulse	FO = 32	1.2		1.4		1.5		1.8		2.5		ns
PVVII	Width HIGH	FO = 256	1.3		1.5		1.7		2.0		2.7		ns
t _{PWL}	Minimum Pulse	FO = 32	1.2		1.4		1.5		1.8		2.5		ns
	Width LOW	FO = 256	1.3		1.5		1.7		2.0		2.7		ns
t_{CKSW}	Maximum Skew	FO = 32 FO = 256		0.3 0.3		0.3		0.4 0.4		0.5 0.5		0.6 0.6	ns
	lancet Latab	FO = 32	0.0	0.3	0.0	0.3	0.0	0.4	0.0	0.5	0.0	0.0	ns
t _{SUEXT}	Input Latch External Set-Up	FO = 32 FO = 256	0.0		0.0		0.0		0.0		0.0		ns ns
t _{HEXT}	Input Latch	FO = 32	2.3		2.6		3.0		3.5		4.9		ns
	External Hold	FO = 256	2.2		2.4		3.3		3.9		5.5		ns
t _P	Minimum Period	FO = 32	3.4		3.7		4.0		4.7		7.8		ns
			3.7		4.1		4.5		5.2		8.6		ns
f _{MAX}	Maximum Frequency												MHz MHz
f _{MAX}	Maximum Frequency	FO = 32 FO = 256	3.7	296 268	4.1	269 244	4.5	247 224	5.2	215 195	8.6	129 117	



Table 38 • A42MX09 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		-3 Sp	eed	-2 S	peed	–1 Sp	peed	Std S	Speed	−F S	peed	
Parame	eter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
TTL Ou	tput Module Timing ⁵											
t _{DLH}	Data-to-Pad HIGH		2.5		2.7		3.1		3.6		5.1	ns
t _{DHL}	Data-to-Pad LOW		2.9		3.2		3.6		4.3		6.0	ns
t _{ENZH}	Enable Pad Z to HIGH		2.6		2.9		3.3		3.9		5.5	ns
t _{ENZL}	Enable Pad Z to LOW		2.9		3.2		3.7		4.3		6.1	ns
t _{ENHZ}	Enable Pad HIGH to Z		4.9		5.4		6.2		7.3		10.2	ns
t _{ENLZ}	Enable Pad LOW to Z		5.3		5.9		6.7		7.9		11.1	ns
t _{GLH}	G-to-Pad HIGH		2.6		2.9		3.3		3.8		5.3	ns
t _{GHL}	G-to-Pad LOW		2.6		2.9		3.3		3.8		5.3	ns
t _{LSU}	I/O Latch Set-Up	0.5		0.5		0.6		0.7		1.0		ns
t _{LH}	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading		5.2		5.8		6.6		7.7		10.8	ns
t _{ACO}	Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading		7.4		8.2		9.3		10.9		15.3	ns
d _{TLH}	Capacity Loading, LOW to HIGH		0.03		0.03		0.03		0.04		0.06	ns/pF
d _{THL}	Capacity Loading, HIGH to LOW		0.04		0.04		0.04		0.05		0.07	ns/pF



Table 38 • A42MX09 Timing Characteristics (Nominal 5.0 V Operation)
(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		-3 Sp	eed	-2 S	peed	-1 Sp	eed	Std S	Speed	−F S	peed	
Parame	ter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
CMOS	Output Module Timing ⁵											
t _{DLH}	Data-to-Pad HIGH		2.4		2.7		3.1		3.6		5.1	ns
t _{DHL}	Data-to-Pad LOW		2.9		3.2		3.6		4.3		6.0	ns
t _{ENZH}	Enable Pad Z to HIGH		2.7		2.9		3.3		3.9		5.5	ns
t _{ENZL}	Enable Pad Z to LOW		2.9		3.2		3.7		4.3		6.1	ns
t _{ENHZ}	Enable Pad HIGH to Z		4.9		5.4		6.2		7.3		10.2	ns
t _{ENLZ}	Enable Pad LOW to Z		5.3		5.9		6.7		7.9		11.1	ns
t _{GLH}	G-to-Pad HIGH		4.2		4.6		5.2		6.1		8.6	ns
t _{GHL}	G-to-Pad LOW		4.2		4.6		5.2		6.1		8.6	ns
t _{LSU}	I/O Latch Set-Up	0.5		0.5		0.6		0.7		1.0		ns
t _{LH}	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading		5.2		5.8		6.6		7.7		10.8	ns
t _{ACO}	Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading		7.4		8.2		9.3		10.9		15.3	ns
d _{TLH}	Capacity Loading, LOW to HIGH		0.03		0.03		0.03		0.04		0.06	ns/pF
d _{THL}	Capacity Loading, HIGH to LOW		0.04		0.04		0.04		0.05		0.07	ns/pF

- 1. For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn}, t_{CO} + t_{RD1} + t_{PDn}, or t_{PD1} + t_{RD1} + t_{SUD}, whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
- 3. Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
- 4. Set-up and hold timing parameters for the input buffer latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
- 5. Delays based on 35 pF loading

Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

		-3 Speed	-2 Speed	-1 Speed	Std Speed -	-F Speed	
Paramo	eter / Description	Min. Max.	Min. Max.	Min. Max.	Min. Max. M	Min. Max.	Units
Logic I	Module Propagation Delays ¹						
t _{PD1}	Single Module	1.6	1.8	2.1	2.5	3.5	ns
t _{CO}	Sequential Clock-to-Q	1.8	2.0	2.3	2.7	3.8	ns
t _{GO}	Latch G-to-Q	1.7	1.9	2.1	2.5	3.5	ns
t _{RS}	Flip-Flop (Latch) Reset-to-Q	2.0	2.2	2.5	2.9	4.1	ns
Logic I	Module Predicted Routing Delays ²						
t _{RD1}	FO = 1 Routing Delay	1.0	1.1	1.2	1.4	2.0	ns
t _{RD2}	FO = 2 Routing Delay	1.3	1.4	1.6	1.9	2.7	ns
t _{RD3}	FO = 3 Routing Delay	1.6	1.8	2.0	2.4	3.3	ns



Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

		-3 S	peed	-2 S _I	peed	-1 S	peed	Std S	Speed	−F S _I	peed	
Paramete	er / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{RD4}	FO = 4 Routing Delay		1.9		2.1		2.4		2.9		4.0	ns
t _{RD8}	FO = 8 Routing Delay		3.2		3.6		4.1		4.8		6.7	ns
Logic Mo	odule Sequential Timing ^{3, 4}											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up	0.5		0.5		0.6		0.7		0.9		ns
t _{HD}	Flip-Flop (Latch) Data Input Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	0.6		0.6		0.7		8.0		1.2		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	4.7		5.3		6.0		7.0		9.8		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	6.2		6.9		7.8		9.2		12.9		ns
t _A	Flip-Flop Clock Input Period	5.0		5.6		6.2		7.1		9.9		ns
t _{INH}	Input Buffer Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{INSU}	Input Buffer Latch Set-Up	0.3		0.3		0.3		0.4		0.6		ns
t _{OUTH}	Output Buffer Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
toutsu	Output Buffer Latch Set-Up	0.3		0.3		0.3		0.4		0.6		ns
f _{MAX}	Flip-Flop (Latch) Clock Frequency		161		146		135		117		70	MHz



Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

			−3 S	peed	-2 S _I	peed	-1 S	peed	Std S	Speed	−F Sp	peed	
Paramet	er / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Input Mo	dule Propagation Dela	ys											
t _{INYH}	Pad-to-Y HIGH			1.5		1.6		1.8		2.17		3.0	ns
t _{INYL}	Pad-to-Y LOW			1.2		1.3		1.4		1.7		2.4	ns
t _{INGH}	G to Y HIGH			1.8		2.0		2.3		2.7		3.7	ns
t _{INGL}	G to Y LOW			1.8		2.0		2.3		2.7		3.7	ns
Input Mo	dule Predicted Routing	g Delays ²											
t _{IRD1}	FO = 1 Routing Delay			2.8		3.2		3.6		4.2		5.9	ns
t _{IRD2}	FO = 2 Routing Delay			3.2		3.5		4.0		4.7		6.6	ns
t _{IRD3}	FO = 3 Routing Delay			3.5		3.9		4.4		5.2		7.3	ns
t _{IRD4}	FO = 4 Routing Delay			3.9		4.3		4.9		5.7		8.0	ns
t _{IRD8}	FO = 8 Routing Delay			5.2		5.8		6.6		7.7		10.8	ns
Global C	lock Network												
t _{CKH}	Input LOW to HIGH	FO = 32		4.1		4.5		5.1		6.0		8.4	ns
		FO = 256		4.5		5.0		5.6		6.7		9.3	ns
t_{CKL}	Input HIGH to LOW	FO = 32 FO = 256		5.0 5.4		5.5 6.0		6.2 6.8		7.3 8.0		10.2 11.2	ns
	Minimum Dulas Midde		4.7	3.4	4.0	0.0	0.4	0.0	0.5	0.0	0.5	11.2	ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 32 FO = 256	1.7 1.9		1.9 2.1		2.1 2.3		2.5 2.7		3.5 3.8		ns ns
t _{PWL}	Minimum Pulse Width	FO = 32	1.7		1.9		2.1		2.5		3.5		ns
. ***	LOW	FO = 256	1.9		2.1		2.3		2.7		3.8		ns
t _{CKSW}	Maximum Skew	FO = 32		0.4		0.5		0.5		0.6		0.9	ns
		FO = 256		0.4		0.5		0.5		0.6		0.9	ns
t _{SUEXT}	Input Latch External Set-Up	FO = 32 FO = 256	0.0		0.0		0.0		0.0		0.0		ns
	•												ns
t _{HEXT}	Input Latch External Hold	FO = 32 FO = 256	3.3 3.7		3.7 4.1		4.2 4.6		4.9 5.5		6.9 7.6		ns ns
t _P	Minimum Period	FO = 32	5.6		6.2		6.7		7.8		12.9		ns
Ψ	Willing III CHOU	FO = 256	6.1		6.8		7.4		8.5		14.2		ns
f _{MAX}	Maximum Frequency	FO = 32		177		161		148		129		77	MHz
1411 01	. ,	FO = 256		161		146		135		117		70	MHz



Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

		-3 S	peed	-2 S	peed	-1 S	peed	Std S	Speed	−F S _I	peed	
Paramet	er / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
TTL Out	put Module Timing ⁵											
t _{DLH}	Data-to-Pad HIGH		3.4		3.8		4.3		5.1		7.1	ns
t _{DHL}	Data-to-Pad LOW		4.0		4.5		5.1		6.1		8.3	ns
t _{ENZH}	Enable Pad Z to HIGH		3.7		4.1		4.6		5.5		7.6	ns
t _{ENZL}	Enable Pad Z to LOW		4.1		4.5		5.1		6.1		8.5	ns
t _{ENHZ}	Enable Pad HIGH to Z		6.9		7.6		8.6		10.2		14.2	ns
t _{ENLZ}	Enable Pad LOW to Z		7.5		8.3		9.4		11.1		15.5	ns
t _{GLH}	G-to-Pad HIGH		5.8		6.5		7.3		8.6		12.0	ns
t _{GHL}	G-to-Pad LOW		5.8		6.5		7.3		8.6		12.0	ns
t _{LSU}	I/O Latch Set-Up	0.7		8.0		0.9		1.0		1.4		ns
t _{LH}	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading		8.7		9.7		10.9		12.9		18.0	ns
t _{ACO}	Array Clock-to-Out (Pad-to-Pad),64 Clock Loading		12.2		13.5		15.4		18.1		25.3	ns
d _{TLH}	Capacity Loading, LOW to HIGH		0.00		0.00		0.00		0.10		0.01	ns/pF
d _{THL}	Capacity Loading, HIGH to LOW		0.09		0.10		0.10		0.10		0.10	ns/pF



Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

		−3 S	peed	–2 Sp	eed	–1 Sp	eed	Std S	peed	−F S _I	peed	
Parame	ter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
CMOS C	Output Module Timing ⁵											
t _{DLH}	Data-to-Pad HIGH		3.4		3.8		5.5		6.4		9.0	ns
t _{DHL}	Data-to-Pad LOW		4.1		4.5		4.2		5.0		7.0	ns
t _{ENZH}	Enable Pad Z to HIGH		3.7		4.1		4.6		5.5		7.6	ns
t _{ENZL}	Enable Pad Z to LOW		4.1		4.5		5.1		6.1		8.5	ns
t _{ENHZ}	Enable Pad HIGH to Z		6.9		7.6		8.6		10.2		14.2	ns
t _{ENLZ}	Enable Pad LOW to Z		7.5		8.3		9.4		11.1		15.5	ns
t _{GLH}	G-to-Pad HIGH		5.8		6.5		7.3		8.6		12.0	ns
t _{GHL}	G-to-Pad LOW		5.8		6.5		7.3		8.6		12.0	ns
t _{LSU}	I/O Latch Set-Up	0.7		0.8		0.9		1.0		1.4		ns
t _{LH}	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading		8.7		9.7		10.9		12.9		18.0	ns
t _{ACO}	Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading		12.2		13.5		15.4		18.1		25.3	ns
d _{TLH}	Capacity Loading, LOW to HIGH		0.04		0.04		0.05		0.06		0.08	ns/pF
d _{THL}	Capacity Loading, HIGH to LOW		0.05		0.05		0.06		0.07		0.10	ns/pF

^{1.} For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn} , t_{CO} + t_{RD1} + t_{PDn} , or t_{PD1} + t_{RD1} + t_{SUD} , whichever is appropriate.

Table 40 • A42MX16 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

		-3 Speed	l –2 Speed	-1 Speed	Std Speed	-F Speed	
Parame	eter / Description	Min. Ma	x. Min. Max.	Min. Max.	Min. Max.	Min. Max.	Units
Logic I	Module Propagation Delays ¹						
t _{PD1}	Single Module	1.	1.5	1.7	2.0	2.8	ns
t _{CO}	Sequential Clock-to-Q	1.	1.6	1.8	2.1	3.0	ns
t _{GO}	Latch G-to-Q	1	4 1.5	1.7	2.0	2.8	ns
t _{RS}	Flip-Flop (Latch) Reset-to-Q	1.	6 1.7	2.0	2.3	3.3	ns
Logic I	Module Predicted Routing Delays	s ²					
t _{RD1}	FO = 1 Routing Delay	0.	3 0.9	1.0	1.2	1.6	ns
t _{RD2}	FO = 2 Routing Delay	1.) 1.2	1.3	1.5	2.1	ns

^{2.} Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

^{3.} Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.

^{4.} Set-up and hold timing parameters for the input buffer latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.

^{5.} Delays based on 35 pF loading.



Table 40 • A42MX16 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

			−3 S	peed	-2 S	peed	–1 S _l	peed	Std S	peed	−F Sp	peed	
Parame	ter / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{RD3}	FO = 3 Routing Delay	/		1.3		1.4		1.6		1.9		2.7	ns
t _{RD4}	FO = 4 Routing Delay	/		1.6		1.7		2.0		2.3		3.2	ns
t _{RD8}	FO = 8 Routing Delay	/		2.6		2.9		3.2		3.8		5.3	ns
Logic M	odule Sequential Tim	ing ^{3,4}											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up		0.3		0.4		0.4		0.5		0.7		ns
t _{HD}	Flip-Flop (Latch) Data	a Input Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{SUENA}	Flip-Flop (Latch) Ena	ble Set-Up	0.7		0.8		0.9		1.0		1.4		ns
t _{HENA}	Flip-Flop (Latch) Ena	ble Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse W	idth	3.4		3.8		4.3		5.0		7.1		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse	Width	4.5		5.0		5.6		6.6		9.2		ns
t _A	Flip-Flop Clock Input	Period	6.8		7.6		8.6		10.1		14.1		ns
t _{INH}	Input Buffer Latch Ho	ld	0.0		0.0		0.0		0.0		0.0		ns
t _{INSU}	Input Buffer Latch Se	t-Up	0.5		0.5		0.6		0.7		1.0		ns
t _{OUTH}	Output Buffer Latch F	lold	0.0		0.0		0.0		0.0		0.0		ns
t _{OUTSU}	Output Buffer Latch S	Set-Up	0.5		0.5		0.6		0.7		1.0		ns
f _{MAX}	Flip-Flop (Latch) Cloc Frequency	k		215		195		179		156		94	MHz
Input Mo	odule Propagation De	lays											
t _{INYH}	Pad-to-Y HIGH			1.1		1.2		1.3		1.6		2.2	ns
t _{INYL}	Pad-to-Y LOW			0.8		0.9		1.0		1.2		1.7	ns
t _{INGH}	G to Y HIGH			1.4		1.6		1.8		2.1		2.9	ns
t _{INGL}	G to Y LOW			1.4		1.6		1.8		2.1		2.9	ns
Input Mo	odule Predicted Routi	ng Delays ²											
t _{IRD1}	FO = 1 Routing Delay	/		1.8		2.0		2.3		2.7		4.0	ns
t _{IRD2}	FO = 2 Routing Delay	/		2.1		2.3		2.6		3.1		4.3	ns
t _{IRD3}	FO = 3 Routing Delay	/		2.3		2.6		3.0		3.5		4.9	ns
t _{IRD4}	FO = 4 Routing Delay	/		2.6		3.0		3.3		3.9		5.4	ns
t _{IRD8}	FO = 8 Routing Delay	/		3.6		4.0		4.6		5.4		7.5	ns
Global (Clock Network												
t _{CKH}	Input LOW to HIGH	FO = 32 FO = 384		2.6 2.9		2.9 3.2		3.3 3.6		3.9 4.3		5.4 6.0	ns ns
t _{CKL}	Input HIGH to LOW	FO = 32 FO = 384		3.8 4.5		4.2 5.0		4.8 5.6		5.6 6.6		7.8 9.2	ns ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 32 FO = 384	3.2 3.7		3.5 4.1		4.0 4.6		4.7 5.4		6.6 7.6		ns ns



Table 40 • A42MX16 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

			-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		
Parameter / Description			Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{PWL}	Minimum Pulse Width LOW	FO = 32 FO = 384	3.2 3.7		3.5 4.1		4.0 4.6		4.7 5.4		6.6 7.6		ns ns
t _{CKSW}	Maximum Skew	FO = 32 FO = 384		0.3 0.3		0.4 0.4		0.4 0.4		0.5 0.5		0.7 0.7	ns ns
t _{SUEXT}	Input Latch External Set-Up	FO = 32 FO = 384	0.0		0.0		0.0		0.0		0.0		ns ns
t _{HEXT}	Input Latch External Hold	FO = 32 FO = 384	2.8 3.2		3.1 3.5		5.5 4.0		4.1 4.7		5.7 6.6		ns ns
t _P	Minimum Period	FO = 32 FO = 384	4.2 4.6		4.67 5.1		5.1 5.6		5.8 6.4		9.7 10.7		ns ns
f _{MAX}	Maximum Frequency	FO = 32 FO = 384		237 215		215 195		198 179		172 156		103 94	MHz MHz



Table 40 • A42MX16 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		-3 Speed	-2 Speed	-1 Speed	Std Speed	-F Speed	
Parame	ter / Description	Min. Max.	Units				
TTL Out	tput Module Timing ⁴						
t _{DLH}	Data-to-Pad HIGH	2.5	2.8	3.2	3.7	5.2	ns
t _{DHL}	Data-to-Pad LOW	3.0	3.3	3.7	4.4	6.1	ns
t _{ENZH}	Enable Pad Z to HIGH	2.7	3.0	3.4	4.0	5.6	ns
t _{ENZL}	Enable Pad Z to LOW	3.0	3.3	3.8	4.4	6.2	ns
t _{ENHZ}	Enable Pad HIGH to Z	5.4	6.0	6.8	8.0	11.2	ns
t _{ENLZ}	Enable Pad LOW to Z	5.0	5.6	6.3	7.4	10.4	ns
t _{GLH}	G-to-Pad HIGH	2.9	3.2	3.6	4.3	6.0	ns
t _{GHL}	G-to-Pad LOW	2.9	3.2	3.6	4.3	6.0	ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading	5.7	6.3	7.1	8.4	11.9	ns
t _{ACO}	Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading	8.0	8.9	10.1	11.9	16.7	ns
d _{TLH}	Capacitive Loading, LOW to HIGH	0.03	0.03	0.03	0.04	0.06	ns/pF
d _{THL}	Capacitive Loading, HIGH to LOW	0.04	0.04	0.04	0.05	0.07	ns/pF



Table 40 • A42MX16 Timing Characteristics (Nominal 5.0 V Operation)
(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		-3 Speed	-2 Speed	-1 Speed	Std Speed	-F Speed	
Parame	eter / Description	Min. Max.	Units				
CMOS	Output Module Timing ⁵						
t _{DLH}	Data-to-Pad HIGH	3.2	3.6	4.0	4.7	6.6	ns
t _{DHL}	Data-to-Pad LOW	2.5	2.7	3.1	3.6	5.1	ns
t _{ENZH}	Enable Pad Z to HIGH	2.7	3.0	3.4	4.0	5.6	ns
t _{ENZL}	Enable Pad Z to LOW	3.0	3.3	3.8	4.4	6.2	ns
t _{ENHZ}	Enable Pad HIGH to Z	5.4	6.0	6.8	8.0	11.2	ns
t _{ENLZ}	Enable Pad LOW to Z	5.0	5.6	6.3	7.4	10.4	ns
t _{GLH}	G-to-Pad HIGH	5.1	5.6	6.4	7.5	10.5	ns
t _{GHL}	G-to-Pad LOW	5.1	5.6	6.4	7.5	10.5	ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading	5.7	6.3	7.1	8.4	11.9	ns
t _{ACO}	Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading	8.0	8.9	10.1	11.9	16.7	ns
d _{TLH}	Capacitive Loading, LOW to HIGH	0.03	0.03	0.03	0.04	0.06	ns/pF

^{1.} For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn}, t_{CO} + t_{RD1} + t_{PDn}, or t_{PD1} + t_{RD1} + t_{SUD}, point and position whichever is appropriate.

Table 41 • A42MX16 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

		−3 Sp	eed	–2 Sp	eed	-1 S	peed	Std S	Speed	−F Sp	oeed	
Parame	ter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic M	lodule Propagation Delays ¹											
t _{PD1}	Single Module		1.9		2.1		2.4		2.8		4.0	ns
t _{CO}	Sequential Clock-to-Q		2.0		2.2		2.5		3.0		4.2	ns
t _{GO}	Latch G-to-Q		1.9		2.1		2.4		2.8		4.0	ns
t _{RS}	Flip-Flop (Latch) Reset-to-Q		2.2		2.4		2.8		3.3		4.6	ns
Logic M	lodule Predicted Routing Delays	2										
t _{RD1}	FO = 1 Routing Delay		1.1		1.2		1.4		1.6		2.3	ns
t _{RD2}	FO = 2 Routing Delay		1.5		1.6		1.8		2.1		3.0	ns
t _{RD3}	FO = 3 Routing Delay		1.8		2.0		2.3		2.7		3.8	ns
t _{RD4}	FO = 4 Routing Delay		2.2		2.4		2.7		3.2		4.5	ns
t _{RD8}	FO = 8 Routing Delay		3.6		4.0		4.5		5.3		7.5	ns

^{2.} Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

^{3.} Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.

^{4.} Set-up and hold timing parameters for the input buffer latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.

^{5.} Delays based on 35 pF loading



Table 41 • A42MX16 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

			-3 S _I	peed	–2 Sp	eed	-1 S _I	peed	Std S	Speed	−F Sp	peed	
Paramet	er / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic Mo	odule Sequential Timir	ոց ^{3, 4}											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up		0.5		0.5		0.6		0.7		0.9		ns
t _{HD}	Flip-Flop (Latch) Data	Input Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{SUENA}	Flip-Flop (Latch) Enal	ble Set-Up	1.0		1.1		1.2		1.4		2.0		ns
t _{HENA}	Flip-Flop (Latch) Enal	ble Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse W	idth	4.8		5.3		6.0		7.1		9.9		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse	Width	6.2		6.9		7.9		9.2		12.9		ns
t _A	Flip-Flop Clock Input	Period	9.5		10.6		12.0		14.1		19.8		ns
t _{INH}	Input Buffer Latch Ho	ld	0.0		0.0		0.0		0.0		0.0		ns
t _{INSU}	Input Buffer Latch Set	t-Up	0.7		8.0		0.9		1.01		1.4		ns
t _{OUTH}	Output Buffer Latch H	lold	0.0		0.0		0.0		0.0		0.0		ns
t _{OUTSU}	Output Buffer Latch S	et-Up	0.7		8.0		0.89		1.01		1.4		ns
f _{MAX}	Flip-Flop (Latch) Cloc Frequency	k		129		117		108		94		56	MHz
Input Mo	dule Propagation Dela	ays											
t _{INYH}	Pad-to-Y HIGH			1.5		1.6		1.9		2.2		3.1	ns
t _{INYL}	Pad-to-Y LOW			1.1		1.3		1.4		1.7		2.4	ns
t _{INGH}	G to Y HIGH			2.0		2.2		2.5		2.9		4.1	ns
t _{INGL}	G to Y LOW			2.0		2.2		2.5		2.9		4.1	ns
Input Mo	dule Predicted Routin	g Delays ²											
t _{IRD1}	FO = 1 Routing Delay			2.6		2.9		3.2		3.8		5.3	ns
t _{IRD2}	FO = 2 Routing Delay			2.9		3.2		3.7		4.3		6.1	ns
t _{IRD3}	FO = 3 Routing Delay			3.3		3.6		4.1		4.9		6.8	ns
t _{IRD4}	FO = 4 Routing Delay			3.6		4.0		4.6		5.4		7.6	ns
t _{IRD8}	FO = 8 Routing Delay			5.1		5.6		6.4		7.5		10.5	ns
Global C	lock Network												
t _{CKH}	•	FO = 32 FO = 384		4.4 4.8		4.8 5.3		5.5 6.0		6.5 7.1		9.0 9.9	ns ns
t _{CKL}	•	FO = 32 FO = 384		5.3 6.2		5.9 6.9		6.7 7.9		7.8 9.2		11.0 12.9	ns ns
t _{PWH}		FO = 32 FO = 384	5.7 6.6		6.3 7.4		7.1 8.3		8.4 9.8		11.8 13.7		ns ns



Table 41 • A42MX16 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

			-3 S	peed	–2 Sp	eed	-1 S	peed	Std S	Speed	−F Sp	eed	
Paramet	er / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{PWL}	Minimum Pulse Width LOW	FO = 32 FO = 384	5.3 6.2		5.9 6.9		6.7 7.9		7.8 9.2		11.0 12.9		ns ns
t _{CKSW}	Maximum Skew	FO = 32 FO = 384		0.5 2.2		0.5 2.4		0.6 2.7		0.7 3.2		1.0 4.5	ns ns
t _{SUEXT}	Input Latch External Set-Up	FO = 32 FO = 384	0.0		0.0		0.0		0.0		0.0 0.0		ns ns
t _{HEXT}	Input Latch External Hold	FO = 32 FO = 384	3.9 4.5		4.3 4.9		4.9 5.6		5.7 6.6		8.0 9.2		ns ns
t _P	Minimum Period	FO = 32 FO = 384	7.0 7.7		7.8 8.6		8.4 9.3		9.7 10.7		16.2 17.8		ns ns
f _{MAX}	Maximum Frequency	FO = 32 FO = 384		142 129		129 117		119 108		103 94		62 56	MHz MHz
TTL Out	put Module Timing ⁵												
t _{DLH}	Data-to-Pad HIGH			3.5		3.9		4.4		5.2		7.3	ns
t _{DHL}	Data-to-Pad LOW			4.1		4.6		5.2		6.1		8.6	ns
t _{ENZH}	Enable Pad Z to HIG	Н		3.8		4.2		4.8		5.6		7.8	ns
t _{ENZL}	Enable Pad Z to LOV	٧		4.2		4.6		5.3		6.2		8.7	ns
t _{ENHZ}	Enable Pad HIGH to	Z		7.6		8.4		9.5		11.2		15.7	ns
t _{ENLZ}	Enable Pad LOW to	Z		7.0		7.8		8.8		10.4		14.5	ns
t _{GLH}	G-to-Pad HIGH			4.8		5.3		6.0		7.2		10.0	ns
t _{GHL}	G-to-Pad LOW			4.8		5.3		6.0		7.2		10.0	ns
t _{LCO}	I/O Latch Clock-to-O (Pad-to-Pad), 64 Clo			8.0		8.9		10.1		11.9		16.7	ns
t _{ACO}	Array Clock-to-Out (Pad-to-Pad), 64 Clo	ck Loading		11.3		12.5		14.2		16.7		23.3	ns
d _{TLH}	Capacitive Loading, HIGH	LOW to		0.04		0.04		0.05		0.06		0.08	ns/pF
d _{THL}	Capacitive Loading, LOW	HIGH to		0.05		0.05		0.06		0.07		0.10	ns/pF
CMOS C	output Module Timing ⁵	5											
t _{DLH}	Data-to-Pad HIGH			4.5		5.0		5.6		6.6		9.3	ns
t _{DHL}	Data-to-Pad LOW			3.4		3.8		4.3		5.1		7.1	ns
t _{ENZH}	Enable Pad Z to HIG	Н		3.8		4.2		4.8		5.6		7.8	ns
t _{ENZL}	Enable Pad Z to LOV	V		4.2		4.6		5.3		6.2		8.7	ns
t _{ENHZ}	Enable Pad HIGH to	Z		7.6		8.4		9.5		11.2		15.7	ns
t _{ENLZ}	Enable Pad LOW to	Z		7.0		7.8		8.8		10.4		14.5	ns
t _{GLH}	G-to-Pad HIGH			7.1		7.9		8.9		10.5		14.7	ns
t _{GHL}	G-to-Pad LOW			7.1		7.9		8.9		10.5		14.7	ns
t _{LCO}	I/O Latch Clock-to-O (Pad-to-Pad), 64 Clo			8.0		8.9		10.1		11.9		16.7	ns



Table 41 • A42MX16 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

		-3 Speed		-2 Sp	peed	-1 S	peed	Std S	Speed	−F Sp	peed	
Parame	Parameter / Description		Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{ACO}	Array Clock-to-Out (Pad-to-Pad),64 Clock Loading		11.3		12.5		14.2		16.7		23.3	ns
d _{TLH}	Capacitive Loading, LOW to HIGH		0.04		0.04		0.05		0.06		0.08	ns/pF
d _{THL}	Capacitive Loading, HIGH to LOW		0.05		0.05		0.06		0.07		0.10	ns/pF

- 1. For dual-module macros use tPD1 + tRD1 + taped, to + tRD1 + taped, or tPD1 + tRD1 + tusk, whichever is appropriate.
- 2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing ansalysis or simulation is required to determine actual performance.
- 3. Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
- 4. Set-up and hold timing parameters for the input buffer latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
- 5. Delays based on 35 pF loading.

Table 42 • A42MX24 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

		-3 S	peed	-2 Sp	eed	-1 S _I	peed	Std S	Speed	−F S	peed	
Paramete	er / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic Mo	odule Combinatorial Functions ¹											
t _{PD}	Internal Array Module Delay		1.2		1.3		1.5		1.8		2.5	ns
t _{PDD}	Internal Decode Module Delay		1.4		1.6		1.8		2.1		3.0	ns
Logic Mo	odule Predicted Routing Delays ²											
t _{RD1}	FO = 1 Routing Delay		0.8		0.9		1.0		1.2		1.7	ns
t _{RD2}	FO = 2 Routing Delay		1.0		1.2		1.3		1.5		2.1	ns
t _{RD3}	FO = 3 Routing Delay		1.3		1.4		1.6		1.9		2.6	ns
t _{RD4}	FO = 4 Routing Delay		1.5		1.7		1.9		2.2		3.1	ns
t _{RD5}	FO = 8 Routing Delay		2.4		2.7		3.0		3.6		5.0	ns
Logic Mo	odule Sequential Timing ^{3, 4}											
t _{CO}	Flip-Flop Clock-to-Output		1.3		1.4		1.6		1.9		2.7	ns
t _{GO}	Latch Gate-to-Output		1.2		1.3		1.5		1.8		2.5	ns
t _{SUD}	Flip-Flop (Latch) Set-Up Time	0.3		0.4		0.4		0.5		0.7		ns
t _{HD}	Flip-Flop (Latch) Hold Time	0.0		0.0		0.0		0.0		0.0		ns
t _{RO}	Flip-Flop (Latch) Reset-to-Output		1.4		1.6		1.8		2.1		2.9	ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	0.4		0.5		0.5		0.6		0.8		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	3.3		3.7		4.2		4.9		6.9		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	4.4		4.8		5.3		6.5		9.0		ns



Table 42 • A42MX24 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		−3 S	peed	-2 S _I	peed	-1 S	peed	Std S	peed	−F S	peed	
Parame	Parameter / Description		Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Input M	odule Propagation Delays											
t _{INPY}	Input Data Pad-to-Y		1.0		1.1		1.3		1.5		2.1	ns
t _{INGO}	Input Latch Gate-to-Output		1.3		1.4		1.6		1.9		2.6	ns
t _{INH}	Input Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{INSU}	Input Latch Set-Up	0.5		0.5		0.6		0.7		1.0		ns
t _{ILA}	Latch Active Pulse Width	4.7		5.2		5.9		6.9		9.7		ns



Table 42 • A42MX24 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		•	−3 S	peed	-2 S _I	oeed	-1 S _I	peed	Std S	peed	−F S	peed	
Paramet	er / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Input Mo	dule Predicted Routing	Delays ²											
t _{IRD1}	FO = 1 Routing Delay			1.8		2.0		2.3		2.7		3.8	ns
t _{IRD2}	FO = 2 Routing Delay			2.1		2.3		2.6		3.1		4.3	ns
t _{IRD3}	FO = 3 Routing Delay			2.3		2.5		2.9		3.4		4.8	ns
t _{IRD4}	FO = 4 Routing Delay			2.5		2.8		3.2		3.7		5.2	ns
t _{IRD8}	FO = 8 Routing Delay			3.4		3.8		4.3		5.1		7.1	ns
Global C	lock Network												
t _{CKH}	Input LOW to HIGH	FO = 32 FO = 486		2.6 2.9		2.9 3.2		3.3 3.6		3.9 4.3		5.4 5.9	ns ns
t _{CKL}	Input HIGH to LOW	FO = 32 FO = 486		3.7 4.3		4.1 4.7		4.6 5.4		5.4 6.3		7.6 8.8	ns ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 32 FO = 486	2.2 2.4		2.4 2.6		2.7 3.0		3.2 3.5		4.5 4.9		ns ns
t _{PWL}	Minimum Pulse Width LOW	FO = 32 FO = 486	2.2 2.4		2.4 2.6		2.7 3.0		3.2 3.5		4.5 4.9		ns ns
t _{CKSW}	Maximum Skew	FO = 32 FO = 486		0.5 0.5		0.6 0.6		0.7 0.7		0.8 0.8		1.1 1.1	ns ns
t _{SUEXT}	Input Latch External Set-Up	FO = 32 FO = 486	0.0		0.0		0.0		0.0		0.0 0.0		ns ns
t _{HEXT}	Input Latch External Hold	FO = 32 FO = 486	2.8 3.3		3.1 3.7		3.5 4.2		4.1 4.9		5.7 6.9		ns ns
t _P	Minimum Period (1/f _{MAX})	FO = 32 FO = 486	4.7 5.1		5.2 5.7		5.7 6.2		6.5 7.1		10.9 11.9		ns ns



Table 42 • A42MX24 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		-3 S	peed	-2 S _I	peed	-1 S	peed	Std S	peed	−F S	peed	
Paramet	er / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
TTL Out	put Module Timing ⁵											
t _{DLH}	Data-to-Pad HIGH		2.4		2.7		3.1		3.6		5.1	ns
t _{DHL}	Data-to-Pad LOW		2.8		3.2		3.6		4.2		5.9	ns
t _{ENZH}	Enable Pad Z to HIGH		2.5		2.8		3.2		3.8		5.3	ns
t _{ENZL}	Enable Pad Z to LOW		2.8		3.1		3.5		4.2		5.9	ns
t _{ENHZ}	Enable Pad HIGH to Z		5.2		5.7		6.5		7.6		10.7	ns
t _{ENLZ}	Enable Pad LOW to Z		4.8		5.3		6.0		7.1		9.9	ns
t _{GLH}	G-to-Pad HIGH		2.9		3.2		3.6		4.3		6.0	ns
t _{GHL}	G-to-Pad LOW		2.9		3.2		3.6		4.3		6.0	ns
t _{LSU}	I/O Latch Output Set-Up	0.5		0.5		0.6		0.7		1.0		ns
t _{LH}	I/O Latch Output Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		5.6		6.1		6.9		8.1		11.4	ns
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		10.6		11.8		13.4		15.7		22.0	ns
d _{TLH}	Capacitive Loading, LOW to HIGH		0.04		0.04		0.04		0.05		0.07	ns/pF
d _{THL}	Capacitive Loading, HIGH to LOW		0.03		0.03		0.03		0.04		0.06	ns/pF



Table 42 • A42MX24 Timing Characteristics (Nominal 5.0 V Operation)
(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		-3 S	peed	-2 Sp	eed	-1 S _l	peed	Std S	peed	−F S _I	peed	
Paramet	er / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
CMOS O	utput Module Timing ⁵											
t _{DLH}	Data-to-Pad HIGH		3.1		3.5		3.9		4.6		6.4	ns
t _{DHL}	Data-to-Pad LOW		2.4		2.6		3.0		3.5		4.9	ns
t _{ENZH}	Enable Pad Z to HIGH		2.5		2.8		3.2		3.8		5.3	ns
t _{ENZL}	Enable Pad Z to LOW		2.8		3.1		3.5		4.2		5.8	ns
t _{ENHZ}	Enable Pad HIGH to Z		5.2		5.7		6.5		7.6		10.7	ns
t _{ENLZ}	Enable Pad LOW to Z		4.8		5.3		6.0		7.1		9.9	ns
t _{GLH}	G-to-Pad HIGH		4.9		5.4		6.2		7.2		10.1	ns
t _{GHL}	G-to-Pad LOW		4.9		5.4		6.2		7.2		10.1	ns
t _{LSU}	I/O Latch Set-Up	0.5		0.5		0.6		0.7		1.0		ns
t _{LH}	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		5.5		6.1		6.9		8.1		11.3	ns
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		10.6		11.8		13.4		15.7		22.0	ns
d _{TLH}	Capacitive Loading, LOW to HIGH		0.04		0.04		0.04		0.05		0.07	ns/pF
d _{THL}	Capacitive Loading, HIGH to LOW		0.03		0.03		0.03		0.04		0.06	ns/pF

- 1. For dual-module macros, use $t_{PD1} + t_{RD1} + t_{PDn}$, $t_{CO} + t_{RD1} + t_{PDn}$, or $t_{PD1} + t_{RD1} + t_{SUD}$, whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
- 3. Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
- 4. Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
- 5. Delays based on 35 pF loading

Table 43 • A42MX24 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

			-2 Sp	eed	-1 S _l	peed	Std S	peed	−F S _I	peed		
Parame	eter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic N	Module Combinatorial Functions ¹											
t _{PD}	Internal Array Module Delay		2.0		1.8		2.1		2.5		3.4	ns
t _{PDD}	Internal Decode Module Delay		1.1		2.2		2.5		3.0		4.2	ns
Logic N	Module Predicted Routing Delays ²											
t _{RD1}	FO = 1 Routing Delay		1.7		1.3		1.4		1.7		2.3	ns
t _{RD2}	FO = 2 Routing Delay		2.0		1.6		1.8		2.1		3.0	ns
t _{RD3}	FO = 3 Routing Delay		1.1		2.0		2.2		2.6		3.7	ns
t _{RD4}	FO = 4 Routing Delay		1.5		2.3		2.6		3.1		4.3	ns
t _{RD5}	FO = 8 Routing Delay		1.8		3.7		4.2		5.0		7.0	ns



Table 43 • A42MX24 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

		-3 S∣	peed	-2 Sp	peed	-1 S	peed	Std S	peed	−F S	peed	
Paramete	r / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic Mod	dule Sequential Timing ^{3, 4}											
t _{CO}	Flip-Flop Clock-to-Output		2.1		2.0		2.3		2.7		3.7	ns
t _{GO}	Latch Gate-to-Output		3.4		1.9		2.1		2.5		3.4	ns
t _{SUD}	Flip-Flop (Latch) Set-Up Time	0.4		0.5		0.6		0.7		0.9		ns
t _{HD}	Flip-Flop (Latch) Hold Time	0.0		0.0		0.0		0.0		0.0		ns
t _{RO}	Flip-Flop (Latch) Reset-to-Output		2.0		2.2		2.5		2.9		4.1	ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	0.6		0.6		0.7		8.0		1.2		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	4.6		5.2		5.8		6.9		9.6		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	6.1		6.8		7.7		9.0		12.6		ns
Input Mod	lule Propagation Delays											
t _{INPY}	Input Data Pad-to-Y		1.4		1.6		1.8		2.2		3.0	ns
t _{INGO}	Input Latch Gate-to-Output		1.8		1.9		2.2		2.6		3.6	ns
t _{INH}	Input Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{INSU}	Input Latch Set-Up	0.7		0.7		8.0		1.0		1.4		ns
t_{ILA}	Latch Active Pulse Width	6.5		7.3		8.2		9.7		13.5		ns



Table 43 • A42MX24 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

		−3 S	peed	-2 S _I	oeed	-1 S	peed	Std S	peed	−F S _l	peed	
er / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
dule Predicted Routing	Delays ²											
FO = 1 Routing Delay			2.6		2.9		3.2		3.8		5.3	ns
FO = 2 Routing Delay			2.9		3.2		3.6		4.3		6.0	ns
FO = 3 Routing Delay			3.2		3.6		4.0		4.8		6.6	ns
FO = 4 Routing Delay			3.5		3.9		4.4		5.2		7.3	ns
FO = 8 Routing Delay			4.8		5.3		6.1		7.1		10.0	ns
lock Network												
Input LOW to HIGH	FO = 32 FO = 486		4.4 4.8		4.8 5.3		5.5 6.0		6.5 7.1		9.1 10.0	ns ns
Input HIGH to LOW	FO = 32 FO = 486		5.1 6.0		5.7 6.6		6.4 7.5		7.6 8.8			
Minimum Pulse Width HIGH	FO = 32 FO = 486	3.0 3.3		3.3 3.7		3.8 4.2		4.5 4.9		6.3 6.9		ns ns
Minimum Pulse Width LOW	FO = 32 FO = 486	3.0 3.3		3.4 3.7		3.8 4.2		4.5 4.9		6.3 6.9		ns ns
Maximum Skew	FO = 32 FO = 486		0.8 0.8		0.8 0.8		1.0 1.0		1.1 1.1		1.6 1.6	ns ns
Input Latch External Set-Up	FO = 32 FO = 486	0.0		0.0		0.0		0.0		0.0		ns ns
out Module Timing ⁵												
Data-to-Pad HIGH			3.4		3.8		4.3		5.0		7.1	ns
Data-to-Pad LOW			4.0		4.4		5.0		5.9		8.3	ns
Enable Pad Z to HIGH			3.6		4.0		4.5		5.3		7.4	ns
Enable Pad Z to LOW			3.9		4.4		5.0		5.8		8.2	ns
Enable Pad HIGH to Z			7.2		8.0		9.1		10.7		14.9	ns
Enable Pad LOW to Z			6.7		7.5		8.5		9.9		13.9	ns
G-to-Pad HIGH			4.8		5.3		6.0		7.2		10.0	ns
G-to-Pad LOW			4.8		5.3		6.0		7.2		10.0	ns
I/O Latch Output Set-U	lp	0.7		0.7		0.8		1.0		1.4		ns
	dule Predicted Routing FO = 1 Routing Delay FO = 2 Routing Delay FO = 3 Routing Delay FO = 4 Routing Delay FO = 8 Routing Delay Input LOW to HIGH Input HIGH to LOW Minimum Pulse Width HIGH Minimum Pulse Width LOW Maximum Skew Input Latch External Set-Up Dut Module Timing ⁵ Data-to-Pad HIGH Data-to-Pad LOW Enable Pad Z to HIGH Enable Pad IOW to Z G-to-Pad HIGH G-to-Pad LOW	FO = 1 Routing Delay FO = 2 Routing Delay FO = 3 Routing Delay FO = 4 Routing Delay FO = 8 Routing Delay FO = 486 Input LOW to HIGH FO = 32 FO = 486 Input HIGH to LOW FO = 32 Width HIGH FO = 32 Width HIGH FO = 486 Minimum Pulse Width LOW FO = 32 FO = 486 Input Latch External Set-Up FO = 32 FO = 486 Input Latch External Set-Up FO = 486 Input Latch External FO = 32 FO = 486 Input Latch External FO = 32 FO = 486 Input Latch External FO = 32 FO = 486 Input Latch External FO = 32 FO = 486 Input Latch External Set-Up FO = 486 Input Latch External FO = 32 FO = 486 Input Latch E	FO = 1 Routing Delay FO = 2 Routing Delay FO = 3 Routing Delay FO = 4 Routing Delay FO = 8 Routing Delay FO = 8 Routing Delay FO = 486 Input LOW to HIGH Input HIGH to LOW Minimum Pulse Width HIGH FO = 32 FO = 486 Minimum Pulse Width LOW FO = 32 SO Width LOW FO = 32 FO = 486 Input Latch External Set-Up FO = 32 FO = 486 Input Module Timing ⁵ Data-to-Pad HIGH Enable Pad Z to LOW Enable Pad LOW to Z G-to-Pad HIGH G-to-Pad LOW G-to-Pad LOW	## Company of Control	Min. Max. Min. Min. Max. Min. Min. Max. Min. Min. Max. Min. Min.	Min. Max. Min. Max. Min. Min.	Min. Max. Min. Max. Min. Max. Min. Min. Max. Min. Min.	Min. Max. Min. Min. Max. Min. Min.	Min. Max. Min. Max.	Min. Max. Min. Min. Max. Min. Max. Min. Min.	Min. Max. Min. Min. Max. Min. Min.	Min. Max. Min. Min.



Table 43 • A42MX24 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

			−3 S	peed	-2 S _I	peed	-1 S	peed	Std S	peed	−F S	peed	
Parame	ter / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
TTL Out	put Module Timing ⁵												
t _{LH}	I/O Latch Output Hold		0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O			7.7		8.5		9.6		11.3		15.9	ns
t _{ACO}	Array Latch Clock-to-Ou (Pad-to-Pad) 32 I/O	it		14.8		16.5		18.7		22.0		30.8	ns
d _{TLH}	Capacitive Loading, LO	W to HIGH		0.05		0.05		0.06		0.07		0.10	ns/pF
d _{THL}	Capacitive Loading, HIC	H to LOW		0.04		0.04		0.05		0.06		0.08	ns/pF
CMOS	Output Module Timing ⁵												
t _{DLH}	Data-to-Pad HIGH			4.8		5.3		5.5		6.4		9.0	ns
t _{DHL}	Data-to-Pad LOW			3.5		3.9		4.1		4.9		6.8	ns
t _{ENZH}	Enable Pad Z to HIGH			3.6		4.0		4.5		5.3		7.4	ns
t _{ENZL}	Enable Pad Z to LOW			3.4		4.0		5.0		5.8		8.2	ns
t _{ENHZ}	Enable Pad HIGH to Z			7.2		8.0		9.0		10.7		14.9	ns
t _{ENLZ}	Enable Pad LOW to Z			6.7		7.5		8.5		9.9		13.9	ns
t _{GLH}	G-to-Pad HIGH			6.8		7.6		8.6		10.1		14.2	ns
t _{GHL}	G-to-Pad LOW			6.8		7.6		8.6		10.1		14.2	ns
t _{LSU}	I/O Latch Set-Up		0.7		0.7		0.8		1.0		1.4		ns
t _{LH}	I/O Latch Hold		0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O			7.7		8.5		9.6		11.3		15.9	ns
t _{ACO}	Array Latch Clock-to-Ou (Pad-to-Pad) 32 I/O	ıt		14.8		16.5		18.7		22.0		30.8	ns
d _{TLH}	Capacitive Loading, LO	W to HIGH		0.05		0.05		0.06		0.07		0.10	ns/pF
d _{THL}	Capacitive Loading, HIG	H to LOW		0.04		0.04		0.05		0.06		0.08	ns/pF
t _{HEXT}	•	FO = 32 FO = 486	3.9 4.6		4.3 5.2		4.9 5.8		5.7 6.9		8.1 9.6		ns ns
t _P		FO = 32 FO = 486	7.8 8.6		8.7 9.5		9.5 10.4		10.8 11.9		18.2 19.9		ns ns

^{1.} For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn} , t_{CO} + t_{RD1} + t_{PDn} , or t_{PD1} + t_{RD1} + t_{SUD} , whichever is appropriate.

Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

^{3.} Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.

^{4.} Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.

^{5.} Delays based on 35 pF loading.



Table 44

A42MX36 Timing Characteristics (Nominal 5.0 V Operation)
(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

		-3 S	peed	-2 Sp	peed	-1 Sp	peed	Std S	peed	−F Sp	peed	
Paramet	ter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic M	odule Combinatorial Functions ¹											
t _{PD}	Internal Array Module Delay		1.3		1.5		1.7		2.0		2.7	ns
t _{PDD}	Internal Decode Module Delay		1.6		1.8		2.0		2.4		3.3	ns
Logic M	odule Predicted Routing Delays ²											
t _{RD1}	FO = 1 Routing Delay		0.9		1.0		1.2		1.4		2.0	ns
t _{RD2}	FO = 2 Routing Delay		1.3		1.4		1.6		1.9		2.7	ns
t _{RD3}	FO =3 Routing Delay		1.6		1.8		2.0		2.4		3.4	ns
t _{RD4}	FO = 4 Routing Delay		2.0		2.2		2.5		2.9		4.1	ns
t _{RD5}	FO = 8 Routing Delay		3.3		3.7		4.2		4.9		6.9	ns
t _{RDD}	Decode-to-Output Routing Delay		0.3		0.4		0.4		0.5		0.7	ns
Logic M	odule Sequential Timing ^{3, 4}											
t _{CO}	Flip-Flop Clock-to-Output		1.3		1.4		1.6		1.9		2.7	ns
t _{GO}	Latch Gate-to-Output		1.3		1.4		1.6		1.9		2.7	ns
t _{SUD}	Flip-Flop (Latch) Set-Up Time	0.3		0.3		0.4		0.5		0.7		ns
t _{HD}	Flip-Flop (Latch) Hold Time	0.0		0.0		0.0		0.0		0.0		ns
t _{RO}	Flip-Flop (Latch) Reset-to-Output		1.6		1.7		2.0		2.3		3.2	ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	0.7		0.8		0.9		1.0		1.4		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	3.3		3.7		4.2		4.9		6.9		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	4.4		4.8		5.5		6.4		9.0		ns
Synchro	onous SRAM Operations											
t _{RC}	Read Cycle Time	6.8		7.5		8.5		10.0		14.0		ns
t _{WC}	Write Cycle Time	6.8		7.5		8.5		10.0		14.0		ns
t _{RCKHL}	Clock HIGH/LOW Time	3.4		3.8		4.3		5.0		7.0		ns
t _{RCO}	Data Valid After Clock HIGH/LOW		3.4		3.8		4.3		5.0		7.0	ns
t _{ADSU}	Address/Data Set-Up Time	1.6		1.8		2.0		2.4		3.4		ns
Synchro	onous SRAM Operations											
t _{ADH}	Address/Data Hold Time	0.0		0.0		0.0		0.0		0.0		ns
t _{RENSU}	Read Enable Set-Up	0.6		0.7		8.0		0.9		1.3		ns
t _{RENH}	Read Enable Hold	3.4		3.8		4.3		5.0		7.0		ns
t _{WENSU}	Write Enable Set-Up	2.7		3.0		3.4		4.0		5.6		ns
t _{WENH}	Write Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{BENS}	Block Enable Set-Up	2.8		3.1		3.5		4.1		5.7		ns
t _{BENH}	Block Enable Hold	0.0		0.0		0.0		0.0		0.0		ns



Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

			−3 S	peed	-2 S _I	peed	-1 Sp	oeed	Std S	peed	−F Sp	eed	
Paramet	er / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Asynchr	onous SRAM Operat	ions											
t _{RPD}	Asynchronous Acces	s Time		8.1		9.0		10.2		12.0		16.8	ns
t _{RDADV}	Read Address Valid		8.8		9.8		11.1		13.0		18.2		ns
t _{ADSU}	Address/Data Set-Up	Time	1.6		1.8		2.0		2.4		3.4		ns
t _{ADH}	Address/Data Hold T	ime	0.0		0.0		0.0		0.0		0.0		ns
t _{RENSUA}	Read Enable Set-Up Valid	to Address	0.6		0.7		0.8		0.9		1.3		ns
t _{RENHA}	Read Enable Hold		3.4		3.8		4.3		5.0		7.0		ns
t _{WENSU}	Write Enable Set-Up		2.7		3.0		3.4		4.0		5.6		ns
t _{WENH}	Write Enable Hold		0.0		0.0		0.0		0.0		0.0		ns
t _{DOH}	Data Out Hold Time			1.2		1.3		1.5		1.8		2.5	ns
Input Mo	dule Propagation De	lays											
t _{INPY}	Input Data Pad-to-Y			1.0		1.1		1.3		1.5		2.1	ns
t _{INGO}	Input Latch Gate-to-0	Dutput		1.4		1.6		1.8		2.1		2.9	ns
t _{INH}	Input Latch Hold		0.0		0.0		0.0		0.0		0.0		ns
t _{INSU}	Input Latch Set-Up		0.5		0.5		0.6		0.7		1.0		ns
t _{ILA}	Latch Active Pulse W	/idth	4.7		5.2		5.9		6.9		9.7		ns
Input Mo	dule Predicted Routi	ing Delays ²											
t _{IRD1}	FO = 1 Routing Delay			2.0		2.2		2.5		2.9		4.1	ns
t _{IRD2}	FO = 2 Routing Delay			2.3		2.6		2.9		3.4		4.8	ns
t _{IRD3}	FO = 3 Routing Delay			2.6		2.9		3.3		3.9		5.5	ns
t _{IRD4}	FO = 4 Routing Delay			3.0		3.3		3.8		4.4		6.2	ns
t _{IRD8}	FO = 8 Routing Delay			4.3		4.8		5.5		6.4		9.0	ns
Global C	lock Network												
t _{CKH}	Input LOW to HIGH	FO = 32 FO = 635		2.7 3.0		3.0 3.3		3.4 3.8		4.0 4.4		5.6 6.2	ns ns
t _{CKL}	Input HIGH to LOW	FO = 32 FO = 635		3.8 4.9		4.2 5.4		4.8 6.1		5.6 7.2		7.8 10.1	ns ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 32 FO = 635	1.8 2.0		2.0 2.2		2.2 2.5		2.6 2.9		3.6 4.1		ns ns
t _{PWL}	Minimum Pulse Width LOW	FO = 32 FO = 635	1.8 2.0		2.0 2.2		2.2 2.5		2.6 2.9		3.6 4.1		ns ns
t _{CKSW}	Maximum Skew	FO = 32 FO = 635		0.8 0.8		0.8		0.9 0.9		1.0 1.0		1.4 1.4	ns ns



Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

			-3 S	peed	-2 S	peed	-1 Sp	peed	Std S	peed	−F Sp	eed	
Paramet	ter / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{SUEXT}	Input Latch External	FO = 32	0.0		0.0		0.0		0.0		0.0		ns
	Set-Up	FO = 635	0.0		0.0		0.0		0.0		0.0		ns
t _{HEXT}	Input Latch External	FO = 32	2.8		3.2		3.6		4.2		5.9		ns
	Hold	FO = 635	3.3		3.7		4.2		4.9		6.9		ns
t _P	Minimum Period	FO = 32	5.5		6.1		6.6		7.6		12.7		ns
	(1/f _{MAX})	FO = 635	6.0		6.6		7.2		8.3		13.8		ns
f _{MAX}	Maximum Datapath	FO = 32		180		164		151		131		79	MHz
	Frequency	FO = 635		166		151		139		121		73	MHz
TTL Out	put Module Timing ⁵												
t _{DLH}	Data-to-Pad HIGH			2.6		2.8		3.2		3.8		5.3	ns
t _{DHL}	Data-to-Pad LOW			3.0		3.3		3.7		4.4		6.2	ns
t _{ENZH}	Enable Pad Z to HIG	Н		2.7		3.0		3.3		3.9		5.5	ns
t _{ENZL}	Enable Pad Z to LOV	V		3.0		3.3		3.7		4.3		6.1	ns
t _{ENHZ}	Enable Pad HIGH to	Z	•	5.3		5.8		6.6		7.8		10.9	ns



Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C) (continued)

		-3 S	peed	-2 S _I	peed	-1 Sp	peed	Std S	peed	−F Sp	oeed	
Parame	eter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
TTL Ou	tput Module Timing ⁵											
t _{ENLZ}	Enable Pad LOW to Z		4.9		5.5		6.2		7.3		10.2	ns
t _{GLH}	G-to-Pad HIGH		2.9		3.3		3.7		4.4		6.1	ns
t _{GHL}	G-to-Pad LOW		2.9		3.3		3.7		4.4		6.1	ns
t _{LSU}	I/O Latch Output Set-Up	0.5		0.5		0.6		0.7		1.0		ns
t _{LH}	I/O Latch Output Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		5.7		6.3		7.1		8.4		11.8	ns
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.8		8.6		9.8		11.5		16.1	ns
d _{TLH}	Capacitive Loading, LOW to HIGH		0.07		0.08		0.09		0.10		0.14	ns/pF
d _{THL}	Capacitive Loading, HIGH to LOW		0.07		0.08		0.09		0.10		0.14	ns/pF



Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCCA = 4.75 V, $T_J = 70$ °C) (continued)

		-3 S	peed	-2 S _I	peed	-1 Sp	peed	Std S	peed	−F Sp	eed	
Parame	eter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
CMOS	Output Module Timing ⁵											
t _{DLH}	Data-to-Pad HIGH		3.5		3.9		4.5		5.2		7.3	ns
t _{DHL}	Data-to-Pad LOW		2.5		2.7		3.1		3.6		5.1	ns
t _{ENZH}	Enable Pad Z to HIGH		2.7		3.0		3.3		3.9		5.5	ns
t _{ENZL}	Enable Pad Z to LOW		2.9		3.3		3.7		4.3		6.1	ns
t _{ENHZ}	Enable Pad HIGH to Z		5.3		5.8		6.6		7.8		10.9	ns
t _{ENLZ}	Enable Pad LOW to Z		4.9		5.5		6.2		7.3		10.2	ns
t _{GLH}	G-to-Pad HIGH		5.0		5.6		6.3		7.5		10.4	ns
t _{GHL}	G-to-Pad LOW		5.0		5.6		6.3		7.5		10.4	ns
t _{LSU}	I/O Latch Set-Up	0.5		0.5		0.6		0.7		1.0		ns
t _{LH}	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		5.7		6.3		7.1		8.4		11.8	ns
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.8		8.6		9.8		11.5		16.1	ns
d _{TLH}	Capacitive Loading, LOW to HIGH		0.07		0.08		0.09		0.10		0.14	ns/pF
d _{THL}	Capacitive Loading, HIGH to LOW		0.07		0.08		0.09		0.10		0.14	ns/pF

Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_{.1} = 70°C)

		-3 S _I	peed	-2 S	peed	-1 Sp	eed	Std S	Speed	−F S _I	peed	
Parame	eter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Logic N	Module Combinatorial Functions ¹											
t _{PD}	Internal Array Module Delay		1.9		2.1		2.3		2.7		3.8	ns
t _{PDD}	Internal Decode Module Delay		2.2		2.5		2.8		3.3		4.7	ns
Logic N	Module Predicted Routing Delays ²											
t _{RD1}	FO = 1 Routing Delay		1.3		1.5		1.7		2.0		2.7	ns
t _{RD2}	FO = 2 Routing Delay		1.8		2.0		2.3		2.7		3.7	ns
t _{RD3}	FO = 3 Routing Delay		2.3		2.5		2.8		3.4		4.7	ns
t _{RD4}	FO = 4 Routing Delay		2.8		3.1		3.5		4.1		5.7	ns

For dual-module macros, use $t_{PD1} + t_{RD1} + t_{PDn}$, $t_{CO} + t_{RD1} + t_{PDn}$, or $t_{PD1} + t_{RD1} + t_{SUD}$, whichever is appropriate. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.

Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.

Delays based on 35 pF loading.



Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

		-3 S _I	peed	-2 S	peed	-1 S _l	peed	Std S	peed	−F S _I	peed	
Paramet	er / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{RD5}	FO = 8 Routing Delay		4.6		5.2		5.8		6.9		9.6	ns
t _{RDD}	Decode-to-Output Routing Delay		0.5		0.5		0.6		0.7		1.0	ns
Logic Mo	odule Sequential Timing ^{3, 4}											
t _{CO}	Flip-Flop Clock-to-Output		1.8		2.0		2.3		2.7		3.7	ns
t _{GO}	Latch Gate-to-Output		1.8		2.0		2.3		2.7		3.7	ns
t _{SUD}	Flip-Flop (Latch) Set-Up Time	0.4		0.5		0.6		0.7		0.9		ns
t _{HD}	Flip-Flop (Latch) Hold Time	0.0		0.0		0.0		0.0		0.0		ns
t _{RO}	Flip-Flop (Latch) Reset-to-Output		2.2		2.4		2.7		3.2		4.5	ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	1.0		1.1		1.2		1.4		2.0		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	4.6		5.2		5.8		6.9		9.6		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	6.1		6.8		7.7		9.0		12.6		ns
Synchro	nous SRAM Operations											
t _{RC}	Read Cycle Time	9.5		10.5		11.9		14.0		19.6		ns
t _{WC}	Write Cycle Time	9.5		10.5		11.9		14.0		19.6		ns
t _{RCKHL}	Clock HIGH/LOW Time	4.8		5.3		6.0		7.0		9.8		ns
t _{RCO}	Data Valid After Clock HIGH/LOW		4.8		5.3		6.0		7.0		9.8	ns
t _{ADSU}	Address/Data Set-Up Time	2.3		2.5		2.8		3.4		4.8		ns



Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

		-3 S _I	peed	-2 S	peed	-1 S _l	peed	Std S	Speed	−F S _I	peed	
Paramete	er / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Synchro	nous SRAM Operations											
t _{ADH}	Address/Data Hold Time	0.0		0.0		0.0		0.0		0.0		ns
t _{RENSU}	Read Enable Set-Up	0.9		1.0		1.1		1.3		1.8		ns
t _{RENH}	Read Enable Hold	4.8		5.3		6.0		7.0		9.8		ns
t _{WENSU}	Write Enable Set-Up	3.8		4.2		4.8		5.6		7.8		ns
t _{WENH}	Write Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{BENS}	Block Enable Set-Up	3.9		4.3		4.9		5.7		8.0		ns
t _{BENH}	Block Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
Asynchr	onous SRAM Operations											
t _{RPD}	Asynchronous Access Time		11.3		12.6		14.3		16.8		23.5	ns
t _{RDADV}	Read Address Valid	12.3		13.7		15.5		18.2		25.5		ns
t _{ADSU}	Address/Data Set-Up Time	2.3		2.5		2.8		3.4		4.8		ns
t _{ADH}	Address/Data Hold Time	0.0		0.0		0.0		0.0		0.0		ns
t _{RENSUA}	Read Enable Set-Up to Address Valid	0.9		1.0		1.1		1.3		1.8		ns
t _{RENHA}	Read Enable Hold	4.8		5.3		6.0		7.0		9.8		ns
t _{WENSU}	Write Enable Set-Up	3.8		4.2		4.8		5.6		7.8		ns
t _{WENH}	Write Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{DOH}	Data Out Hold Time		1.8		2.0		2.1		2.5		3.5	ns
Input Mo	dule Propagation Delays											
t _{INPY}	Input Data Pad-to-Y		1.4		1.6		1.8		2.1		3.0	ns
t _{INGO}	Input Latch Gate-to-Output		2.0		2.2		2.5		2.9		4.1	ns
t _{INH}	Input Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{INSU}	Input Latch Set-Up	0.7		0.7		8.0		1.0		1.4		ns
t _{ILA}	Latch Active Pulse Width	6.5		7.3		8.2		9.7		13.5		ns



Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

			−3 S	peed	-2 S	peed	-1 S _I	peed	Std S	Speed	−F S _I	peed	
Paramet	ter / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Input Mo	odule Predicted Routin	g Delays ²											
t _{IRD1}	FO = 1 Routing Delay			2.8		3.1		3.5		4.1		5.7	ns
t _{IRD2}	FO = 2 Routing Delay			3.2		3.5		4.1		4.8		6.7	ns
t _{IRD3}	FO = 3 Routing Delay			3.7		4.1		4.7		5.5		7.7	ns
t _{IRD4}	FO = 4 Routing Delay			4.2		4.6		5.3		6.2		8.7	ns
t _{IRD8}	FO = 8 Routing Delay			6.1		6.8		7.7		9.0		12.6	ns
Global (Clock Network												
t _{CKH}	Input LOW to HIGH	FO = 32 FO = 635		4.6 5.0		5.1 5.6		5.7 6.3		6.7 7.4		9.3 10.3	ns ns
t _{CKL}	Input HIGH to LOW	FO = 32 FO = 635		5.3 6.8		5.9 7.6		6.7 8.6		7.8 10.1		11.0 14.1	ns ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 32 FO = 635	2.5 2.8		2.7 3.1		3.1 3.5		3.6 4.1		5.1 5.7		ns ns
t _{PWL}	Minimum Pulse Width LOW	FO = 32 FO = 635	2.5 2.8		2.7 3.1		3.1 3.5		3.6 4.1		5.1 5.7		ns ns
t _{CKSW}	Maximum Skew	FO = 32 FO = 635		1.0 1.0		1.2 1.2		1.3 1.3		1.5 1.5		2.2 2.2	ns ns
t _{SUEXT}	Input Latch External Set-Up	FO = 32 FO = 635	0.0		0.0		0.0		0.0 0.0		0.0		ns ns
t _{HEXT}	Input Latch External Hold	FO = 32 FO = 635	4.0 4.6		4.4 5.2		5.0 5.9		5.9 6.9		8.2 9.6		ns ns
t _P	Minimum Period (1/f _{MAX})	FO = 32 FO = 635	9.2 9.9		10.2 11.0		11.1 12.0		12.7 13.8		21.2 23.0		ns ns
f _{MAX}	Maximum Datapath Frequency	FO = 32 FO = 635		108 100		98 91		90 83		79 73		47 44	MHz MHz
TTL Out	put Module Timing ⁵												
t _{DLH}	Data-to-Pad HIGH			3.6		4.0		4.5		5.3		7.4	ns
t _{DHL}	Data-to-Pad LOW			4.2		4.6		5.2		6.2		8.6	ns
t _{ENZH}	Enable Pad Z to HIGH			3.7		4.2		4.7		5.5		7.7	ns
t _{ENZL}	Enable Pad Z to LOW			4.1		4.6		5.2		6.1		8.5	ns
t _{ENHZ}	Enable Pad HIGH to Z			7.34		8.2		9.3		10.9		15.3	ns
TTL Out	put Module Timing ⁵												
t _{ENLZ}	Enable Pad LOW to Z			6.9		7.6		8.7		10.2		14.3	ns
t _{GLH}	G-to-Pad HIGH			4.9		5.5		6.2		7.3		10.2	ns
t _{GHL}	G-to-Pad LOW			4.9		5.5		6.2		7.3		10.2	ns
t _{LSU}	I/O Latch Output Set-U	Jр	0.7		0.7		8.0		1.0		1.4		ns
t _{LH}	I/O Latch Output Hold		0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O	İ		7.9		8.8		10.0		11.8		16.5	ns



Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C) (continued)

		-3 S	peed	–2 S	peed	-1 S	peed	Std S	peed	−F S _I	peed	
Parame	ter / Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		10.9		12.1		13.7		16.1		22.5	ns
d _{TLH}	Capacitive Loading, LOW to HIGH		0.10		0.11		0.12		0.14		0.20	ns/pF
d _{THL}	Capacitive Loading, HIGH to LOW		0.10		0.11		0.12		0.14		0.20	ns/pF
CMOS	Dutput Module Timing ⁵											
t _{DLH}	Data-to-Pad HIGH		4.9		5.5		6.2		7.3		10.3	ns
t _{DHL}	Data-to-Pad LOW		3.4		3.8		4.3		5.1		7.1	ns
t _{ENZH}	Enable Pad Z to HIGH		3.7		4.1		4.7		5.5		7.7	ns
t _{ENZL}	Enable Pad Z to LOW		4.1		4.6		5.2		6.1		8.5	ns
t _{ENHZ}	Enable Pad HIGH to Z		7.4		8.2		9.3		10.9		15.3	ns
t _{ENLZ}	Enable Pad LOW to Z		6.9		7.6		8.7		10.2		14.3	ns
t _{GLH}	G-to-Pad HIGH		7.0		7.8		8.9		10.4		14.6	ns
t _{GHL}	G-to-Pad LOW		7.0		7.8		8.9		10.4		14.6	ns
t _{LSU}	I/O Latch Set-Up	0.7		0.7		8.0		1.0		1.4		ns
t _{LH}	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.9		8.8		10.0		11.8		16.5	ns

- 1. For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn} , t_{CO} + t_{RD1} + t_{PDn} , or t_{PD1} + t_{RD1} + t_{SUD} , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
- 3. Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
- 4. Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
- 5. Delays based on 35 pF loading.

3.12 Pin Descriptions

This section lists the pin descriptions for 40MX and 42MX series FPGAs.

CLK/A/B, I/O Global Clock

Clock inputs for clock distribution networks. CLK is for 40MX while CLKA and CLKB are for 42MX devices. The clock input is buffered prior to clocking the logic modules. This pin can also be used as an I/O

DCLK, I/ODiagnostic Clock

Clock input for diagnostic probe and device programming. DCLK is active when the MODE pin is HIGH. This pin functions as an I/O when the MODE pin is LOW.

GND, Ground

Input LOW supply voltage.

I/O, Input/Output



Input, output, tristate or bidirectional buffer. Input and output levels are compatible with standard TTL and CMOS specifications. Unused I/Os pins are configured by the Designer software as shown in Table 46, page 86.

Table 46 • Configuration of Unused I/Os

Device	Configuration
A40MX02, A40MX04	Pulled LOW
A42MX09, A42MX16	Pulled LOW
A42MX24, A42MX36	Tristated

In all cases, it is recommended to tie all unused MX I/O pins to LOW on the board. This applies to all dual-purpose pins when configured as I/Os as well.

LP, Low Power Mode

Controls the low power mode of all 42MX devices. The device is placed in the low power mode by connecting the LP pin to logic HIGH. In low power mode, all I/Os are tristated, all input buffers are turned OFF, and the core of the device is turned OFF. To exit the low power mode, the LP pin must be set to LOW. The device enters the low power mode 800 ns after the LP pin is driven to a logic HIGH. It will resume normal operation in 200 µs after the LP pin is driven to a logic LOW.

MODE, Mode

Controls the use of multifunction pins (DCLK, PRA, PRB, SDI, TDO). The MODE pin is held HIGH to provide verification capability. The MODE pin should be terminated to GND through a $10k\Omega$ resistor so that the MODE pin can be pulled HIGH when required.

NC, No Connection

This pin is not connected to circuitry within the device. These pins can be driven to any voltage or can be left floating with no effect on the operation of the device.

PRA, I/O

PRB, I/OProbe A/B

The probe pin is used to output data from any user-defined design node within the device. Each diagnostic pin can be used in conjunction with the other probe pin to allow real-time diagnostic output of any signal path within the device. The probe pin can be used as a user-defined I/O when verification has been completed. The pin's probe capabilities can be permanently disabled to protect programmed design confidentiality. The probe pin is accessible when the MODE pin is HIGH. This pin functions as an I/O when the MODE pin is LOW.

QCLKA/B/C/D, I/O Quadrant Clock

Quadrant clock inputs for A42MX36 devices. When not used as a register control signal, these pins can function as user I/Os.

SDI, I/OSerial Data Input

Serial data input for diagnostic probe and device programming. SDI is active when the MODE pin is HIGH. This pin functions as an I/O when the MODE pin is LOW.

SDO, I/OSerial Data Output

Serial data output for diagnostic probe and device programming. SDO is active when the MODE pin is HIGH. This pin functions as an I/O when the MODE pin is LOW. SDO is available for 42MX devices only.

When Silicon Explorer II is being used, SDO will act as an output while the "checksum" command is run. It will return to user I/O when "checksum" is complete.



TCK, I/O Test Clock

Clock signal to shift the boundary scan test (BST) data into the device. This pin functions as an I/O when "Reserve JTAG" is not checked in the Designer Software. BST pins are only available in A42MX24 and A42MX36 devices.

TDI, I/OTest Data In

Serial data input for BST instructions and test data. Data is shifted in on the rising edge of TCK. This pin functions as an I/O when "Reserve JTAG" is not checked in the Designer Software. BST pins are only available in A42MX24 and A42MX36 devices.

TDO, I/OTest Data Out

Serial data output for BST instructions and test data. This pin functions as an I/O when "Reserve JTAG" is not checked in the Designer Software. BST pins are only available in A42MX24 and A42MX36 devices.

TMS, I/OTest Mode Select

The TMS pin controls the use of the IEEE 1149.1 boundary scan pins (TCK, TDI, TDO). In flexible mode when the TMS pin is set to LOW, the TCK, TDI and TDO pins act as boundary scan pins. Once the boundary scan pins are in test mode, they will remain in that mode until the internal boundary scan state machine reaches the "logic reset" state. At this point, the boundary scan pins will be released and will function as regular I/O pins. The "logic reset" state is reached 5 TCK cycles after the TMS pin is set to HIGH. In dedicated test mode, TMS functions as specified in the IEEE 1149.1 specifications. IEEE JTAG specification recommends a $10k\Omega$ pull-up resistor on the pin. BST pins are only available in A42MX24 and A42MX36 devices.

VCC, Supply Voltage

Input supply voltage for 40MX devices

VCCA, Supply Voltage

Supply voltage for an array in 42MX devices

VCCI, Supply Voltage

Supply voltage for I/Os in 42MX devices

WD, I/OWide Decode Output

When a wide decode module is used in a 42MX device; this pin can be used as a dedicated output from the wide decode module. This direct connection eliminates additional interconnect delays associated with regular logic modules. To implement the direct I/O connection, connect an output buffer of any type to the output of the wide decode macro and place this output on one of the reserved WD pins.



4 Package Pin Assignments

The following figures and tables give the details of the package pin assignments.

Figure 38 • PL44

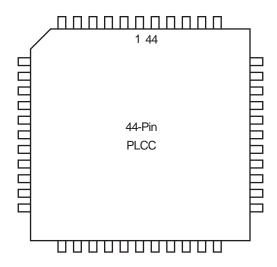


Table 47 • PL44

PL44		
Pin Number	A40MX02 Function	A40MX04 Function
1	I/O	I/O
2	I/O	I/O
3	VCC	VCC
4	I/O	I/O
5	I/O	I/O
6	I/O	I/O
7	I/O	I/O
8	I/O	I/O
9	I/O	I/O
10	GND	GND
11	I/O	I/O
12	I/O	I/O
13	I/O	I/O
14	VCC	VCC
15	I/O	I/O
16	VCC	VCC
17	I/O	I/O
18	I/O	I/O
19	I/O	I/O
20	I/O	I/O



Table 47 • PL44 (continued)

PL44		
Pin Number	A40MX02 Function	A40MX04 Function
21	GND	GND
22	I/O	I/O
23	I/O	I/O
24	I/O	I/O
25	VCC	VCC
26	I/O	I/O
27	I/O	I/O
28	I/O	I/O
29	I/O	I/O
30	I/O	I/O
31	I/O	I/O
32	GND	GND
33	CLK, I/O	CLK, I/O
34	MODE	MODE
35	VCC	VCC
36	SDI, I/O	SDI, I/O
37	DCLK, I/O	DCLK, I/O
38	PRA, I/O	PRA, I/O
39	PRB, I/O	PRB, I/O
40	I/O	I/O
41	I/O	I/O
42	I/O	I/O
43	GND	GND
44	I/O	I/O



Figure 39 • PL68

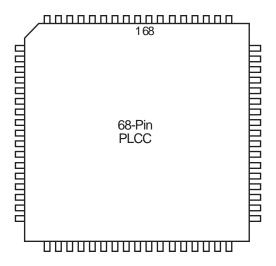


Table 48 • PL68

PL68		
Pin Number	A40MX02 Function	A40MX04 Function
1	I/O	I/O
2	I/O	I/O
3	I/O	I/O
4	VCC	VCC
5	I/O	I/O
6	I/O	I/O
7	I/O	I/O
8	I/O	I/O
9	I/O	I/O
10	I/O	I/O
11	I/O	I/O
12	I/O	I/O
13	I/O	I/O
14	GND	GND
15	GND	GND
16	I/O	I/O
17	I/O	I/O
18	I/O	I/O
19	I/O	I/O
20	I/O	I/O
21	VCC	VCC
22	I/O	I/O
23	I/O	I/O
-		



Table 48 • PL68 (continued)

PL68		
Pin Number	A40MX02 Function	A40MX04 Function
24	I/O	I/O
25	VCC	VCC
26	I/O	I/O
27	I/O	I/O
28	I/O	I/O
29	I/O	I/O
30	I/O	I/O
31	I/O	I/O
32	GND	GND
33	I/O	I/O
34	I/O	I/O
35	I/O	I/O
36	I/O	I/O
37	I/O	I/O
38	VCC	VCC
39	I/O	I/O
40	I/O	I/O
41	I/O	I/O
42	I/O	I/O
43	I/O	I/O
44	I/O	I/O
45	I/O	I/O
46	I/O	I/O
47	I/O	I/O
48	I/O	I/O
49	GND	GND
50	I/O	I/O
51	I/O	I/O
52	CLK, I/O	CLK, I/O
53	I/O	I/O
54	MODE	MODE
55	VCC	VCC
56	SDI, I/O	SDI, I/O
57	DCLK, I/O	DCLK, I/O
58	PRA, I/O	PRA, I/O
59	PRB, I/O	PRB, I/O
60	I/O	I/O



Table 48 • PL68 (continued)

PL68		
Pin Number	A40MX02 Function	A40MX04 Function
61	I/O	I/O
62	I/O	I/O
63	I/O	I/O
64	I/O	I/O
65	I/O	I/O
66	GND	GND
67	I/O	I/O
68	I/O	I/O

Figure 40 • PL84

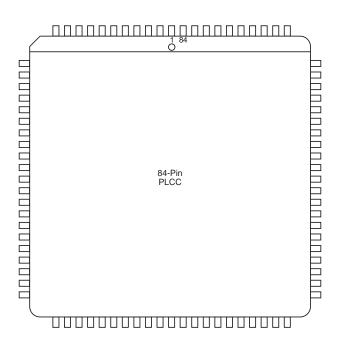


Table 49 • PL84

PL84				
Pin Number	A40MX04 Function	A42MX09 Function	A42MX16 Function	A42MX24 Function
1	I/O	I/O	I/O	I/O
2	I/O	CLKB, I/O	CLKB, I/O	CLKB, I/O
3	I/O	I/O	I/O	I/O
4	VCC	PRB, I/O	PRB, I/O	PRB, I/O
5	I/O	I/O	I/O	WD, I/O
6	I/O	GND	GND	GND
7	I/O	I/O	I/O	I/O
8	I/O	I/O	I/O	WD, I/O
9	I/O	I/O	I/O	WD, I/O



Table 49 • PL84 (continued)

PL84				
Pin Number	A40MX04 Function	A42MX09 Function	A42MX16 Function	A42MX24 Function
10	I/O	DCLK, I/O	DCLK, I/O	DCLK, I/O
11	I/O	I/O	I/O	I/O
12	NC	MODE	MODE	MODE
13	I/O	I/O	I/O	I/O
14	I/O	I/O	I/O	I/O
15	I/O	I/O	I/O	I/O
16	I/O	I/O	I/O	I/O
17	I/O	I/O	I/O	I/O
18	GND	I/O	I/O	I/O
19	GND	I/O	I/O	I/O
20	I/O	I/O	I/O	I/O
21	I/O	I/O	I/O	I/O
22	I/O	VCCA	VCCI	VCCI
23	I/O	VCCI	VCCA	VCCA
24	I/O	I/O	I/O	I/O
25	VCC	I/O	I/O	I/O
26	VCC	I/O	I/O	I/O
27	I/O	I/O	I/O	I/O
28	I/O	GND	GND	GND
29	I/O	I/O	I/O	I/O
30	I/O	I/O	I/O	I/O
31	I/O	I/O	I/O	I/O
32	I/O	I/O	I/O	I/O
33	VCC	I/O	I/O	I/O
34	I/O	I/O	I/O	TMS, I/O
35	I/O	I/O	I/O	TDI, I/O
36	I/O	I/O	I/O	WD, I/O
37	I/O	I/O	I/O	I/O
38	I/O	I/O	I/O	WD, I/O
39	I/O	I/O	I/O	WD, I/O
40	GND	I/O	I/O	I/O
41	I/O	I/O	I/O	I/O
42	I/O	I/O	I/O	I/O
43	I/O	VCCA	VCCA	VCCA
44	I/O	I/O	I/O	WD, I/O
45	I/O	I/O	I/O	WD, I/O
46	VCC	I/O	I/O	WD, I/O



Table 49 • PL84 (continued)

PL84				
Pin Number	A40MX04 Function	A42MX09 Function	A42MX16 Function	A42MX24 Function
47	I/O	I/O	I/O	WD, I/O
48	I/O	I/O	I/O	I/O
49	I/O	GND	GND	GND
50	I/O	I/O	I/O	WD, I/O
51	I/O	I/O	I/O	WD, I/O
52	I/O	SDO, I/O	SDO, I/O	SDO, TDO, I/O
53	I/O	I/O	I/O	I/O
54	I/O	I/O	I/O	I/O
55	I/O	I/O	I/O	I/O
56	I/O	I/O	I/O	I/O
57	I/O	I/O	I/O	I/O
58	I/O	I/O	I/O	I/O
59	I/O	I/O	I/O	I/O
60	GND	I/O	I/O	I/O
61	GND	I/O	I/O	I/O
62	I/O	I/O	I/O	TCK, I/O
63	I/O	LP	LP	LP
64	CLK, I/O	VCCA	VCCA	VCCA
65	I/O	VCCI	VCCI	VCCI
66	MODE	I/O	I/O	I/O
67	VCC	I/O	I/O	I/O
68	VCC	I/O	I/O	I/O
69	I/O	I/O	I/O	I/O
70	I/O	GND	GND	GND
71	I/O	I/O	I/O	I/O
72	SDI, I/O	I/O	I/O	I/O
73	DCLK, I/O	I/O	I/O	I/O
74	PRA, I/O	I/O	I/O	I/O
75	PRB, I/O	I/O	I/O	I/O
76	I/O	SDI, I/O	SDI, I/O	SDI, I/O
77	I/O	I/O	I/O	I/O
78	I/O	I/O	I/O	WD, I/O
79	I/O	I/O	I/O	WD, I/O
80	I/O	I/O	I/O	WD, I/O
81	I/O	PRA, I/O	PRA, I/O	PRA, I/O
82	GND	I/O	I/O	I/O
83	I/O	CLKA, I/O	CLKA, I/O	CLKA, I/O



Table 49 • PL84 (continued)

PL84				
Pin Number	A40MX04 Function	A42MX09 Function	A42MX16 Function	A42MX24 Function
84	I/O	VCCA	VCCA	VCCA

Figure 41 • PQ100

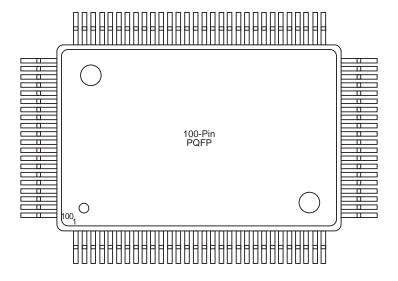


Table 50 • PQ 100

PQ100				
Pin Number	A40MX02 Function	A40MX04 Function	A42MX09 Function	A42MX16 Function
1	NC	NC	I/O	I/O
2	NC	NC	DCLK, I/O	DCLK, I/O
3	NC	NC	I/O	I/O
4	NC	NC	MODE	MODE
5	NC	NC	I/O	I/O
6	PRB, I/O	PRB, I/O	I/O	I/O
7	I/O	I/O	I/O	I/O
8	I/O	I/O	I/O	I/O
9	I/O	I/O	GND	GND
10	I/O	I/O	I/O	I/O
11	I/O	I/O	I/O	I/O
12	I/O	I/O	I/O	I/O
13	GND	GND	I/O	I/O
14	I/O	I/O	I/O	I/O
15	I/O	I/O	I/O	I/O
16	I/O	I/O	VCCA	VCCA
17	I/O	I/O	VCCI	VCCA
18	I/O	I/O	I/O	I/O



Table 50 • PQ 100 (continued)

PQ100				
Pin Number	A40MX02 Function	A40MX04 Function	A42MX09 Function	A42MX16 Function
19	VCC	V _{CC}	I/O	I/O
20	I/O	I/O	I/O	I/O
21	I/O	I/O	I/O	I/O
22	I/O	I/O	GND	GND
23	I/O	I/O	I/O	I/O
24	I/O	I/O	I/O	I/O
25	I/O	I/O	I/O	I/O
26	I/O	I/O	I/O	I/O
27	NC	NC	I/O	I/O
28	NC	NC	I/O	I/O
29	NC	NC	I/O	I/O
30	NC	NC	I/O	I/O
31	NC	I/O	I/O	I/O
32	NC	I/O	I/O	I/O
33	NC	I/O	I/O	I/O
34	I/O	I/O	GND	GND
35	I/O	I/O	I/O	I/O
36	GND	GND	I/O	I/O
37	GND	GND	I/O	I/O
38	I/O	I/O	I/O	I/O
39	I/O	I/O	I/O	I/O
40	I/O	I/O	VCCA	VCCA
41	I/O	I/O	I/O	I/O
42	I/O	I/O	I/O	I/O
43	VCC	VCC	I/O	I/O
44	VCC	VCC	I/O	I/O
45	I/O	I/O	I/O	I/O
46	I/O	I/O	GND	GND
47	I/O	I/O	I/O	I/O
48	NC	I/O	I/O	I/O
49	NC	I/O	I/O	I/O
50	NC	I/O	I/O	I/O
51	NC	NC	I/O	I/O
52	NC	NC	SDO, I/O	SDO, I/O
53	NC	NC	I/O	I/O
54	NC	NC	I/O	I/O
55	NC	NC	I/O	I/O



Table 50 • PQ 100 (continued)

PQ100				
Pin Number	A40MX02 Function	A40MX04 Function	A42MX09 Function	A42MX16 Function
56	VCC	VCC	I/O	I/O
57	I/O	I/O	GND	GND
58	I/O	I/O	I/O	I/O
59	I/O	I/O	I/O	I/O
60	I/O	I/O	I/O	I/O
61	I/O	I/O	I/O	I/O
62	I/O	I/O	I/O	I/O
63	GND	GND	I/O	I/O
64	I/O	I/O	LP	LP
65	I/O	I/O	VCCA	VCCA
66	I/O	I/O	VCCI	VCCI
67	I/O	I/O	VCCA	VCCA
68	I/O	I/O	I/O	I/O
69	VCC	VCC	I/O	I/O
70	I/O	I/O	I/O	I/O
71	I/O	I/O	I/O	I/O
72	I/O	I/O	GND	GND
73	I/O	I/O	I/O	I/O
74	I/O	I/O	I/O	I/O
75	I/O	I/O	I/O	I/O
76	I/O	I/O	I/O	I/O
77	NC	NC	I/O	I/O
78	NC	NC	I/O	I/O
79	NC	NC	SDI, I/O	SDI, I/O
80	NC	I/O	I/O	I/O
81	NC	I/O	I/O	I/O
82	NC	I/O	I/O	I/O
83	I/O	I/O	I/O	I/O
84	I/O	I/O	GND	GND
85	I/O	I/O	I/O	I/O
86	GND	GND	I/O	I/O
87	GND	GND	PRA, I/O	PRA, I/O
88	I/O	I/O	I/O	I/O
89	I/O	I/O	CLKA, I/O	CLKA, I/O
90	CLK, I/O	CLK, I/O	VCCA	VCCA
91	I/O	I/O	I/O	I/O
92	MODE	MODE	CLKB, I/O	CLKB, I/O



Table 50 • PQ 100 (continued)

PQ100				
Pin Number	A40MX02 Function	A40MX04 Function	A42MX09 Function	A42MX16 Function
93	VCC	VCC	I/O	I/O
94	VCC	VCC	PRB, I/O	PRB, I/O
95	NC	I/O	I/O	I/O
96	NC	I/O	GND	GND
97	NC	I/O	I/O	I/O
98	SDI, I/O	SDI, I/O	I/O	I/O
99	DCLK, I/O	DCLK, I/O	I/O	I/O
100	PRA, I/O	PRA, I/O	I/O	I/O



Figure 42 • PQ144

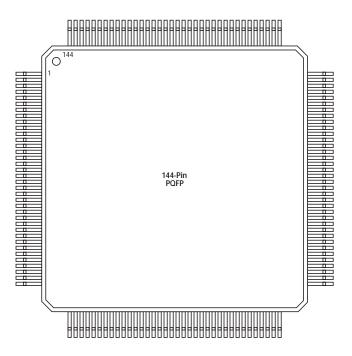


Table 51 • PQ144

PQ144	
Pin Number	A42MX09 Function
1	I/O
2	MODE
3	I/O
4	I/O
5	I/O



Table 51 • PQ144 (continued)

PQ144	_
Pin Number	A42MX09 Function
6	1/0
7	I/O
8	I/O
9	GNDQ
10	GNDI
11	NC
12	I/O
13	I/O
14	I/O
15	I/O
16	I/O
17	I/O
18	VSV
19	VCC
20	VCCI
21	NC
22	I/O
23	I/O
24	I/O
25	I/O
26	I/O
27	I/O
28	GND
29	GNDI
30	NC
31	I/O
32	I/O
33	I/O
34	I/O
35	I/O
36	I/O
37	BININ
38	BINOUT
39	I/O
40	I/O
41	I/O
42	I/O



Table 51 • PQ144 (continued)

PQ144	
Pin Number	A42MX09 Function
43	1/0
44	GNDQ
45	GNDI
46	
	NC I/O
47	1/0
48	
49	1/0
50	1/0
51	1/0
52	1/0
53	I/O
54	VCC
55	VCCI
56	NC
57	I/O
58	I/O
59	I/O
60	I/O
61	I/O
62	I/O
63	I/O
64	GND
65	GNDI
66	I/O
67	I/O
68	I/O
69	I/O
70	I/O
71	SDO
72	I/O
73	I/O
74	I/O
75	I/O
76	I/O
77	I/O
78	I/O
79	GNDQ
-	



Table 51 • PQ144 (continued)

PQ144	
Pin Number	A42MX09 Function
80	GNDI
81	NC
82	I/O
83	I/O
84	I/O
85	I/O
86	I/O
87	I/O
88	VKS
89	VPP
90	VCC
91	VCCI
92	NC
93	VSV
94	I/O
95	I/O
96	I/O
97	I/O
98	I/O
99	I/O
100	GND
101	GNDI
102	NC
103	I/O
104	I/O
105	I/O
106	I/O
107	I/O
108	I/O
109	I/O
110	SDI
111	I/O
112	I/O
113	I/O
114	I/O
115	I/O
116	GNDQ



Table 51 • PQ144 (continued)

PQ144	
Pin Number	A42MX09 Function
117	GNDI
118	NC
119	I/O
120	I/O
121	I/O
122	I/O
123	PROBA
124	I/O
125	CLKA
126	VCC
127	VCCI
128	NC
129	I/O
130	CLKB
131	I/O
132	PROBB
133	I/O
134	I/O
135	I/O
136	GND
137	GNDI
138	NC
139	I/O
140	I/O
141	I/O
142	I/O
143	I/O
144	DCLK



Figure 43 • PQ160

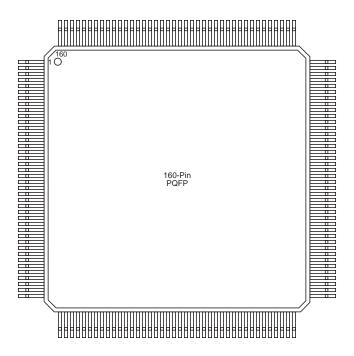


Table 52 • PQ160

Pin Number 1 2	A42MX09 Function I/O DCLK, I/O	A42MX16 Function I/O	
		I/O	1/0
2	DCLK, I/O		I/O
		DCLK, I/O	DCLK, I/O
3	NC	I/O	I/O
4	I/O	I/O	WD, I/O
5	I/O	I/O	WD, I/O
6	NC	VCCI	VCCI
7	I/O	I/O	I/O
8	I/O	I/O	I/O
9	I/O	I/O	I/O
10	NC	I/O	I/O
11	GND	GND	GND
12	NC	I/O	I/O
13	I/O	I/O	WD, I/O
14	I/O	I/O	WD, I/O
15	I/O	I/O	I/O
16	PRB, I/O	PRB, I/O	PRB, I/O
17	I/O	I/O	I/O
18	CLKB, I/O	CLKB, I/O	CLKB, I/O
19	I/O	I/O	I/O
20	VCCA	VCCA	VCCA



Table 52 • PQ160 (continued)

PQ160			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
21	CLKA, I/O	CLKA, I/O	CLKA, I/O
22	I/O	I/O	I/O
23	PRA, I/O	PRA, I/O	PRA, I/O
24	NC	I/O	WD, I/O
25	I/O	I/O	WD, I/O
26	I/O	I/O	I/O
27	I/O	I/O	I/O
28	NC	I/O	I/O
29	I/O	I/O	WD, I/O
30	GND	GND	GND
31	NC	I/O	WD, I/O
32	I/O	I/O	I/O
33	I/O	I/O	I/O
34	I/O	I/O	I/O
35	NC	VCCI	VCCI
36	I/O	I/O	WD, I/O
37	I/O	I/O	WD, I/O
38	SDI, I/O	SDI, I/O	SDI, I/O
39	I/O	I/O	I/O
40	GND	GND	GND
41	I/O	I/O	I/O
42	I/O	I/O	I/O
43	I/O	I/O	I/O
44	GND	GND	GND
45	I/O	I/O	I/O
46	I/O	I/O	I/O
47	I/O	I/O	I/O
48	I/O	I/O	I/O
49	GND	GND	GND
50	I/O	I/O	I/O
51	I/O	I/O	I/O
52	NC	I/O	I/O
53	I/O	I/O	I/O
54	NC	VCCA	VCCA
55	I/O	I/O	I/O
56	I/O	I/O	I/O
57	VCCA	VCCA	VCCA



Table 52 • PQ160 (continued)

PQ160			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
58	VCCI	VCCI	VCCI
59	GND	GND	GND
60	VCCA	VCCA	VCCA
61	LP	LP	LP
62	I/O	I/O	TCK, I/O
63	I/O	I/O	I/O
64	GND	GND	GND
65	I/O	I/O	I/O
66	I/O	I/O	I/O
67	I/O	I/O	I/O
68	I/O	I/O	I/O
69	GND	GND	GND
70	NC	I/O	I/O
71	I/O	I/O	I/O
72	I/O	I/O	I/O
73	I/O	I/O	I/O
74	I/O	I/O	I/O
75	NC	I/O	I/O
76	I/O	I/O	I/O
77	NC	I/O	I/O
78	I/O	I/O	I/O
79	NC	I/O	I/O
80	GND	GND	GND
81	I/O	I/O	I/O
82	SDO, I/O	SDO, I/O	SDO, TDO, I/O
83	I/O	I/O	WD, I/O
84	I/O	I/O	WD, I/O
85	I/O	I/O	I/O
86	NC	VCCI	VCCI
87	I/O	I/O	I/O
88	I/O	I/O	WD, I/O
89	GND	GND	GND
90	NC	I/O	I/O
91	I/O	I/O	I/O
92	I/O	I/O	I/O
93	I/O	I/O	I/O
94	I/O	I/O	I/O



Table 52 • PQ160 (continued)

PQ160			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
95	I/O	I/O	I/O
96	I/O	I/O	WD, I/O
97	I/O	I/O	I/O
98	VCCA	VCCA	VCCA
99	GND	GND	GND
100	NC	I/O	I/O
101	I/O	I/O	I/O
102	I/O	I/O	I/O
103	NC	I/O	I/O
104	I/O	I/O	I/O
105	I/O	I/O	I/O
106	I/O	I/O	WD, I/O
107	I/O	I/O	WD, I/O
108	I/O	I/O	I/O
109	GND	GND	GND
110	NC	I/O	I/O
111	I/O	I/O	WD, I/O
112	I/O	I/O	WD, I/O
113	I/O	I/O	I/O
114	NC	VCCI	VCCI
115	I/O	I/O	WD, I/O
116	NC	I/O	WD, I/O
117	I/O	I/O	I/O
118	I/O	I/O	TDI, I/O
119	I/O	I/O	TMS, I/O
120	GND	GND	GND
121	I/O	I/O	I/O
122	I/O	I/O	I/O
123	I/O	I/O	I/O
124	NC	I/O	I/O
125	GND	GND	GND
126	I/O	I/O	I/O
127	I/O	I/O	I/O
128	I/O	I/O	I/O
129	NC	I/O	I/O
130	GND	GND	GND
131	I/O	I/O	I/O



Table 52 • PQ160 (continued)

PQ160			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
132	I/O	I/O	I/O
133	I/O	I/O	I/O
134	I/O	I/O	I/O
135	NC	VCCA	VCCA
136	I/O	I/O	I/O
137	I/O	I/O	I/O
138	NC	VCCA	VCCA
139	VCCI	VCCI	VCCI
140	GND	GND	GND
141	NC	I/O	I/O
142	I/O	I/O	I/O
143	I/O	I/O	I/O
144	I/O	I/O	I/O
145	GND	GND	GND
146	NC	I/O	I/O
147	I/O	I/O	I/O
148	I/O	I/O	I/O
149	I/O	I/O	I/O
150	NC	VCCA	VCCA
151	NC	I/O	I/O
152	NC	I/O	I/O
153	NC	I/O	I/O
154	NC	I/O	I/O
155	GND	GND	GND
156	I/O	I/O	I/O
157	I/O	I/O	I/O
158	I/O	I/O	I/O
159	MODE	MODE	MODE
160	GND	GND	GND



Figure 44 • PQ208

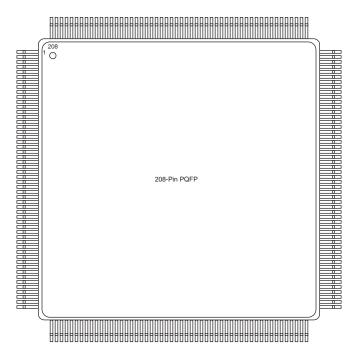


Table 53 • PQ208

PQ208			
Pin Number	A42MX16 Function	A42MX24 Function	A42MX36 Function
1	GND	GND	GND
2	NC	VCCA	VCCA
3	MODE	MODE	MODE
4	I/O	I/O	I/O
5	I/O	I/O	I/O
6	I/O	I/O	I/O
7	I/O	I/O	I/O
8	I/O	I/O	I/O
9	NC	I/O	I/O
10	NC	I/O	I/O
11	NC	I/O	I/O
12	I/O	I/O	I/O
13	I/O	I/O	I/O
14	I/O	I/O	I/O
15	I/O	I/O	I/O
16	NC	I/O	I/O
17	VCCA	VCCA	VCCA
18	I/O	I/O	I/O
19	I/O	I/O	I/O
20	I/O	I/O	I/O



Table 53 • PQ208 (continued)

PQ208			
Pin Number	A42MX16 Function	A42MX24 Function	A42MX36 Function
21	I/O	I/O	I/O
22	GND	GND	GND
23	I/O	I/O	I/O
24	I/O	I/O	I/O
25	I/O	I/O	I/O
26	I/O	I/O	I/O
27	GND	GND	GND
28	VCCI	VCCI	VCCI
29	VCCA	VCCA	VCCA
30	I/O	I/O	I/O
31	I/O	I/O	I/O
32	VCCA	VCCA	VCCA
33	I/O	I/O	I/O
34	I/O	I/O	I/O
35	I/O	I/O	I/O
36	I/O	I/O	I/O
37	I/O	I/O	I/O
38	I/O	I/O	I/O
39	I/O	I/O	I/O
40	I/O	I/O	I/O
41	NC	I/O	I/O
42	NC	I/O	I/O
43	NC	I/O	I/O
44	I/O	I/O	I/O
45	I/O	I/O	I/O
46	I/O	I/O	I/O
47	I/O	I/O	I/O
48	I/O	I/O	I/O
49	I/O	I/O	I/O
50	NC	I/O	I/O
51	NC	I/O	I/O
52	GND	GND	GND
53	GND	GND	GND
54	I/O	TMS, I/O	TMS, I/O
55	I/O	TDI, I/O	TDI, I/O
56	I/O	I/O	I/O
57	I/O	WD, I/O	WD, I/O



Table 53 • PQ208 (continued)

PQ208			
Pin Number	A42MX16 Function	A42MX24 Function	A42MX36 Function
58	I/O	WD, I/O	WD, I/O
59	I/O	I/O	I/O
60	VCCI	VCCI	VCCI
61	NC	I/O	I/O
62	NC	I/O	I/O
63	I/O	I/O	I/O
64	I/O	I/O	I/O
65	I/O	I/O	QCLKA, I/O
66	I/O	WD, I/O	WD, I/O
67	NC	WD, I/O	WD, I/O
68	NC	I/O	I/O
69	I/O	I/O	I/O
70	I/O	WD, I/O	WD, I/O
71	I/O	WD, I/O	WD, I/O
72	I/O	I/O	I/O
73	I/O	I/O	I/O
74	I/O	I/O	I/O
75	I/O	I/O	I/O
76	I/O	I/O	I/O
77	I/O	I/O	I/O
78	GND	GND	GND
79	VCCA	VCCA	VCCA
80	NC	VCCI	VCCI
81	I/O	I/O	I/O
82	I/O	I/O	I/O
83	I/O	I/O	I/O
84	I/O	I/O	I/O
85	I/O	WD, I/O	WD, I/O
86	I/O	WD, I/O	WD, I/O
87	I/O	I/O	I/O
88	I/O	I/O	I/O
89	NC	I/O	I/O
90	NC	I/O	I/O
91	I/O	I/O	QCLKB, I/O
92	I/O	I/O	I/O
93	I/O	WD, I/O	WD, I/O
94	I/O	WD, I/O	WD, I/O



Table 53 • PQ208 (continued)

PQ208			
Pin Number	A42MX16 Function	A42MX24 Function	A42MX36 Function
95	NC	I/O	I/O
96	NC	I/O	I/O
97	NC	I/O	I/O
98	VCCI	VCCI	VCCI
99	I/O	I/O	I/O
100	I/O	WD, I/O	WD, I/O
101	I/O	WD, I/O	WD, I/O
102	I/O	I/O	I/O
103	SDO, I/O	SDO, TDO, I/O	SDO, TDO, I/O
104	I/O	I/O	I/O
105	GND	GND	GND
106	NC	VCCA	VCCA
107	I/O	I/O	I/O
108	I/O	I/O	I/O
109	I/O	I/O	I/O
110	I/O	I/O	I/O
111	I/O	I/O	I/O
112	NC	I/O	I/O
113	NC	I/O	I/O
114	NC	I/O	I/O
115	NC	I/O	I/O
116	I/O	I/O	I/O
117	I/O	I/O	I/O
118	I/O	I/O	I/O
119	I/O	I/O	I/O
120	I/O	I/O	I/O
121	I/O	I/O	I/O
122	I/O	I/O	I/O
123	I/O	I/O	I/O
124	I/O	I/O	I/O
125	I/O	I/O	I/O
126	GND	GND	GND
127	I/O	I/O	I/O
128	I/O	TCK, I/O	TCK, I/O
129	LP	LP	LP
130	VCCA	VCCA	VCCA
131	GND	GND	GND



Table 53 • PQ208 (continued)

PQ208			
Pin Number	A42MX16 Function	A42MX24 Function	A42MX36 Function
132	VCCI	VCCI	VCCI
133	VCCA	VCCA	VCCA
134	I/O	I/O	I/O
135	I/O	I/O	I/O
136	VCCA	VCCA	VCCA
137	I/O	I/O	I/O
138	I/O	I/O	I/O
139	I/O	I/O	I/O
140	I/O	I/O	I/O
141	NC	I/O	I/O
142	I/O	I/O	I/O
143	I/O	I/O	I/O
144	I/O	I/O	I/O
145	I/O	I/O	I/O
146	NC	I/O	I/O
147	NC	I/O	I/O
148	NC	I/O	I/O
149	NC	I/O	I/O
150	GND	GND	GND
151	I/O	I/O	I/O
152	I/O	I/O	I/O
153	I/O	I/O	I/O
154	I/O	I/O	I/O
155	I/O	I/O	I/O
156	I/O	I/O	I/O
157	GND	GND	GND
158	I/O	I/O	I/O
159	SDI, I/O	SDI, I/O	SDI, I/O
160	I/O	I/O	I/O
161	I/O	WD, I/O	WD, I/O
162	I/O	WD, I/O	WD, I/O
163	I/O	I/O	I/O
164	VCCI	VCCI	VCCI
165	NC	I/O	I/O
166	NC	I/O	I/O
167	I/O	I/O	I/O
168	I/O	WD, I/O	WD, I/O



Table 53 • PQ208 (continued)

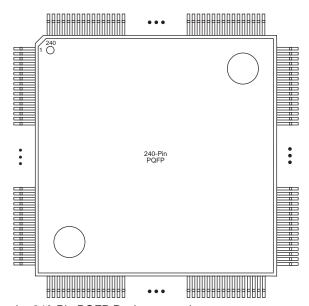
PQ208			
Pin Number	A42MX16 Function	A42MX24 Function	A42MX36 Function
169	I/O	WD, I/O	WD, I/O
170	I/O	I/O	I/O
171	NC	I/O	QCLKD, I/O
172	I/O	I/O	I/O
173	I/O	I/O	I/O
174	I/O	I/O	I/O
175	I/O	I/O	I/O
176	I/O	WD, I/O	WD, I/O
177	I/O	WD, I/O	WD, I/O
178	PRA, I/O	PRA, I/O	PRA, I/O
179	I/O	I/O	I/O
180	CLKA, I/O	CLKA, I/O	CLKA, I/O
181	NC	I/O	I/O
182	NC	VCCI	VCCI
183	VCCA	VCCA	VCCA
184	GND	GND	GND
185	I/O	I/O	I/O
186	CLKB, I/O	CLKB, I/O	CLKB, I/O
187	I/O	I/O	I/O
188	PRB, I/O	PRB, I/O	PRB, I/O
189	I/O	I/O	I/O
190	I/O	WD, I/O	WD, I/O
191	I/O	WD, I/O	WD, I/O
192	I/O	I/O	I/O
193	NC	I/O	I/O
194	NC	WD, I/O	WD, I/O
195	NC	WD, I/O	WD, I/O
196	I/O	I/O	QCLKC, I/O
197	NC	I/O	I/O
198	I/O	I/O	I/O
199	I/O	I/O	I/O
200	I/O	I/O	I/O
201	NC	I/O	I/O
202	VCCI	VCCI	VCCI
203	I/O	WD, I/O	WD, I/O
204	I/O	WD, I/O	WD, I/O
205	I/O	I/O	I/O



Table 53 • PQ208 (continued)

PQ208			
Pin Number	A42MX16 Function	A42MX24 Function	A42MX36 Function
206	I/O	I/O	I/O
207	DCLK, I/O	DCLK, I/O	DCLK, I/O
208	I/O	I/O	I/O

Figure 45 • PQ240



Note: This figure shows the 240-Pin PQFP Package top view.

Table 54 • PQ240

3 I/O 4 I/O 5 I/O 6 WD, I/O 7 WD, I/O 8 VCCI 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O	PQ240	
2 DCLK, I/O 3 I/O 4 I/O 5 I/O 6 WD, I/O 7 WD, I/O 8 VCCI 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O	Pin Number	A42MX36 Function
3 I/O 4 I/O 5 I/O 6 WD, I/O 7 WD, I/O 8 VCCI 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O	1	I/O
4 I/O 5 I/O 6 WD, I/O 7 WD, I/O 8 VCCI 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O	2	DCLK, I/O
5 I/O 6 WD, I/O 7 WD, I/O 8 VCCI 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O	3	I/O
6 WD, I/O 7 WD, I/O 8 VCCI 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O	4	I/O
7 WD, I/O 8 VCCI 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O	5	I/O
8 VCCI 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O	6	WD, I/O
9 I/O 10 I/O 11 I/O 12 I/O 13 I/O	7	WD, I/O
10 I/O 11 I/O 12 I/O 13 I/O	8	VCCI
11 I/O 12 I/O 13 I/O	9	I/O
12 I/O 13 I/O	10	I/O
13 I/O	11	I/O
	12	I/O
	13	I/O
14 I/O	14	I/O



Table 54 • PQ240 (continued)

PQ240	
Pin Number	A42MX36 Function
15	QCLKC, I/O
16	I/O
17	WD, I/O
18	WD, I/O
19	I/O
20	I/O
21	WD, I/O
22	WD, I/O
23	I/O
24	PRB, I/O
25	I/O
26	CLKB, I/O
27	I/O
28	GND
29	VCCA
30	VCCI
31	I/O
32	CLKA, I/O
33	I/O
34	PRA, I/O
35	I/O
36	I/O
37	WD, I/O
38	WD, I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O
44	I/O
45	QCLKD, I/O
46	I/O
47	WD, I/O
48	WD, I/O
49	I/O
50	I/O
51	I/O
-	_



Table 54 • PQ240 (continued)

PQ240	
Pin Number	A42MX36 Function
52	VCCI
53	I/O
54	WD, I/O
55	WD, I/O
56	I/O
57	SDI, I/O
58	I/O
59	VCCA
60	GND
61	GND
62	I/O
63	I/O
64	I/O
65	I/O
66	I/O
67	I/O
68	I/O
69	I/O
70	I/O
71	VCCI
72	I/O
73	I/O
74	I/O
75	I/O
76	I/O
77	I/O
78	I/O
79	I/O
80	I/O
81	I/O
82	I/O
83	I/O
84	I/O
85	VCCA
86	I/O
87	I/O
88	VCCA



Table 54 • PQ240 (continued)

PQ240	
Pin Number	A42MX36 Function
89	VCCI
90	VCCA
91	LP
92	TCK, I/O
93	I/O
94	GND
95	I/O
96	I/O
97	I/O
98	I/O
99	I/O
100	I/O
101	I/O
102	I/O
103	I/O
104	I/O
105	I/O
106	I/O
107	I/O
108	VCCI
109	I/O
110	I/O
111	I/O
112	I/O
113	I/O
114	I/O
115	I/O
116	I/O
117	I/O
118	VCCA
119	GND
120	GND
121	GND
122	I/O
123	SDO, TDO, I/O
124	I/O
125	WD, I/O
-	



Table 54 • PQ240 (continued)

Pin Number A42MX36 Function 126 WD, I/O 127 I/O 128 VCCI 129 I/O 130 I/O 131 I/O 132 WD, I/O 133 WD, I/O 134 I/O 135 QCLKB, I/O 136 I/O 137 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160	PQ240	
126 WD, I/O 127 I/O 128 VCCI 129 I/O 130 I/O 131 I/O 132 WD, I/O 133 WD, I/O 134 I/O 135 QCLKB, I/O 136 I/O 137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O		A42MX36 Function
128 VCCI 129 I/O 130 I/O 131 I/O 132 WD, I/O 133 WD, I/O 134 I/O 135 QCLKB, I/O 136 I/O 137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	126	WD, I/O
129 I/O 130 I/O 131 I/O 132 WD, I/O 133 WD, I/O 134 I/O 135 QCLKB, I/O 136 I/O 137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	127	I/O
130 I/O 131 I/O 132 WD, I/O 133 WD, I/O 134 I/O 135 QCLKB, I/O 136 I/O 137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	128	VCCI
131 I/O 132 WD, I/O 133 WD, I/O 134 I/O 135 QCLKB, I/O 136 I/O 137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	129	I/O
132 WD, I/O 133 WD, I/O 134 I/O 135 QCLKB, I/O 136 I/O 137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 144 I/O 145 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	130	I/O
133 WD, I/O 134 I/O 135 QCLKB, I/O 136 I/O 137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	131	I/O
134 I/O 135 QCLKB, I/O 136 I/O 137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	132	WD, I/O
135 QCLKB, I/O 136 I/O 137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	133	WD, I/O
136	134	I/O
137 I/O 138 I/O 139 I/O 140 I/O 141 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	135	QCLKB, I/O
138 I/O 139 I/O 140 I/O 141 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	136	I/O
139 I/O 140 I/O 141 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	137	I/O
140 I/O 141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	138	I/O
141 I/O 142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	139	I/O
142 WD, I/O 143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	140	I/O
143 WD, I/O 144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	141	I/O
144 I/O 145 I/O 146 I/O 147 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	142	WD, I/O
145 I/O 146 I/O 147 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	143	WD, I/O
146 I/O 147 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	144	I/O
147 I/O 148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	145	I/O
148 I/O 149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	146	I/O
149 I/O 150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	147	I/O
150 VCCI 151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	148	I/O
151 VCCA 152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	149	I/O
152 GND 153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	150	VCCI
153 I/O 154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	151	VCCA
154 I/O 155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	152	GND
155 I/O 156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O	153	I/O
156 I/O 157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	154	I/O
157 I/O 158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	155	I/O
158 I/O 159 WD, I/O 160 WD, I/O 161 I/O	156	I/O
159 WD, I/O 160 WD, I/O 161 I/O	157	I/O
160 WD, I/O 161 I/O	158	I/O
161 I/O	159	WD, I/O
	160	WD, I/O
162 I/O	161	I/O
	162	I/O



Table 54 • PQ240 (continued)

PQ240	
Pin Number	A42MX36 Function
163	WD, I/O
164	WD, I/O
165	I/O
166	QCLKA, I/O
167	I/O
168	I/O
169	I/O
170	I/O
171	I/O
172	VCCI
173	I/O
174	WD, I/O
175	WD, I/O
176	I/O
177	I/O
178	TDI, I/O
179	TMS, I/O
180	GND
181	VCCA
182	GND
183	I/O
184	I/O
185	I/O
186	I/O
187	I/O
188	I/O
189	I/O
190	I/O
191	I/O
192	VCCI
193	I/O
194	I/O
195	I/O
196	I/O
197	I/O
198	I/O
199	I/O
-	



Table 54 • PQ240 (continued)

PQ240	
Pin Number	A42MX36 Function
200	I/O
201	I/O
202	I/O
203	I/O
204	I/O
205	I/O
206	VCCA
207	I/O
208	I/O
209	VCCA
210	VCCI
211	I/O
212	I/O
213	I/O
214	I/O
215	I/O
216	I/O
217	I/O
218	I/O
219	VCCA
220	I/O
221	I/O
222	I/O
223	I/O
224	I/O
225	I/O
226	I/O
227	VCCI
228	I/O
229	I/O
230	I/O
231	I/O
232	I/O
233	I/O
234	I/O
235	I/O
236	I/O



Table 54 • PQ240 (continued)

PQ240		
Pin Number	A42MX36 Function	
237	GND	
238	MODE	
239	VCCA	
240	GND	

Figure 46 • VQ80

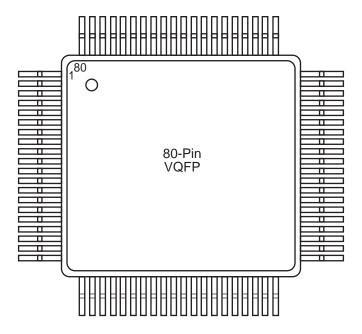


Table 55 • VQ80

VQ80		
Pin Number	A40MX02 Function	A40MX04 Function
1	I/O	I/O
2	NC	I/O
3	NC	I/O
4	NC	I/O
5	I/O	I/O
6	I/O	I/O
7	GND	GND
8	I/O	I/O
9	I/O	I/O
10	I/O	I/O
11	I/O	I/O
12	I/O	I/O



Table 55 • VQ80 (continued)

VQ80			
Pin Number	A40MX02 Function	A40MX04 Function	
13	VCC	VCC	
14	I/O	I/O	
15	I/O	I/O	
16	I/O	I/O	
17	NC	I/O	
18	NC	I/O	
19	NC	I/O	
20	VCC	VCC	
21	I/O	I/O	
22	I/O	I/O	
23	I/O	I/O	
24	I/O	I/O	
25	I/O	I/O	
26	I/O	I/O	
27	GND	GND	
28	I/O	I/O	
29	I/O	I/O	
30	I/O	I/O	
31	I/O	I/O	
32	I/O	I/O	
33	VCC	VCC	
34	I/O	I/O	
35	I/O	I/O	
36	I/O	I/O	
37	I/O	I/O	
38	I/O	I/O	
39	I/O	I/O	
40	I/O	I/O	
41	NC	I/O	
42	NC	I/O	
43	NC	I/O	
44	I/O	I/O	
45	I/O	I/O	
46	I/O	I/O	
47	GND	GND	
48	I/O	I/O	
49	I/O	I/O	



Table 55 • VQ80 (continued)

VQ80		
Pin Number	A40MX02 Function	A40MX04 Function
50	CLK, I/O	CLK, I/O
51	I/O	I/O
52	MODE	MODE
53	VCC	VCC
54	NC	I/O
55	NC	I/O
56	NC	I/O
57	SDI, I/O	SDI, I/O
58	DCLK, I/O	DCLK, I/O
59	PRA, I/O	PRA, I/O
60	NC	NC
61	PRB, I/O	PRB, I/O
62	I/O	I/O
63	I/O	I/O
64	I/O	I/O
65	I/O	I/O
66	I/O	I/O
67	I/O	I/O
68	GND	GND
69	I/O	I/O
70	I/O	I/O
71	I/O	I/O
72	I/O	I/O
73	I/O	I/O
74	VCC	VCC
75	I/O	I/O
76	I/O	I/O
77	I/O	I/O
78	I/O	I/O
79	I/O	I/O
80	I/O	I/O
·	·	



Figure 47 • VQ100

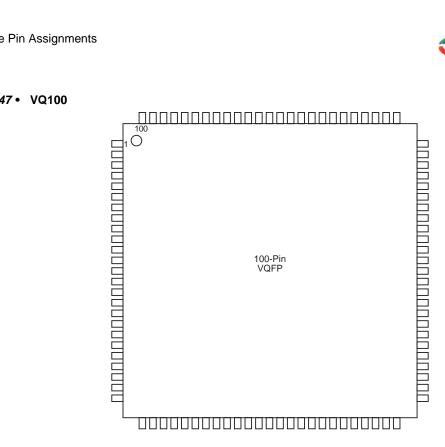


Table 56 • VQ100

VQ100		
Pin Number	A42MX09 Function	A42MX16 Function
1	I/O	I/O
2	MODE	MODE
3	I/O	I/O
4	I/O	I/O
5	I/O	I/O
6	I/O	I/O
7	GND	GND
8	I/O	I/O
9	I/O	I/O
10	I/O	I/O
11	I/O	I/O
12	I/O	I/O
13	I/O	I/O
14	VCCA	NC
15	VCCI	VCCI
16	I/O	I/O
17	I/O	I/O
18	I/O	I/O
19	I/O	I/O
20	GND	GND



Table 56 • VQ100 (continued)

VQ100			
Pin Number	A42MX09 Function	A42MX16 Function	
21	I/O	I/O	
22	I/O	I/O	
23	I/O	I/O	
24	I/O	I/O	
25	I/O	I/O	
26	I/O	I/O	
27	I/O	I/O	
28	I/O	I/O	
29	I/O	I/O	
30	I/O	I/O	
31	I/O	I/O	
32	GND	GND	
33	I/O	I/O	
34	I/O	I/O	
35	I/O	I/O	
36	I/O	I/O	
37	I/O	I/O	
38	VCCA	VCCA	
39	I/O	I/O	
40	I/O	I/O	
41	I/O	I/O	
42	I/O	I/O	
43	I/O	I/O	
44	GND	GND	
45	I/O	I/O	
46	I/O	I/O	
47	I/O	I/O	
48	I/O	I/O	
49	I/O	I/O	
50	SDO, I/O	SDO, I/O	
51	I/O	I/O	
52	I/O	I/O	
53	I/O	I/O	
54	I/O	I/O	
55	GND	GND	
56	I/O	I/O	
57	I/O	I/O	
-			



Table 56 • VQ100 (continued)

VQ100			
Pin Number	A42MX09 Function	A42MX16 Function	
58	I/O	I/O	
59	I/O	I/O	
60	I/O	I/O	
61	I/O	I/O	
62	LP	LP	
63	VCCA	VCCA	
64	VCCI	VCCI	
65	VCCA	VCCA	
66	I/O	I/O	
67	I/O	I/O	
68	I/O	I/O	
69	I/O	I/O	
70	GND	GND	
71	I/O	I/O	
72	I/O	I/O	
73	I/O	I/O	
74	I/O	I/O	
75	I/O	I/O	
76	I/O	I/O	
77	SDI, I/O	SDI, I/O	
78	I/O	I/O	
79	I/O	I/O	
80	I/O	I/O	
81	I/O	I/O	
82	GND	GND	
83	I/O	I/O	
84	I/O	I/O	
85	PRA, I/O	PRA, I/O	
86	I/O	I/O	
87	CLKA, I/O	CLKA, I/O	
88	VCCA	VCCA	
89	I/O	I/O	
90	CLKB, I/O	CLKB, I/O	
91	I/O	I/O	
92	PRB, I/O	PRB, I/O	
93	I/O	I/O	
94	GND	GND	



Table 56 • VQ100 (continued)

VQ100		
Pin Number	A42MX09 Function	A42MX16 Function
95	I/O	I/O
96	I/O	I/O
97	I/O	I/O
98	I/O	I/O
99	I/O	I/O
100	DCLK, I/O	DCLK, I/O

Figure 48 • TQ176

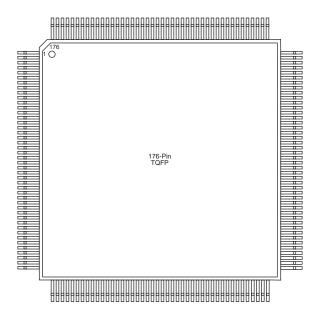


Table 57 • TQ176

Pin Number A42MX09 Function A42MX16 Function A42MX24 1 GND GND GND 2 MODE MODE MODE 3 I/O I/O I/O 4 I/O I/O I/O 5 I/O I/O I/O 6 I/O I/O I/O 7 I/O I/O I/O	Function
2 MODE MODE 3 I/O I/O 4 I/O I/O 5 I/O I/O 6 I/O I/O	
3 I/O I/O I/O 4 I/O I/O I/O 5 I/O I/O I/O 6 I/O I/O I/O	
4 I/O I/O I/O 5 I/O I/O I/O 6 I/O I/O I/O	
5 I/O I/O I/O 6 I/O I/O	
6 I/O I/O I/O	
7 I/O I/O I/O	
8 NC NC I/O	
9 I/O I/O I/O	
10 NC I/O I/O	
11 NC I/O I/O	
12 I/O I/O I/O	



Table 57 • TQ176 (continued)

TQ176			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
13	NC	VCCA	VCCA
14	I/O	I/O	I/O
15	I/O	I/O	I/O
16	I/O	I/O	I/O
17	I/O	I/O	I/O
18	GND	GND	GND
19	NC	I/O	I/O
20	NC	I/O	I/O
21	I/O	I/O	I/O
22	NC	I/O	I/O
23	GND	GND	GND
24	NC	VCCI	VCCI
25	VCCA	VCCA	VCCA
26	NC	I/O	I/O
27	NC	I/O	I/O
28	VCCI	VCCA	VCCA
29	NC	I/O	I/O
30	I/O	I/O	I/O
31	I/O	I/O	I/O
32	I/O	I/O	I/O
33	NC	NC	I/O
34	I/O	I/O	I/O
35	I/O	I/O	I/O
36	I/O	I/O	I/O
37	NC	I/O	I/O
38	NC	NC	I/O
39	I/O	I/O	I/O
40	I/O	I/O	I/O
41	I/O	I/O	I/O
42	I/O	I/O	I/O
43	I/O	I/O	I/O
44	I/O	I/O	I/O
45	GND	GND	GND
46	I/O	I/O	TMS, I/O
47	I/O	I/O	TDI, I/O
48	I/O	I/O	I/O
49	I/O	I/O	WD, I/O



Table 57 • TQ176 (continued)

TQ176			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
50	I/O	I/O	WD, I/O
51	I/O	I/O	I/O
52	NC	VCCI	VCCI
53	I/O	I/O	I/O
54	NC	I/O	I/O
55	NC	I/O	WD, I/O
56	I/O	I/O	WD, I/O
57	NC	NC	I/O
58	I/O	I/O	I/O
59	I/O	I/O	WD, I/O
60	I/O	I/O	WD, I/O
61	NC	I/O	I/O
62	I/O	I/O	I/O
63	I/O	I/O	I/O
64	NC	I/O	I/O
65	I/O	I/O	I/O
66	NC	I/O	I/O
67	GND	GND	GND
68	VCCA	VCCA	VCCA
69	I/O	I/O	WD, I/O
70	I/O	I/O	WD, I/O
71	I/O	I/O	I/O
72	I/O	I/O	I/O
73	I/O	I/O	I/O
74	NC	I/O	I/O
75	I/O	I/O	I/O
76	I/O	I/O	I/O
77	NC	NC	WD, I/O
78	NC	I/O	WD, I/O
79	I/O	I/O	I/O
80	NC	I/O	I/O
81	I/O	I/O	I/O
82	NC	VCCI	VCCI
83	I/O	I/O	I/O
84	I/O	I/O	WD, I/O
85	I/O	I/O	WD, I/O
86	NC	I/O	I/O



Table 57 • TQ176 (continued)

TQ176			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
87	SDO, I/O	SDO, I/O	SDO, TDO, I/O
88	I/O	I/O	I/O
89	GND	GND	GND
90	I/O	I/O	I/O
91	I/O	I/O	I/O
92	I/O	I/O	I/O
93	I/O	I/O	I/O
94	I/O	I/O	I/O
95	I/O	I/O	I/O
96	NC	I/O	I/O
97	NC	I/O	I/O
98	I/O	I/O	I/O
99	I/O	I/O	I/O
100	I/O	I/O	I/O
101	NC	NC	I/O
102	I/O	I/O	I/O
103	NC	I/O	I/O
104	I/O	I/O	I/O
105	I/O	I/O	I/O
106	GND	GND	GND
107	NC	I/O	I/O
108	NC	I/O	TCK, I/O
109	LP	LP	LP
110	VCCA	VCCA	VCCA
111	GND	GND	GND
112	VCCI	VCCI	VCCI
113	VCCA	VCCA	VCCA
114	NC	I/O	I/O
115	NC	I/O	I/O
116	NC	VCCA	VCCA
117	I/O	I/O	I/O
118	I/O	I/O	I/O
119	I/O	I/O	I/O
120	I/O	I/O	I/O
121	NC	NC	I/O
122	I/O	I/O	I/O
123	I/O	I/O	I/O



Table 57 • TQ176 (continued)

TQ176			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
124	NC	I/O	I/O
125	NC	I/O	I/O
126	NC	NC	I/O
127	I/O	I/O	I/O
128	I/O	I/O	I/O
129	I/O	I/O	I/O
130	I/O	I/O	I/O
131	I/O	I/O	I/O
132	I/O	I/O	I/O
133	GND	GND	GND
134	I/O	I/O	I/O
135	SDI, I/O	SDI, I/O	SDI, I/O
136	NC	I/O	I/O
137	I/O	I/O	WD, I/O
138	I/O	I/O	WD, I/O
139	I/O	I/O	I/O
140	NC	VCCI	VCCI
141	I/O	I/O	I/O
142	I/O	I/O	I/O
143	NC	I/O	I/O
144	NC	I/O	WD, I/O
145	NC	NC	WD, I/O
146	I/O	I/O	I/O
147	NC	I/O	I/O
148	I/O	I/O	I/O
149	I/O	I/O	I/O
150	I/O	I/O	WD, I/O
151	NC	I/O	WD, I/O
152	PRA, I/O	PRA, I/O	PRA, I/O
153	I/O	I/O	I/O
154	CLKA, I/O	CLKA, I/O	CLKA, I/O
155	VCCA	VCCA	VCCA
156	GND	GND	GND
157	I/O	I/O	I/O
158	CLKB, I/O	CLKB, I/O	CLKB, I/O



Table 57 • TQ176 (continued)

TQ176			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
159	I/O	I/O	I/O
160	PRB, I/O	PRB, I/O	PRB, I/O
161	NC	I/O	WD, I/O
162	I/O	I/O	WD, I/O
163	I/O	I/O	I/O
164	I/O	I/O	I/O
165	NC	NC	WD, I/O
166	NC	I/O	WD, I/O
167	I/O	I/O	I/O
168	NC	I/O	I/O
169	I/O	I/O	I/O
170	NC	VCCI	VCCI
171	I/O	I/O	WD, I/O
172	I/O	I/O	WD, I/O
173	NC	I/O	I/O
174	I/O	I/O	I/O
175	DCLK, I/O	DCLK, I/O	DCLK, I/O
176	I/O	I/O	I/O

Figure 49 • CQ208

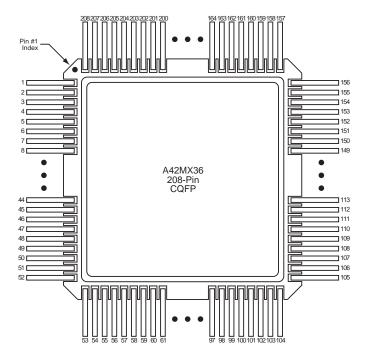




Table 58 • CQ208

Pin Number A42MX36 Function 1 GND 2 VCCA 3 MODE 4 I/O 5 I/O 6 I/O 7 I/O 8 I/O 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O 14 I/O 15 I/O 16 I/O 17 VCCA 18 I/O 20 I/O 21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O </th <th>CQ208</th> <th></th>	CQ208	
2 VCCA 3 MODE 4 I/O 5 I/O 6 I/O 7 I/O 8 I/O 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O 14 I/O 15 I/O 16 I/O 17 VCCA 18 I/O 19 I/O 20 I/O 21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	Pin Number	A42MX36 Function
3	1	GND
4	2	VCCA
5 I/O 6 I/O 7 I/O 8 I/O 9 I/O 10 I/O 11 I/O 12 I/O 13 I/O 14 I/O 15 I/O 16 I/O 17 VCCA 18 I/O 20 I/O 21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 34 I/O 35 I/O	3	MODE
6	4	I/O
7	5	I/O
8	6	I/O
9	7	I/O
10	8	I/O
11	9	I/O
12	10	I/O
13	11	I/O
14 I/O 15 I/O 16 I/O 17 VCCA 18 I/O 19 I/O 20 I/O 21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	12	I/O
15	13	I/O
16 I/O 17 VCCA 18 I/O 19 I/O 20 I/O 21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 34 I/O 35 I/O	14	I/O
17 VCCA 18 I/O 19 I/O 20 I/O 21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	15	I/O
18 I/O 19 I/O 20 I/O 21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	16	I/O
19 I/O 20 I/O 21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	17	VCCA
20 I/O 21 I/O 21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	18	I/O
21 I/O 22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	19	I/O
22 GND 23 I/O 24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	20	I/O
23	21	I/O
24 I/O 25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	22	GND
25 I/O 26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	23	I/O
26 I/O 27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	24	I/O
27 GND 28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	25	I/O
28 VCCI 29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	26	I/O
29 VCCA 30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	27	GND
30 I/O 31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	28	VCCI
31 I/O 32 VCCA 33 I/O 34 I/O 35 I/O	29	VCCA
32 VCCA 33 I/O 34 I/O 35 I/O	30	I/O
33 I/O 34 I/O 35 I/O	31	I/O
34 I/O 35 I/O	32	VCCA
35 I/O	33	I/O
	34	I/O
36 I/O	35	I/O
	36	I/O



Table 58 • CQ208 (continued)

CQ208	
Pin Number	A42MX36 Function
37	I/O
38	I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O
44	I/O
45	I/O
46	I/O
47	I/O
48	I/O
49	I/O
50	I/O
51	I/O
52	GND
53	GND
54	TMS, I/O
55	TDI, I/O
56	I/O
57	WD, I/O
58	WD, I/O
59	I/O
60	VCCI
61	I/O
62	I/O
63	I/O
64	I/O
65	QCLKA, I/O
66	WD, I/O
67	WD, I/O
68	I/O
69	I/O
70	WD, I/O
71	WD, I/O
72	I/O
73	I/O



Table 58 • CQ208 (continued)

CQ208	
Pin Number	A42MX36 Function
74	I/O
75	I/O
76	I/O
77	I/O
78	GND
79	VCCA
80	VCCI
81	I/O
82	I/O
83	I/O
84	I/O
85	WD, I/O
86	WD, I/O
87	I/O
88	I/O
89	I/O
90	I/O
91	QCLKB, I/O
92	I/O
93	WD, I/O
94	WD, I/O
95	I/O
96	I/O
97	I/O
98	VCCI
99	I/O
100	WD, I/O
101	WD, I/O
102	I/O
103	TDO, I/O
104	I/O
105	GND
106	VCCA
107	I/O
108	I/O
109	I/O
110	I/O



Table 58 • CQ208 (continued)

CQ208	
Pin Number	A42MX36 Function
111	I/O
112	I/O
113	I/O
114	I/O
115	I/O
116	I/O
117	I/O
118	I/O
119	I/O
120	I/O
121	I/O
122	I/O
123	I/O
124	I/O
125	I/O
126	GND
127	I/O
128	TCK, I/O
129	LP
130	VCCA
131	GND
132	VCCI
133	VCCA
134	I/O
135	I/O
136	VCCA
137	I/O
138	I/O
139	I/O
140	I/O
141	I/O
142	I/O
143	I/O
144	I/O
145	I/O
146	I/O
147	I/O



Table 58 • CQ208 (continued)

Pin Number A42MX36 Function 148 I/O 149 I/O 150 GND 151 I/O 152 I/O 153 I/O 154 I/O 155 I/O 156 I/O 157 GND 158 I/O 159 SDI, I/O 160 I/O 161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 181	CQ208	
149 I/O 150 GND 151 I/O 152 I/O 153 I/O 154 I/O 155 I/O 156 I/O 157 GND 158 I/O 159 SDI, I/O 160 I/O 161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI	Pin Number	A42MX36 Function
150 GND 151 I/O 152 I/O 153 I/O 154 I/O 155 I/O 156 I/O 157 GND 158 I/O 159 SDI, I/O 160 I/O 161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 177 WD, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI	148	I/O
151 I/O 152 I/O 153 I/O 154 I/O 155 I/O 156 I/O 157 GND 158 I/O 159 SDI, I/O 160 I/O 161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI	149	I/O
152 I/O 153 I/O 154 I/O 155 I/O 156 I/O 157 GND 158 I/O 159 SDI, I/O 160 I/O 161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI	150	GND
153 I/O 154 I/O 155 I/O 156 I/O 157 GND 158 I/O 159 SDI, I/O 160 I/O 161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI	151	I/O
154	152	I/O
155	153	I/O
156	154	I/O
157 GND 158 I/O 159 SDI, I/O 160 I/O 161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	155	I/O
158	156	I/O
159 SDI, I/O 160 I/O 161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	157	GND
160 I/O 161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 168 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	158	I/O
161 WD, I/O 162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	159	SDI, I/O
162 WD, I/O 163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	160	I/O
163 I/O 164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	161	WD, I/O
164 VCCI 165 I/O 166 I/O 167 I/O 168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	162	WD, I/O
165 I/O 166 I/O 167 I/O 168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	163	I/O
166 I/O 167 I/O 168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	164	VCCI
167 I/O 168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	165	I/O
168 WD, I/O 169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	166	I/O
169 WD, I/O 170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	167	I/O
170 I/O 171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	168	WD, I/O
171 QCLKD, I/O 172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	169	WD, I/O
172 I/O 173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	170	I/O
173 I/O 174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	171	QCLKD, I/O
174 I/O 175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	172	I/O
175 I/O 176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	173	I/O
176 WD, I/O 177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	174	I/O
177 WD, I/O 178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	175	I/O
178 PRA, I/O 179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	176	WD, I/O
179 I/O 180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	177	WD, I/O
180 CLKA, I/O 181 I/O 182 VCCI 183 VCCA	178	PRA, I/O
181 I/O 182 VCCI 183 VCCA	179	I/O
182 VCCI 183 VCCA	180	CLKA, I/O
183 VCCA	181	I/O
	182	VCCI
184 GND	183	VCCA
	184	GND



Table 58 • CQ208 (continued)

A42MX36 Function
I/O
CLKB, I/O
I/O
PRB, I/O
I/O
WD, I/O
WD, I/O
I/O
I/O
WD, I/O
WD, I/O
QCLKC, I/O
I/O
I/O
I/O
I/O
I/O
VCCI
WD, I/O
WD, I/O
I/O
I/O
DCLK, I/O
I/O



Figure 50 • CQ256

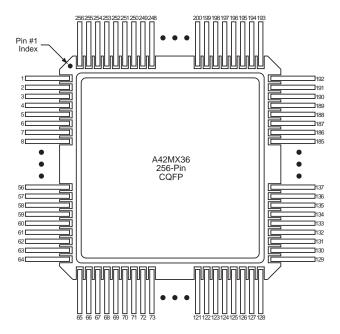


Table 59 • CQ256

CQ256	
Pin Number	A42MX36 Function
1	NC
2	GND
3	I/O
4	I/O
5	I/O
6	I/O
7	I/O
8	I/O
9	I/O
10	GND
11	I/O
12	I/O
13	I/O
14	I/O
15	I/O
16	I/O
17	I/O
18	I/O
19	I/O
20	I/O
21	I/O



Table 59 • CQ256 (continued)

CQ256	- 4011V00 =
Pin Number	
22	I/O
23	I/O
24	I/O
25	I/O
26	VCCA
27	I/O
28	I/O
29	VCCA
30	VCCI
31	GND
32	VCCA
33	LP
34	TCK, I/O
35	I/O
36	GND
37	I/O
38	I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O
44	I/O
45	I/O
46	I/O
47	I/O
48	GND
49	I/O
50	I/O
51	I/O
52	I/O
53	I/O
54	I/O
55	I/O
56	I/O
57	I/O
58	I/O



Table 59 • CQ256 (continued)

CQ256	
Pin Number	
59	I/O
60	VCCA
61	GND
62	GND
63	NC
64	NC
65	NC
66	I/O
67	SDO, TDO, I/O
68	I/O
69	WD, I/O
70	WD, I/O
71	I/O
72	VCCI
73	I/O
74	I/O
75	I/O
76	WD, I/O
77	GND
78	WD, I/O
79	I/O
80	QCLKB, I/O
81	I/O
82	I/O
83	I/O
84	I/O
85	I/O
86	I/O
87	WD, I/O
88	WD, I/O
89	I/O
90	I/O
91	I/O
92	I/O
93	I/O
94	I/O
95	VCCI



Table 59 • CQ256 (continued)

CQ256	_
Pin Number	A42MX36 Function
96	VCCA
97	GND
98	GND
99	1/0
100	I/O
101	I/O
102	I/O
103	I/O
104	I/O
105	WD, I/O
106	WD, I/O
107	I/O
108	I/O
109	WD, I/O
110	WD, I/O
111	I/O
112	QCLKA, I/O
113	I/O
114	GND
115	I/O
116	I/O
117	I/O
118	I/O
119	VCCI
120	I/O
121	WD, I/O
122	WD, I/O
123	I/O
124	I/O
125	I/O
126	I/O
127	GND
128	NC
129	NC
130	NC
131	GND
132	I/O



Table 59 • CQ256 (continued)

CQ256	
Pin Number	A42MX36 Function
133	1/0
134	1/0
135	1/0
	1/0
136	
137	1/0
138	1/0
139	GND
140	1/0
141	1/0
142	1/0
143	1/0
144	1/0
145	I/O
146	I/O
147	I/O
148	I/O
149	I/O
150	I/O
151	I/O
152	I/O
153	I/O
154	I/O
155	VCCA
156	I/O
157	I/O
158	VCCA
159	VCCI
160	GND
161	I/O
162	I/O
163	I/O
164	I/O
165	GND
166	I/O
167	I/O
168	I/O
169	I/O



Table 59 • CQ256 (continued)

CQ256	
Pin Number	A42MX36 Function
170	VCCA
171	I/O
172	I/O
173	I/O
174	I/O
175	I/O
176	I/O
177	I/O
178	I/O
179	I/O
180	GND
181	I/O
182	I/O
183	I/O
184	I/O
185	I/O
186	I/O
187	I/O
188	MODE
189	VCCA
190	GND
191	NC
192	NC
193	NC
194	I/O
195	DCLK, I/O
196	I/O
197	I/O
198	I/O
199	WD, I/O
200	WD, I/O
201	VCCI
202	I/O
203	I/O
204	I/O
205	I/O
206	GND



Table 59 • CQ256 (continued)

CQ256	
Pin Number	A42MX36 Function
207	I/O
208	I/O
209	QCLKC, I/O
210	I/O
211	WD, I/O
212	WD, I/O
213	I/O
214	I/O
215	WD, I/O
216	WD, I/O
217	I/O
218	PRB, I/O
219	I/O
220	CLKB, I/O
221	I/O
222	GND
223	GND
224	VCCA
225	VCCI
226	I/O
227	CLKA, I/O
228	I/O
229	PRA, I/O
230	I/O
231	I/O
232	WD, I/O
233	WD, I/O
234	I/O
235	I/O
236	I/O
237	I/O
238	I/O
239	I/O
240	QCLKD, I/O
241	I/O
242	WD, I/O
243	GND



Table 59 • CQ256 (continued)

CQ256	
Pin Number	A42MX36 Function
244	WD, I/O
245	I/O
246	I/O
247	I/O
248	VCCI
249	I/O
250	WD, I/O
251	WD, I/O
252	I/O
253	SDI, I/O
254	I/O
255	GND
256	NC

Figure 51 • BG272

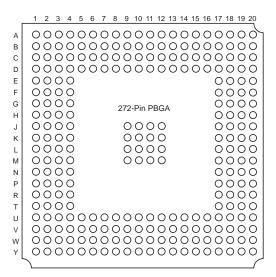


Table 60 • BG272

BG272	
Pin Number	A42MX36 Function
A1	GND
A2	GND
A3	I/O
A4	WD, I/O
A5	I/O



Table 60 • BG272 (continued)

BG272	
Pin Number	A42MX36 Function
A6	I/O
A7	WD, I/O
A8	WD, I/O
A9	I/O
A10	I/O
A11	CLKA
A12	I/O
A13	I/O
A14	I/O
A15	I/O
A16	WD, I/O
A17	I/O
A18	I/O
A19	GND
A20	GND
B1	GND
B2	GND
B3	DCLK, I/O
B4	I/O
B5	I/O
B6	I/O
B7	WD, I/O
B8	I/O
B9	PRB, I/O
B10	I/O
B11	I/O
B12	WD, I/O
B13	I/O
B14	I/O
B15	WD, I/O
B16	I/O
B17	WD, I/O
B18	I/O
B19	GND
B20	GND
C1	I/O
C2	MODE



Table 60 • BG272 (continued)

BG272	
	A42MX36 Function
C3	GND
C4	I/O
C5	WD, I/O
C6	I/O
C7	QCLKC, I/O
C8	I/O
C9	I/O
C10	CLKB
C11	PRA, I/O
C12	WD, I/O
C13	I/O
C14	QCLKD, I/O
C15	I/O
C16	WD, I/O
C17	SDI, I/O
C18	I/O
C19	I/O
C20	I/O
D1	I/O
D2	I/O
D3	I/O
D4	I/O
D5	VCCI
D6	I/O
D7	I/O
D8	VCCA
D9	WD, I/O
D10	VCCI
D11	I/O
D12	VCCI
D13	I/O
D14	VCCI
D15	I/O
D16	VCCA
D17	GND
D18	I/O
D19	I/O



Table 60 • BG272 (continued)

D0070	
BG272	A 42MV2C Function
Pin Number	
D20	1/0
E1	1/0
E2	I/O
E3	I/O
E4	VCCA
E17	VCCI
E18	I/O
E19	I/O
E20	I/O
F1	I/O
F2	I/O
F3	I/O
F4	VCCI
F17	I/O
F18	I/O
F19	I/O
F20	I/O
G1	I/O
G2	I/O
G3	I/O
G4	VCCI
G17	VCCI
G18	I/O
G19	I/O
G20	I/O
H1	I/O
H2	I/O
H3	I/O
H4	VCCA
H17	I/O
H18	I/O
H19	I/O
H20	I/O
J1	I/O
J2	I/O
J3	I/O
J4	VCCI



Table 60 • BG272 (continued)

	. ,
BG272	
	A42MX36 Function
J9	GND
J10	GND
J11	GND
J12	GND
J17	VCCA
J18	I/O
J19	I/O
J20	I/O
K1	I/O
K2	I/O
K3	I/O
K4	VCCI
K9	GND
K10	GND
K11	GND
K12	GND
K17	I/O
K18	VCCA
K19	VCCA
K20	LP
L1	I/O
L2	I/O
L3	VCCA
L4	VCCA
L9	GND
L10	GND
L11	GND
L12	GND
L17	VCCI
L18	I/O
L19	I/O
L20	TCK, I/O
M1	I/O
M2	I/O
M3	I/O
M4	VCCI
M9	GND



Table 60 • BG272 (continued)

D0070	. ,
BG272	A 40MVQQ From alian
	A42MX36 Function
M10	GND
M11	GND
M12	GND
M17	I/O
M18	I/O
M19	I/O
M20	I/O
N1	I/O
N2	I/O
N3	I/O
N4	VCCI
N17	VCCI
N18	I/O
N19	I/O
N20	I/O
P1	I/O
P2	I/O
P3	I/O
P4	VCCA
P17	I/O
P18	I/O
P19	I/O
P20	I/O
R1	I/O
R2	I/O
R3	I/O
R4	VCCI
R17	VCCI
R18	I/O
R19	I/O
R20	I/O
T1	I/O
T2	I/O
T3	I/O
T4	I/O
T17	VCCA
T18	I/O



Table 60 • BG272 (continued)

BG272	
Pin Number	A42MX36 Function
T19	I/O
T20	I/O
U1	I/O
U2	I/O
U3	I/O
U4	I/O
U5	VCCI
U6	WD, I/O
U7	I/O
U8	I/O
U9	WD, I/O
U10	VCCA
U11	VCCI
U12	I/O
U13	I/O
U14	QCLKB, I/O
U15	I/O
U16	VCCI
U17	I/O
U18	GND
U19	I/O
U20	I/O
V1	I/O
V2	I/O
V3	GND
V4	GND
V5	I/O
V6	I/O
V7	I/O
V8	WD, I/O
V9	I/O
V10	I/O
V11	I/O
V12	I/O
V13	WD, I/O
V14	I/O
V15	WD, I/O
-	



Table 60 • BG272 (continued)

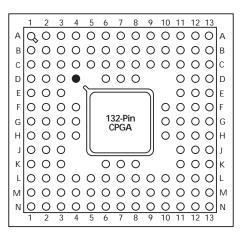
BG272	
Pin Number	A42MX36 Function
V16	I/O
V17	I/O
V18	SDO, TDO, I/O
V19	I/O
V20	I/O
W1	GND
W2	GND
W3	I/O
W4	TMS, I/O
W5	I/O
W6	I/O
W7	I/O
W8	WD, I/O
W9	WD, I/O
W10	I/O
W11	I/O
W12	I/O
W13	WD, I/O
W14	I/O
W15	I/O
W16	WD, I/O
W17	I/O
W18	WD, I/O
W19	GND
W20	GND
Y1	GND
Y2	GND
Y3	I/O
Y4	TDI, I/O
Y5	WD, I/O
Y6	I/O
Y7	QCLKA, I/O
Y8	I/O
Y9	I/O
Y10	I/O
Y11	I/O
Y12	I/O



Table 60 • BG272 (continued)

BG272	
Pin Number	A42MX36 Function
Y13	I/O
Y14	I/O
Y15	I/O
Y16	I/O
Y17	I/O
Y18	WD, I/O
Y19	GND
Y20	GND

Figure 52 • PG132



Orientation Pin

Table 61 • PG132

PG132	
Pin Number	A42MX09 Function
_	PMPOUT
B2	I/O
A1	MODE
B1	I/O
D3	I/O
C2	I/O
C1	I/O
D2	I/O
D1	I/O
E2	I/O
E1	I/O
F3	I/O



Table 61 • PG132 (continued)

PG132	
Pin Number	A42MX09 Function
F2	I/O
F1	I/O
G1	I/O
G4	VSV
H1	I/O
H2	I/O
H3	I/O
H4	I/O
J1	I/O
K1	I/O
L1	I/O
K2	I/O
M1	I/O
K3	I/O
L2	I/O
N1	I/O
L3	BININ
M2	BINOUT
N2	I/O
M3	I/O
L4	I/O
N3	I/O
M4	I/O
N4	I/O
M5	I/O
K6	I/O
N5	I/O
N6	I/O
L6	I/O
M6	I/O
M7	I/O
N7	I/O
N8	I/O
M8	I/O
L8	I/O
K8	I/O
N9	I/O



Table 61 • PG132 (continued)

DC422	
PG132	
Pin Number	A42MX09 Function
N10	I/O
M10	I/O
N11	I/O
L10	I/O
M11	I/O
N12	SDO
M12	I/O
L11	I/O
N13	I/O
M13	I/O
K11	I/O
L12	I/O
L13	I/O
K13	I/O
H10	I/O
J12	I/O
J13	I/O
H11	I/O
H12	I/O
H13	VKS
G13	VPP



Table 61 • PG132 (continued)

PG132	
Pin Number	A42MX09 Function
G12	VSV
F13	I/O
F12	I/O
F11	I/O
F10	I/O
E13	I/O
D13	I/O
D12	I/O
C13	I/O
B13	I/O
D11	I/O
C12	I/O
A13	I/O
C11	I/O
B12	SDI
B11	I/O
C10	I/O
A12	I/O
A11	I/O
B10	I/O
D8	I/O
A10	I/O
C8	I/O
A9	I/O
B8	PRBA
A8	I/O
B7	CLKA
A7	I/O
B6	CLKB
A6	I/O
C6	PRBB
A5	I/O
D6	I/O
A4	I/O
B4	I/O
A3	I/O
C4	I/O



Table 61 • PG132 (continued)

PG132	
Pin Number	A42MX09 Function
B3	I/O
A2	I/O
C3	DCLK
B5	GNDA
E12	GNDA
J2	GNDA
M9	GNDA
B9	GNDI
C5	GNDI
E11	GNDI
F4	GNDI
J3	GNDI
J11	GNDI
L5	GNDI
L9	GNDI
C9	GNDQ
E3	GNDQ
K12	GNDQ
D7	VCCA
G3	VCCA
G10	VCCA
L7	VCCA
C7	VCCI
G2	VCCI
G11	VCCI
K7	VCCI



Figure 53 • CQ172

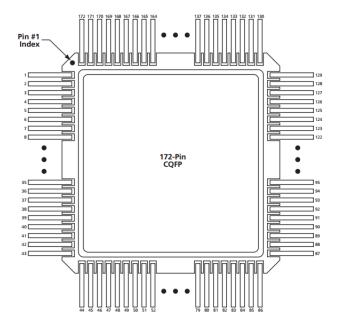


Table 62 • CQ172

CQ172	
Pin Number	A42MX16 Function
1	MODE
2	I/O
3	I/O
4	I/O
5	I/O
6	I/O
7	GND
8	I/O
9	I/O
10	I/O
11	I/O
12	VCC
13	I/O
14	I/O
15	I/O
16	I/O
17	GND
18	I/O
19	I/O
20	I/O



Table 62 • CQ172 (continued)

CQ172	
Pin Number	A42MX16 Function
21	I/O
22	GND
23	VCCI
24	VSV
25	I/O
26	I/O
27	VCC
28	I/O
29	I/O
30	I/O
31	I/O
32	GND
33	I/O
34	I/O
35	I/O
36	I/O
37	GND
38	I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O
44	BININ
45	BINOUT
46	I/O
47	I/O
48	I/O
49	I/O
50	VCCI
51	I/O
52	I/O
53	I/O
54	I/O
55	GND
56	I/O
57	I/O



Table 62 • CQ172 (continued)

CQ172	_
Pin Number	A42MX16 Function
58	1/0
59	I/O
60	I/O
61	I/O
62	I/O
63	I/O
64	I/O
65	GND
66	VCC
67	I/O
68	I/O
69	I/O
70	I/O
71	I/O
72	I/O
73	I/O
74	I/O
75	GND
76	I/O
77	I/O
78	I/O
79	I/O
80	VCCI
81	I/O
82	I/O
83	I/O
84	I/O
85	SDO
86	I/O
87	I/O
88	I/O
89	I/O
90	I/O
91	I/O
92	I/O
93	I/O
94	I/O



Table 62 • CQ172 (continued)

CQ172	
Pin Number	A42MX16 Function
95	I/O
96	I/O
97	I/O
98	GND
99	I/O
100	I/O
101	I/O
102	I/O
103	GND
104	I/O
105	I/O
106	VKS
107	VPP
108	GND
109	VCCI
110	VSV
111	I/O
112	I/O
113	VCC
114	I/O
115	I/O
116	I/O
117	I/O
118	GND
119	I/O
120	I/O
121	I/O
122	I/O
123	GNDI
124	I/O
125	I/O
126	I/O
127	I/O
128	I/O
129	I/O
130	I/O
131	SDI



Table 62 • CQ172 (continued)

CQ172	
Pin Number	A42MX16 Function
132	I/O
133	I/O
134	I/O
135	I/O
136	VCCI
137	I/O
138	I/O
139	I/O
140	I/O
141	GND
142	I/O
143	I/O
144	I/O
145	I/O
146	I/O
147	I/O
148	PROBA
149	I/O
150	CLKA
151	VCC
152	GND
153	I/O
154	CLKB
155	I/O
156	PROBB
157	I/O
158	I/O
159	I/O
160	I/O
161	GND
162	I/O
163	I/O
164	I/O
165	I/O
166	VCCI
167	I/O
168	I/O



Table 62 • CQ172 (continued)

CQ172	
Pin Number	A42MX16 Function
169	I/O
170	I/O
171	DCLK